# Fooling Constant-Depth Threshold Circuits

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## Abstract

We present new constructions of pseudorandom generators (PRGs) for two of the most widely-studied non-uniform circuit classes in complexity theory. Our main result is a construction of the *first non-trivial PRG for linear threshold (LTF) circuits* of arbitrary constant depth and super-linear size. This PRG fools circuits with depth $d \in \mathbb{N}$ and $n^{1+\delta}$ wires, where $\delta = 2^{-O(d)}$, using seed length $O(n^{1-\delta})$ and with error $2^{-n^{\delta}}$. This tightly matches the best known lower bounds for this circuit class. As a consequence of our result, all the known hardness for LTF circuits has now effectively been translated into pseudorandomness. This brings the extensive effort in the last decade to construct PRGs and deterministic circuit-analysis algorithms for this class to the point where any subsequent improvement would yield breakthrough lower bounds.

Our second contribution is a PRG for De Morgan formulas of size $s$ whose seed length is $s^{1/3+o(1)} \cdot \mathrm{polylog}(1/\epsilon)$ for error $\epsilon$. In particular, our PRG can fool formulas of sub-cubic size $s = n^{3-\Omega(1)}$ with an exponentially small error $\epsilon = \exp(-n^{\Omega(1)})$. This significantly improves the inverse-polynomial error of the previous state-of-the-art for such formulas by Impagliazzo, Meka, and Zuckerman (FOCS 2012), and again tightly matches the best currently-known lower bounds for this class.

In both settings, a key ingredient in our constructions is a pseudorandom restriction procedure that has tiny failure probability, but simplifies the function to a non-natural "hybrid computational model" that combines several computational models. As part of our proofs we also construct "extremely low-error" PRGs for related circuit classes; for example, we construct a PRG for the class of functions computable by an arbitrary function of $s$ linear threshold functions that can handle even the extreme setting of parameters $s = n/\mathrm{polylog}(n)$ and $\epsilon = 2^{-n/\mathrm{polylog}(n)}$.

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# 1   Introduction

A `pseudorandom generator` (PRG) for a class $\mathcal{F}$ of functions $\{0,1\}^n \to \mathbb{R}$ is an efficient (deterministic) algorithm that maps a short random seed of length $\ell$ into a longer string of length $n$ such that for every $f \in \mathcal{F}$,

$$\left| \mathop{\mathbb{E}}_{s \in \{0,1\}^\ell}[f(G(s)] - \mathop{\mathbb{E}}_{x \in \{0,1\}^n}[f(x)] \right| \leq \epsilon \,,$$

where $\epsilon$ is called the `error` of the PRG.

In this work we present new constructions of PRGs for two of the most widely-studied non-uniform circuit classes in complexity theory. Our main result is a construction of the *first non-trivial PRG for linear threshold (`LTF`) circuits* of arbitrary constant depth and super-linear size. Prior to this work no non-trivial PRGs or deterministic satisfiability algorithms were known for `LTF` circuits of depth $d \geq 3$, and our result builds on considerable efforts dedicated to this challenge in the last decade. Moreover, our PRG is not only the first non-trivial one, but in fact already *tightly matches the best known lower bounds for `LTF` circuits* in terms of size and of error. Our second result is a PRG for De Morgan formulas of sub-cubic size that has an exponentially-small error, where this error significantly improves on the previous state-of-the-art by [IMZ12]. In this setting too, the parameters of our PRG tightly match the best known lower bounds and correlation bounds for De Morgan formulas. Thus, in both settings, essentially any improvement in dependency of our PRGs on the circuit size or on the target error would improve the best known lower bounds for the corresponding circuit class.

A common initial technical challenge that underlies both of our PRGs is that of constructing *pseudorandom restriction procedures* that "simplify" the circuit with an *exponentially-small failure probability.* The obstacle here is that the natural (and well-known) definitions of simplification do not yield such small failure probability, even if the restrictions were completely random. To overcome this obstacle, following [Hås14; CSS16; ST17a; Tal17b], we explore `hybrid computational models` that, despite being less natural, satisfy the following two competing properties: (1) They are strong enough so that the circuits simplify to those hybrid models except for an exponentially-small probability; and (2) They are weak enough that we can fool them using a PRG with a suitable seed length. Our proofs hinge on a careful balance of this trade-off, as well as on PRG constructions for the corresponding hybrid model, both of which significantly improve on known technical results.

## 1.1   A PRG for super-linear size `LTF` circuits

Recall that a `linear threshold function` (LTF) is a Boolean function of the form $\Phi(x) = 1 \iff \sum_i w_i \cdot x_i > \theta$, where $w \in \mathbb{R}^n$ and $\theta \in \mathbb{R}$. The class of `constant-depth linear-threshold circuits` (LTF circuits) consists of circuits of constant depth whose gates can compute arbitrary LTFs. This circuit class has been studied since the '80s, both since it serves as a natural simple model of neural networks, and since it is a natural extension of circuit classes for which strong lower bounds have already been proved, such as $\mathsf{AC}^0$ and $\mathsf{AC}^0[p]$.

While the common belief is that the class $\mathsf{TC}^0$ of polynomial-sized constant-depth `LTF` circuits[1] is strictly weaker than the class $\mathsf{NC}^1$ (of polynomial-sized De Morgan formulas), at the moment we do not even know of a function in $\mathsf{EXP}^{\mathsf{NP}}$ that is hard for $\mathsf{TC}^0$. In fact, we do not even know lower bounds for `LTF` circuits of size (say) $n^{1.1}$: The best currently-known lower bounds against explicit functions were proved more than 25 years ago by Impagliazzo, Paturi, and Saks [IPS93], who showed that the parity function is hard for `LTF` circuits of depth

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[1]The class $\mathsf{TC}^0$ is sometimes defined using unweighted majority gates and sometimes defined using `LTF` gates. Both definitions are equivalent up to polynomial overheads (see [GHR92; GK98]), but since we will be concerned with precise size bounds we will use a specific definition. Note that our PRG fools the stronger class.

$d$ with $n^{1+c^{-d}}$ wires, for some constant $c > 1$.[2] Despite the fact that no lower bounds for larger LTF circuits are known, *average-case* lower-bounds for circuits of the same size (up to the constant $c$) against functions in P were proved several years ago by Chen, Santhanam, and Srinivasan [CSS16]. Also, for the special case of $d = 2$, Kane and Williams [KW16] proved that Andreev's function (which is in P) is hard for circuits with $n^{2.49}$ wires.

In the last decade, a line of works pioneered by Williams (see, e.g. [Wil13; BSV14; MW18; CLW20]) showed that lower bounds for a circuit class can be proved by constructing non-trivial deterministic circuit-analysis algorithms for circuits from this class; that is, by constructing algorithms for satisfiability or for CAPP[3] that are faster than the trivial brute-force algorithm. Following Williams' [Wil11] breakthrough lower bounds for ACC$^0$ circuits that relied on this approach, the natural subsequent major challenge in complexity theory is to try and finally prove better lower bounds for LTF circuits by constructing circuit-analysis algorithms for such circuits – see, e.g., the first open problem in [Aar16], and also see [Wil13; SW13; MW18; CW19]. However, a major shortcoming is that so far we have not even been able to construct circuit-analysis algorithms that imply the *existing* lower bounds for LTF circuits from 1993, let alone new lower bounds; in other words, so far we have not even been able to "translate the known hardness into randomness".

Accordingly, in the past decade an extensive research effort has been devoted to this challenge, resulting in dozens of exciting works. For a single LTF (i.e., a single "gate" in the circuit), a long line-of-works culminated in a PRG with near-optimal seed length by Gopalan, Kane, and Meka (see [GKM15], following [DGJSV10; RS10; DKN10; Kan11; KRS12; MZ13; Kan14; KM15]). Various works constructed PRGs for "simple functions" of LTFs, for example for AND $\circ$ LTF (aka polytopes, see [GOWZ10; DKN10; HKM12; ST17b; CDS19; OST19; KKLMO20]). For LTF circuits of *depth two* and subquadratic size, a PRG with seed length $n^{1-\Omega(1)}$ was constructed by Servedio and Tan [ST17a]; and a satisfiability algorithm with running time $2^{n-n^{\Omega(1)}}$ was constructed by Alman, Chan, and Williams [ACW16] (following [IPS13; Wil18; Tam16]; this algorithm also works for the larger class AC$^0[m] \circ \text{LTF}_{n^{2-\Omega(1)}} \circ \text{LTF}$, see Section 3). However, despite these efforts, for circuits of *arbitrary depth* $d > 2$, prior to this work no non-trivial deterministic satisfiability or CAPP algorithm was known. The only known deterministic circuit-analysis algorithm for such circuits was an algorithm for the relaxed version of CAPP called *quantified derandomization* (see [Tel18]), algorithms for which are not known to imply lower bounds. We defer further discussion of other relevant works to Section 3.

Building on the rich ideas developed in the last decade, in this paper we construct the *first non-trivial PRG for LTF circuits* of arbitrary constant depth. Moreover, as we explain below, our PRG construction *tightly matches the best currently-known lower bounds* for such circuits – both the size lower bounds of [IPS93] and the average-case lower bounds of [CSS16]. Thus, our construction brings the extensive research effort described above to the point where essentially further improvement would yield new lower bounds for LTF circuits.

**Theorem 1.1** (PRG for super-linear LTF circuits). *For any $d \in \mathbb{N}$ and $\delta \leq 100^{-d}$, there exists a polynomial-time computable $\epsilon$-PRG for the class of LTF circuits of depth $d$ with at most $n^{1+\delta}$ wires, whose seed length is $O(n^{1-\delta})$ and whose error is $\epsilon = 2^{-n^\delta}$.*

We comment that Theorem 1.1 holds also for super-constant values of $d \in \mathbb{N}$ (see Theorem 6.23 for details). Looking closely at the parameters of our PRG, the seed length

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[2]Here, by "explicit" we mean that these lower bounds are against functions in P. There are also incomparable lower bounds for *general circuits* (that in particular hold for LTF circuits) against functions that are "not very explicit", and in particular are not even known to be in NP (see, e.g., [Kan82; BFT98; San09]). We also note that the precise value of the constant $c > 1$ in this expression turns out to be surprisingly important (see [CT19]).

[3]Recall that CAPP (the Circuit Acceptance Probability Problem) is the problem of distinguishing between circuits with acceptance probability at most $1/3$ and circuits with acceptance probability at least $2/3$.

$O(n^{1-\delta})$ is "slightly non-trivial" (yielding a CAPP algorithm with running time $2^{O(n^{1-\delta})}$), yet essentially any improvement to this seed length would yield new size lower bounds for LTF circuits (see Proposition 4.11). Also, the error of our PRG is *exponentially-small*, and again essentially any improvement to this error would imply new average-case lower bounds for LTF circuits (with respect to a natural polynomial-time-samplable distribution; again, see Proposition 4.11). It might seem surprising that the first non-trivial PRG already has such a small error, but this is not a coincidence: As explained above, a key technical challenge underlying our techniques is to reduce the error of certain auxiliary pseudorandom algorithms (i.e., of pseudorandom restriction procedures and of PRGs for a related class; we elaboare on this in Section 2.1).

As part of our proof of Theorem 1.1 we also construct an "extremely-low-error" PRG for an *arbitrary function* of a bounded number of LTFs. In particular, our PRG fools any function of $s = n^{.99}$ LTFs with error $\epsilon = 2^{-n^{.99}}$ and seed length $n^{1-\Omega(1)}$; this setting of parameters is close to the maximal possible one (as there does not exist a non-trivial PRG for an arbitrary function of $n$ variables, or with error $2^{-n}$), and indeed we will use this PRG with such small error $\epsilon \approx 2^{-n^{.99}}$ in our proof of Theorem 1.1. Our PRG significantly improves on the previous state-of-the-art, which could handle functions of $o(n^{2/5})$ LTFs and whose error is sub-exponential (see Section 3 for details). To present this result, for any $n, s \in \mathbb{N}$ denote by $\text{ANY}_s \circ \text{LTF}_n$ the class of functions $\{0,1\}^n \to \{0,1\}$ of the form $f(x) = g(\Phi_1(x), \dots, \Phi_s(x))$, where the $\Phi_i$'s are LTFs and $g$ is *arbitrary*. We prove that:

**Theorem 1.2** (low-error PRG for $\text{ANY}_s \circ \text{LTF}$). *There exists an $\epsilon$-PRG for $\text{ANY}_s \circ \text{LTF}_n$ that is computable in time* $\text{poly}(n)$ *with seed length* $\widetilde{O}\left(\sqrt{n \cdot (s + \log(1/\epsilon))}\right)$.

One corollary of Theorem 1.2 is a PRG with seed length $o(n)$ and error $\epsilon = 2^{-n/\text{polylog}(n)}$ for the class of LTF circuits with *unbounded depth* and *at most* $\frac{n}{\text{polylog}(n)}$ *gates* (see Corollary 6.20). The class of unbounded-depth LTF circuits has received less attention in recent years, compared to $\text{TC}^0$, and our PRG almost matches the $\Omega(n)$ lower bound that has been known for this class since the early '90s (see [GT91; ROS94; Nis93]).

## 1.2 A low-error PRG for De Morgan formulas

Our second main result is a PRG for the class of De Morgan formulas, which consists of formulas of fan-in 2 over the De Morgan basis (i.e., with AND, OR, and NOT gates). This class has been widely-studied since the early '60s, with a focus on the sub-class $\text{NC}^1$ of polynomial-sized formulas, which is a non-uniform analogue of computation in parallel logarithmic time.

A common conjecture is that $\text{NC}^1$ cannot compute all functions in P. However, at the moment, the best lower bounds that we know for $\text{NC}^1$ against explicit functions hold for De Morgan formulas of size $\frac{n^3}{\text{polylog}(n)}$; these were proved by Håstad [Hås98] (following [Sub61; Khr71; And87; IN93; PZ93]), with subsequent log-factor improvements [Tal14; Tal17a]. These bounds were extended to average-case lower bounds by Komargodski, Raz, and Tal [KRT17] and Bogdanov [Bog18] (following [San10; KR13]; see also [IK17; Tal17a]), who showed that for any parameter $r \leq n$, De Morgan formulas of size $\frac{n^3}{r^2 \cdot \text{polylog}(n)}$ cannot compute a corresponding function in P with success probability more than $1/2 + 2^{-r}$; in particular, for $r = n^\delta$, this gives an average-case lower bound of $1/2 + 2^{-n^\delta}$ for De Morgan formulas of size $n^{3-2\delta-o(1)}$.

Almost a decade ago, Impagliazzo, Meka, and Zuckerman [IMZ12] were able to essentially match the known *formula size* lower bounds with a polynomial-time computable PRG, which has seed length $s^{1/3+o(1)}$, fooling De Morgan formulas of size $s$. While their PRG matches the known size lower bounds, it unfortunately supports only inverse-polynomial

error and not exponentially small error,[4] and therefore does not match the known *average-case* lower bounds, which assert at most an exponentially-small advantage. Later on, Kabanets, Koroth, Lu, Myrisiotis, and Oliveira [KKLMO20, Theorem 2] constructed a PRG for De Morgan formulas whose leaves are labeled by functions with low communication complexity. Their PRG fools a more general class, and its seed length has logarithmic dependency on the error parameter, but unfortunately the seed length is proportional to $\sqrt{s}$, and therefore this PRG is non-trivial only when the formulas are of quadratic size rather than of cubic size.

In this work we construct a PRG that nearly-matches the known lower bounds for De Morgan formulas both in terms of formula size and in terms of the average-case hardness (i.e., in terms of the error probability of the PRG). In more detail:

**Theorem 1.3** (low-error PRG for De Morgan formulas). *There exists a polynomial-time computable $\epsilon$-PRG for De Morgan formulas of size $s$ on $n$ variables with seed length*

$$\left(s^{1/3} \cdot \log^{2/3}(1/\epsilon) + \log^2(1/\epsilon)\right) \cdot 2^{O(\sqrt{\log s})} \cdot \text{polylog}(n) = s^{1/3+o(1)} \cdot \text{polylog}(n/\epsilon) \ .$$

As one particular setting of the parameters, our PRG yields a function in NP that cannot be computed by De Morgan formulas of size $n^{3-2\delta-o(1)}$ with success probability more than $1/2 + 2^{n^{-\delta}}$ over a natural polynomial-time-samplable distribution, for any $\delta > 0$ (see Proposition 4.11). This essentially matches the best known average-case lower bounds for De Morgan formulas by [KRT17; Bog18], which were mentioned above.

## 2 High-level proof overviews

We now present high-level overviews of our proofs. First, in Section 2.1, we will describe the common high-level technical challenge underlying both constructions, and our general approach for handling this challenge. Then in Section 2.2 we describe our construction of a PRG for De Morgan formulas (i.e., Theorem 1.3), which is considerably simpler than our PRG for LTF circuits and nevertheless showcases our approach. Finally, in Section 2.3, we move on to the more involved construction of a PRG for LTF circuits (Theorem 1.1).

### 2.1 The common high-level technical approach

Like most of the known unconditional PRGs for circuit classes, our constructions are based on *pseudorandom restrictions* that simplify every circuit in the class to a simpler circuit, with high probability.[5] There are many known frameworks for obtaining PRGs from pseudorandom restrictions (see, e.g. [AW85; IMZ12; GMRTV12; CHHL19]), yet a common property is that the error of the PRG crucially depends on the *failure probability* of each restriction (i.e., the probability that the circuit does not simplify under restriction). In particular, when each restriction fails with probability $p$ or more (where $p$ is the fraction of variables kept alive by the restriction), we do not obtain any non-trivial PRG. (This is because these PRGs typically involve at least $p^{-1}$ applications of restrictions.)

In classical analyses of restrictions (e.g., in [Hås87; Hås98]), one aims to prove that every circuit simplifies to a circuit from the same class that is shallower or of significantly smaller size. The main problem for us is that such statements simply *do not hold with very high*

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[4]More precisely, the result statements in [IMZ12] assert an error of $s^{-O(1)}$, but a careful examination of their analysis shows that an error of $1/s^{o(\log s)^{1/3}}$ is possible with similar seed length $s^{1/3+o(1)}$. Nonetheless, when the error is $1/s^{\omega(\log s)^{1/3}}$ the seed length becomes trivial.

[5]Recall that a `restriction` is a partial assignment to the input variables. Following standard convention, throughout the section the letter $p$ will denote the probability that each variable remains alive (i.e., unassigned) under a random or pseudorandom restriction.

*probability* for LTF circuits or for De Morgan formulas. For example, a size-$n$ De Morgan formula might only depend on $O(\log n)$ variables. Under a random restriction, the formula remains completely intact with probability $p^{O(\log n)} > 2^{-O(\log(n)^2)}$. For LTF circuits the situation is even worse: Even a *single majority gate* fails to simplify with sufficiently high probability; we would like the gate to become constant under the restriction, or at least extremely biased, but the probability of that not happening is at least $\sqrt{p} \gg p$. This means that *we cannot hope to get any non-trivial PRG for* LTF *circuits using this approach*, and this has indeed been a main bottleneck prior to the current work.[6]

Our way to bypass this obstacle in both settings, generalizing ideas from [Hås14; CSS16; ST17a; Tal17b], is to change the definition of what it means to "simplify". Instead of trying to claim that each circuit simplifies to a shallower or smaller circuit, as in classical results, we will claim that the restricted circuit can be computed by a hybrid computational model, which is an artificial combination of several models that is nevertheless "simpler" in some useful sense. Indeed, in both settings this relaxation allows us to reduce the failure probability of the restriction to be *exponentially-small*. The trade-off, though, is that we will have to deal with restricted functions that are more complicated than just simpler circuits from the same class (i.e., they are computable by hybrid models). Our proofs will hinge on a careful balance of this trade-off. For example, improving on a previous result of [CSS16], we will show that with probability $1 - \exp(-n^{\Omega(1)})$, restricted LTF circuits of super-linear size can be approximated by a decision tree of depth significantly less than $p \cdot n$ whose nodes query both variables and LTFs, and whose leaves are labeled by (small sets of) LTFs (see Proposition 2.2 and the preceding explanation); indeed, the precise balance of parameters here is crucial for our PRG construction.

To be more specific, in each of the two settings we will need three new technical results to construct our PRG. First, we will show that a truly random restriction simplifies the circuit to a suitable hybrid model with probability $1 - \exp(-n^{\Omega(1)})$. Then, to use a restrictions-to-PRG framework, we will derandomize the latter result, showing that a suitable *pseudorandom restriction* also simplifies the circuit to the corresponding hybrid model with probability $1 - \exp(-n^{\Omega(1)})$.[7] And lastly, we will have to fool the hybrid model in a way useful for the particular restrictions-to-PRG framework; for LTF circuits we construct a new PRG for the hybrid model (which will be a corollary of Theorem 1.2), whereas for De Morgan formulas we will refine an extractor-based argument of [IMZ12] to work for the hybrid model.

We stress that our motivation for undertaking this approach is different in each of the two settings. For De Morgan formulas, we want to improve the error of the previous state-of-the-art PRG of [IMZ12]. However, for LTF circuits, as mentioned above, the failure probability of previously-known restrictions was a bottleneck toward obtaining *any* PRG whatsoever. Our motivation for reducing the failure probability is in order to construct the first non-trivial PRG for this class.

We comment that this general approach is also useful for fooling other circuit classes. For *branching programs* and for *formulas over an arbitrary basis*, it can provide PRGs with improved dependence on error compared to the previous state-of-the-art by Impagliazzo, Meka, and Zuckerman [IMZ12]. However, for these two classes, it turns out that a more elementary approach gives even better parameters. We defer the details to Appendix B.

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[6]In fact, to materialize our approach and get a non-trivial PRG for LTF circuits we will have to show restrictions that fail with *exponentially-small* probability (which is indeed what we show); see Section 2.3 for details.

[7]We note in advance that our technical result statements typically already assert the result for a pseudorandom restriction (which is stronger than the corresponding result for a random restriction).

## 2.2 Low-error PRG for De Morgan formulas

For De Morgan formulas we will build on the PRG framework of Impagliazzo, Meka, and Zuckerman [IMZ12], which they used to construct the previous state-of-the-art PRG. Loosely speaking, their PRG framework combines $t \approx p^{-1}$ restrictions, and the PRG's error suffers a union-bound over the failure probability of these $t$ restrictions. It is well-known that a random restriction shrinks every size-$s$ De Morgan formula to a formula of expected size $O(p^2 \cdot s)$ (see [Hås98; Tal14]), and in [IMZ12] they showed a concentration bound for this result that also holds for a pseudorandom restriction: For $p \geq 1/\sqrt{s}$, their restriction shrinks every size-$s$ De Morgan formula to a formula of size $p^{2-o(1)} \cdot s$ with probability $1 - s^{-O(1)}$ (see [IMZ12, Lemma 4.8]).

As mentioned in Section 2.1, it is impossible to improve the failure probability in their result to be smaller than $p^{O(\log(n))} > 2^{-\log(n)^2}$, since a De Morgan formula that is sensitive only to $O(\log(n))$ input variables does not simplify at all with such probability.[8] Nevertheless, in this counterexample, a small number of variables are the ones responsible for the function's failure to simplify: In fact, if we were allowed to make a small number of "queries" to variables, the function would become trivial.

We show that *in general*, querying only a small number of variables helps us avoid almost all possible failure scenarios for the restriction: For any De Morgan formula of size $s$, with probability $1 - \epsilon$ over a random restriction, the restricted formula can be $\epsilon$-approximated by a decision tree of depth $s^{o(1)} \cdot \text{polylog}(1/\epsilon)$ whose leaves are labeled by formulas of size $p^{2-o(1)} \cdot s$. Moreover, we show that this happens also for a suitable pseudorandom restriction:

**Proposition 2.1** (low-error pseudorandom restrictions for De Morgan formulas; informal, see Theorem 5.7). *For any $n, s \in \mathbb{N}$, $p \in (1/n, 1/2)$ and $\epsilon > 0$, there exists a distribution over restrictions $\rho \in \{0, 1, \star\}^n$ keeping each variable alive with marginal probability $p' \geq p$ that is samplable in time $\text{poly}(n, s)$ with $s^{o(1)} \cdot \text{polylog}(n/\epsilon)$ random bits and satisfies the following. For every size-$s$ De Morgan formula $f$, with probability at least $1 - \epsilon$ the formula $f\!\restriction_\rho$ can be $\epsilon$-approximated by a decision tree of depth $s^{o(1)} \cdot \text{polylog}(sn/\epsilon)$ with formulas of size $p^{2-o(1)} \cdot s$ at its leaves.[9]*

Let us first describe the main idea in the proof of Proposition 2.1. Recall that a De Morgan formula is called read-$k$ if each variable appears at most $k$ times among the leaves. In [IMZ12] they first showed that *read-$k$ formulas* shrink with extremely high probability; specifically, for $k = \frac{p^{O(1)}}{\log(s/\epsilon)} \cdot s$, they showed that a pseudorandom restriction shrinks any read-$k$ formula from size $s$ to size $O(p^2 \cdot s)$, with probability $1 - \epsilon$. This can indeed yield an exponentially-small error with seed length smaller than $n$, and the main part in their analysis that increases the error to $1/\text{poly}(s)$ is a subtle reduction from the case of general De Morgan formulas to the case of read-$k$ De Morgan formulas. (Similarly, the analyses of [KR13; KRT17; CKKSZ15] also had to handle the "heavy" variables in a non-trivial manner.)

Our key observation here is simple: Using a DT, we can just *query all the "heavy" variables*, i.e., variables that appear more than $k$ times, thereby reducing the case of a general De Morgan formula to the case of a DT with read-$k$ De Morgan formulas at its leaves. Since there are at most $s/k$ heavy variables, the depth of our DT will be at most $s/k = \text{poly}(p^{-1}) \cdot \log(s/\epsilon)$. While this does not yet achieve the parameters stated in Proposition 2.1, we follow [IMZ12] in composing less than $\log(1/p)$ restrictions that each keep a $q = s^{-o(1)}$ fraction of live variables

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[8] Recall that (by a counting argument) for any $c \in \mathbb{N}$ there exist functions over $O(\log(n))$ variables that require formulas of size $n^c$, so this counter-example holds also for polynomial-sized formulas.

[9] To use this result in our PRG construction we actually need a stronger notion of approximation. In our technical result we show that the formula is approximated with "zero-error" by the hybrid model, but for simplicity we ignore this in the high-level overview (see Section 5 for details).

such that their composition keeps a $p$ fraction of live variables; the depth of our DT is thus less than $\log(1/p) \cdot \text{poly}(q^{-1}) \cdot \log(s/\epsilon) < s^{o(1)} \cdot \text{polylog}(sn/\epsilon)$, as stated in Proposition 2.1.

The trade-off, however, is that since we simplify a De Morgan formula to a hybrid model rather than to a smaller De Morgan formula, a naive application of the PRG framework of [IMZ12] would yield a trivial seed length: This is because the seed length in their analysis is proportional to the description length of the restricted function, whereas our hybrid model requires a very large description (exponential in its depth). To overcome this we modify their analysis such that it can handle our hybrid model. Specifically, we show that if the restricted function can be computed by a DT with $m$ leaves, each labeled with a function of description length $s_0$, then we can replace an additive term of $\widetilde{O}(m \cdot s_0)$ in the seed length (which is too much for us) with an additive term of $\widetilde{O}(s_0 + \log(m))$, at the (mild) cost of multiplying the final seed length by $\log(m/\epsilon)$. We defer the full description to Section 5.4.[10]

## 2.3 PRG for super-linear LTF circuits

We now describe the proof of Theorem 1.1. For simplicity, in the high-level overview we think of $d \in \mathbb{N}$ as a constant, and fix $\delta = 2^{-O(d)}$, where the $O$ hides a universal constant. We want to construct a PRG for LTF circuits of depth $d$ with at most $n^{1+\delta}$ wires, which has seed length $n^{1-\delta}$ and error $2^{-n^\delta}$. As part of this proof we will also describe the proof of Theorem 1.2 (our PRG for $\text{ANY}_s \circ \text{LTF}_n$), and a self-contained description of the latter appears in Section 2.3.3.

### 2.3.1 Overview: Basic ideas and main challenges

For this setting we will use the classical restrictions-to-PRG framework of Ajtai and Wigderson [AW85]. The first component needed to instantiate this framework is a pseudorandom restriction, or more specifically a pseudorandom way to choose $\approx p \cdot n$ variables such that for every LTF circuit with depth $d$ and $n^{1+\delta}$ wires, when fixing the rest of the variables *uniformly*, with high probability the circuit simplifies to some class $\mathsf{C}_{\text{simple}}$. The second component that we need is a PRG for the class $\mathsf{C}_{\text{simple}}$.

Random restrictions for LTF circuits of depth $d$ with $n^{1+\delta}$ wires were previously studied in [IPZ01; CSS16]. In the most relevant result to our setting, Chen, Santhanam, and Srinivasan [CSS16, Lemma 39] proved that a random restriction simplifies any such circuit to a corresponding hybrid model with *exponentially-small* failure probability (jumping ahead, the hybrid model that we will use will be a refinement of their hybrid model). Moreover, even a *pseudorandom* restriction procedure for such circuits is already known (see [Tel18]). The foregoing procedures (as well as all other procedures that we will mention below) use the parameter value $p = n^{-\alpha}$, where $\alpha$ is a small constant. However, these restriction procedures do not suffice in order to obtain a PRG via the [AW85] framework. Concretely, we are faced with three main challenges:

1. **Stronger simplification of the restricted function.** The first challenge is that in previous analyses *the hybrid model to which the restricted* LTF *circuit simplifies is not "simple enough"* to be useful in known restrictions-to-PRG frameworks. Specifically, to get a PRG we will need to "fool" the restricted circuit using significantly less randomness than the remaining $p \cdot n$ bits. However, in [CSS16; Tel18] the hybrid model involves a DT of depth

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[10]In a nutshell, instead of treating the entire tree as a single computational device with exponential description length, we express the tree as a sum over $m$ functions, one per leaf. Then, to $\epsilon$-fool the entire tree it suffices to $\epsilon/m$-fool every single path in the tree. Indeed, each path has a succinct description that fits the PRG framework of [IMZ12], and the crucial point for us is that in this framework the seed length only increases *logarithmically* in the error $\epsilon/m$ of *"fooling"* the restricted model. See Section 5.4 for further details.

$(1 - o(1)) \cdot (p \cdot n)$, which requires seed length essentially $p \cdot n$ to "fool".[11] We need to show that random restrictions (and, later on, pseudorandom ones) simplify any LTF circuit to a "sufficiently simple" hybrid model, for which we can (potentially) construct an unconditional PRG with seed length $o(p \cdot n)$.

2. **Low-error derandomization.** The second challenge is that *the error probability of the known pseudorandom restriction procedure is too large* to be useful in the known restrictions-to-PRG frameworks. As mentioned in Section 2.1, the [AW85] framework involves a union-bound over $p^{-1}$ restrictions, and therefore the error of each restriction has to be at most $p$. However, the analysis of pseudorandom restrictions in [Tel18] only bounds the error by $p^{1/5}$, using a naive concentration bound (i.e., Markov's inequality); whereas the analysis of [CSS16] for truly uniform restrictions relies on a read-$k$ Chernoff bound (i.e., on [GLSS15]), which is not known to hold for a suitable pseudorandom distribution.

3. **Constructing a PRG for the hybrid model.** Lastly, after we show that suitable pseudorandom restrictions simplify any LTF circuit to a "sufficiently simple" hybrid model with sufficiently-small failure probability, we need to *construct a PRG with seed length $o(p \cdot n)$ and error smaller than $p$* for the hybrid model. As we will explain in Section 2.3.3, previously-known PRG constructions do not seem to suffice for this purpose.

We now state our two key technical results underlying Theorem 1.1, corresponding to the challenges above. First, we construct a pseudorandom restriction procedure with seed length approximately $p^{-1}$ and failure probability $\epsilon = 2^{-n^\delta}$ that simplifies any LTF circuit of super-linear size to a sufficiently simple hybrid model. In more detail, the hybrid model that we consider is a DT whose gates query *both LTFs and variables*, with no more than $p^{\Omega(1)} \cdot (p \cdot n)$ variables and $O(n^{1/4})$ LTFs queried in each path, and whose leaves are labeled by LTFs. Indeed, the precise depth and number of queries of each type that this DT makes are of crucial importance to our results. (Our actual hybrid model is unfortunately slightly more complicated, labelling each leaf with a small set of LTFs rather than with a single LTF, since for our PRG we will need to show that any LTF circuit can be *sandwiched with error $\epsilon$* between two functions that are each computable by such a hybrid model. For simplicity, we ignore this fact and the more complicated model in the high-level overview.)

**Proposition 2.2** (low-error pseudorandom restrictions for super-linear LTF circuits; informal, see Corollary 6.12). *For any constant $d \in \mathbb{N}$ and $\delta = \frac{1}{2} \cdot 50^{-d}$, there is a distribution over subsets $\mathbf{I} \subseteq [n]$ of size $\lceil pn \rceil$, where $p = n^{-(1+\delta)/10}$, that can be sampled in time $\mathrm{poly}(n)$ with $n^{1/10 + O(\delta)}$ random bits, such that the following holds. For any depth-$d$ LTF circuit over $n$ bits and with $n^{1+\delta}$ wires, when fixing uniform values for the variables in $[n] \setminus \mathbf{I}$, with probability at least $1 - 2^{-n^\delta}$ the restricted circuit can be $2^{-n^\delta}$-approximated by a decision tree in which each path queries at most $p^{\Omega(1)} \cdot (p \cdot n)$ variables and $O(n^{1/4})$ LTFs, and each leaf is labeled by an LTF.*

Our second key technical result is a low-error PRG for the hybrid model from Proposition 2.2, which has seed length $p^{\Omega(1)} \cdot (p \cdot n)$ (note that this is essentially the best possible seed length, given that the DT queries $p^{\Omega(1)} \cdot (p \cdot n)$ variables in each path). This low-error PRG will follow as a special case of the PRG that was stated in Theorem 1.2.

**Proposition 2.3** (low-error PRG for the hybrid model; informal, see Theorem 6.19). *Consider the class of functions over $n'$ input bits that are computable by decision trees that in each path query at most $D$ variables and $M$ LTF functions, and whose leaves are labeled by LTFs. Then, there exists an $\epsilon$-PRG for this class, computable in $\mathrm{poly}(n')$ time, with seed length $\widetilde{O}\left(\sqrt{n' \cdot (D + M + \log(1/\epsilon))}\right)$.*

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[11]In [Tel18], the pseudorandom algorithm gets as input an LTF circuit and queries variables according to that specific circuit, but this argument can be easily converted to a "black-box" pseudorandom restriction algorithm that simplifies any circuit to a DT with parameters essentially as in [CSS16].

In our application, given the restriction procedure in Proposition 2.2, we will have $n' = \lceil pn \rceil$ and $D = p^{\Omega(1)} \cdot (p \cdot n)$ and $M = O(n^{1/4})$, and we will use the error parameter $\epsilon = 2^{-n^{\delta}}$. Therefore, the seed length of the PRG from Proposition 2.3 will be dominated by $\widetilde{O}(\sqrt{(p \cdot n) \cdot D}) \le p^{\Omega(1)} \cdot (p \cdot n)$.

In the following Sections 2.3.2 and 2.3.3 we will describe the main ideas behind the proofs of Propositions 2.2 and 2.3, respectively. We note that these two sections can be read independently of each other.

### 2.3.2 Low-error pseudorandom restrictions that "sufficiently simplify" the circuit

We now describe the proof of Proposition 2.2, in high-level and while not specifying precise parameter values for simplicity. We will iteratively restrict the circuit for $d - 1$ iterations; in each iteration $i$ we start with a DT whose leaves are labeled by LTF circuits of depth $i$, and our goal is to simplify it to a DT whose leaves are labeled by LTF circuits of depth $i - 1$. For simplicity, let us first ignore the parameters of the DT, and just focus on a single circuit.

**A single iteration.** We choose the variables to keep alive via a $k$-wise independent distribution, for $k \approx p^{-1} \cdot \log(1/\epsilon)$. Following [CSS16; Tel18], we partition the graph between the gates at the bottom layer and the variables into three parts: The one induced by "heavy" variables, the one between "light" gates and "light" variables, and the remaining one between "heavy" gates and "light" gates (we intentionally avoid precise definitions in this high-level description). Our goal is to show that after the restriction, and given appropriate queries of variables and of LTFs by the DT, all light gates will have fan-in at most one, and all heavy gates will become extremely biased. In this case we will replace the heavy gates by the corresponding constant, and will thus be able to reduce the depth of the circuit by one (at a cost of a small approximation error).

*1. Heavy variables.* Analogously to the setting of De Morgan formulas, our DT first queries all the heavy variables. Recall that the circuit has only $n^{1+\delta}$ wires; we define heavy variables so that the DT would query at most $p^{\Omega(1)} \cdot (p \cdot n)$ such variables.

*2. Light gates and light variables.* The subgraph induced by light gates and light variables was handled in previous arguments using a simple graph-theoretic argument, which resulted in a DT that is too deep for our purposes (i.e., the previous DTs were of depth $(1 - o(1)) \cdot (p \cdot n)$ whereas we need depth $o(p \cdot n)$). We handle this subgraph using a more refined graph-theoretic argument. First, we carefully set the parameters (in all other parts of our proof) such that the expected number of variable-pairs in this subgraph that both feed into a common gate and that survive the restriction is $p^{\Omega(1)} \cdot (p \cdot n)$.

Now we prove a concentration bound, showing that with probability $1 - \epsilon$ under our choice of restrictions, indeed at most $p^{\Omega(1)} \cdot (p \cdot n)$ such variable-pairs survive the restriction. To prove this bound we rely on the fact that the subgraph between light gates and light variables has *small degree*: This allows us to partition the light gates into few large sets that read disjoint subsets of variables. Given this concentration bound, with probability $1 - \epsilon$, after the restriction our DT can query all the $p^{\Omega(1)} \cdot (p \cdot n)$ living variables participating in such pairs, hence reducing the fan-in of all gates in the subgraph to at most one (which allows us to merge these gates into the layer above them). See Claim 6.7.1 for precise details.

*3. Heavy gates and light variables.* Lastly, we are left with the subgraph between heavy gates and light variables, which is the most interesting part in the argument. The analysis of [CSS16] for a truly random restriction handled this subgraph with an exponentially-small failure probability; but this analysis relied on a read-$k$ Chernoff bound [GLSS15], which we do not know how to derandomize in our particular setting using only $p \cdot n$ random bits. We use a $k$-wise independent choice of variables to keep alive, and rely on an analysis that refers to the

particular structure of each LTF function (computed by a gate in the circuit) to show that with all but an exponentially-small failure probability, we can simplify this subgraph after at most $p^{\Omega(1)} \cdot (p \cdot n)$ queries to variables and $p^{-O(1)}$ queries to LTFs. Details follow.

The idea underlying previous results is to rely on a "restriction lemma" for a single LTF, which shows that each gate in this subgraph becomes extremely biased with probability $1 - p^{\Omega(1)}$ when restricted (see Section 6.1.2). Thus, we expect the fan-in of each gate in this subgraph to decrease by a factor of about $p$ (recall that gates are heavy), and that all but a $p^{\Omega(1)}$ fraction of the gates will become extremely biased. When this happens, we can replace the extremely biased gates by constants, thereby reducing the number of wires in the subgraph by a $p \cdot p^{\Omega(1)}$ factor, and then we can query of all the $p^{1+\Omega(1)} \cdot n^{1+\delta} = p^{\Omega(1)} \cdot (p \cdot n)$ remaining variables in the subgraph using our DT (hence eliminating the subgraph completely). However, it is not clear how to show that the decrease of $p^{1+\Omega(1)}$ in the number of wires happens with high probability, rather than just in expectation.

Recall that our choice of values for fixed variables is *uniform*, but that our choice of which variables to keep alive is only *k-wise independent*. The key problem is the latter choice might restrict some gates in a manner such that we can no longer claim that a uniform choice of values makes these gates biased with probability $1 - p^{\Omega(1)}$. To overcome this problem, we prove that with all but exponentially-small probability, after choosing the live variables we can use the DT to *query $p^{\Omega(1)} \cdot (p \cdot n)$ additional variables in a careful way, which takes into account the particular structure of each LTF gate*, such that after these queries, each LTF becomes biased with probability at least $1 - p^{\Omega(1)}$ over a uniform choice of values for the restricted variables. We stress that we are considering two different events and distributions here: We are interested in proving that with extremely high probability $1 - \epsilon$, our pseudorandom choice of values is "good" for each and every LTF gate (after querying additional variables); whereas the meaning of "good" here is that with moderately high probability $1 - p^{\Omega(1)}$ over random choice of values for fixed variables, the LTF gate becomes biased. Conditioned on any successful choice of live variables, we can *now* apply the read-*k* Chernoff bound to the uniform choice of values for fixed variables, and deduce that the fraction of unbiased gates is very close to $p^{\Omega(1)}$. One caveat is that during this process, our DT will also query a small number of LTFs, rather than only variables. For further details see the proof of Proposition 6.7.

**Subsequent iterations and approximation errors.** The above procedure transforms a circuit $C_d$ of depth $d$ into a DT over LTFs and variables whose leaves are labeled by circuits of depth $d - 1$ and that *approximates* $C_d$ with very small error, where the approximation error comes from the fact that we replaced biased gates by constants. (As mentioned above, we actually construct both an *upper-sandwiching* approximation and a *lower-sandwiching* approximation, at the cost of labeling each leaf by one depth-$(d - 1)$ LTF circuit and a small set of LTF functions. For simplicity, we ignore this complication in the current overview.)

Our goal now is to iteratively apply further restrictions, in order to further reduce the depth of the LTF circuits at the leaves of the DT, until we reach a DT whose leaves are labeled with LTF circuits of depth one (i.e., LTFs). For $i = d - 1, \ldots, 1$, we reduce the model to a decision tree querying at most $D_i$ variables and $M_i$ gates, and most importantly, whose leaves are circuits of depth $i$. (We index iterations backwards as they correspond to the depth of the LTF circuits on the leaves.) Note that when applying a restriction with value $p_i$ to a DT of depth $D_i$, in addition to claiming that the LTF circuits at the leaves of the DT become shallower, we also need to claim that the depth of the tree itself decreases to roughly $p_i \cdot D_i$ (to ensure that the final depth of the DT is sub-linear in the number of alive variables). We show that in each iteration both statements hold for $1 - \epsilon$ of the leaves.

However, when composing restrictions in this manner we are faced with a subtle issue, which is the bottleneck in the proof that *necessitates having an exponentially-small error in each restriction* (i.e., the argument would not follow through with larger error). Recall that each

leaf contributes a small error to the global tree, where the source of error is that the new DT that labels this leafs only approximates the corresponding function. Also recall that when counting the global error, the underlying distribution refers to the errors each leaf makes on inputs that correspond to this leaf, under a uniform choice of input. The issue arises since the initial DT queries not only variables but also LTFs: Hence, a uniform choice of input does not induce a uniform choice of input *in each leaf*, since the set of inputs that reach any particular leaf are the ones who also satisfy the queries of the LTF gates along the path. In particular, this means that the weight of errors inside each leaf might be amplified. The key to resolving this issue is to rely on the fact there are at most $M_i$ LTFs in each path, and therefore we intuitively expect the distribution over inputs inside the leaf to be skewed by a multiplicative factor of at most $2^{M_i}$. We indeed formalize this intuition, and to solve the issue, in each restriction $i$ we ensure that the number of queried LTFs is at most $M_i = p_i^{-O(1)}$, and we make sure that *the error in the subsequent iteration, $\epsilon_{i-1}$ will be much smaller than $2^{-M_i}$*. (This is done by choosing, in each subsequent iteration, a smaller value for $p_{i-1}$, i.e., $p_{i-1} \ll p_i$.) Hence, the global in the subsequent restriction will be at most $\epsilon_{i-1} \cdot 2^{M_i} \ll \epsilon_i$. For further details see the proof of Proposition 6.9.

### 2.3.3 Low-error PRG for the "sufficiently simple" hybrid model

Our goal in this section is to prove Theorem 1.2, i.e., to construct a PRG for the class $\text{ANY}_s \circ \text{LTF}_n$ of functions that can be computed as an arbitrary function of $s$ LTFs, whose seed length is $\widetilde{O}\left(\sqrt{n \cdot (s + \log(1/\epsilon))}\right)$. Our main application of this result is to prove Proposition 2.3, and we will explain at the end of this section how the latter can be easily obtained as a corollary. We note in advance that the crucial thing for this corollary is that the PRG will be able to handle a tiny error of $\epsilon \approx 2^{-n^{.99}}$.

Until recently, the seed length of known PRGs, even for the special case of $\text{AND} \circ \text{LTF}$, was proportional to $\log(1/\epsilon)^2$, which is too much for us (see [GOWZ10; HKM12; ST17b; OST19]). However, very recently Kabanets, Koroth, Lu, Myrisiotis, and Oliveira [KKLMO20] constructed a PRG that has a better dependency on the error, while simultaneously handling a larger class of composition functions. Specifically, when the composition function is a De Morgan formula of size $s$, their seed length is $\widetilde{O}(\sqrt{n} \cdot s^{1/4} \cdot \log(1/\epsilon))$. While this is still not good enough for our application, their ideas will serve as our starting point.

Let $f(x) = h(g_1(x), \ldots, g_s(x))$ for $g_i$'s that are LTFs and for some composition function $h$. Informally, the main idea underlying [KKLMO20] is to reduce the problem of $\epsilon$-fooling $f$ to the problem of $\delta$-fooling communication protocols for functions of the form $\bar{g}(x) = \prod_{j \in [\Delta]} g_{i_j}(x)$, where $\Delta \in \mathbb{N}$ is not too large but the error $\delta$ is very small. To do so, in the analysis they first $(\epsilon/3)$-approximate $h$ by a real polynomial $p_h$ of bounded degree $\Delta$, then replace each of the monomials $\bar{g}$ of the polynomial by a corresponding randomized communication protocol with error $\epsilon/3s$, and finally claim that our PRG "fools" each of the communication protocols with sufficiently low error $\delta \ll \epsilon/2^{\widetilde{O}(\Delta)}$ allowing for a union-bound over monomials. (See [KKLMO20, Theorem 25] for a detailed analysis.)

Instantiating the approach above with the trivial degree-$s$ polynomial representation of $h$ and with efficient randomized communication protocols for functions of the form $\bar{g}$ and with suitable PRGs for these protocols, the resulting seed length is $\widetilde{O}(\sqrt{n \cdot s} \cdot \log(1/\epsilon))$ (see Section 6.2 for details). Tracking the parameters carefully, the multiplicative term of $\log(1/\epsilon)$ comes from computing each $\bar{g}$ up to error $\epsilon/3s$.

Our main idea is to avoid the multiplicative overhead of $\log(1/\epsilon)$ by *making the polynomial $p_h$ "robust to noise" at each coordinate*, which allows us to use *communication protocols with constant error rather than with error $\epsilon/3s$*. To do so we use a beautiful result of Sherstov [She13]: For every polynomial $p_h$, he constructed a "robust" polynomial $\widetilde{p_h}$ of degree $d = O(\deg(p_h) + \log(1/\epsilon))$ such that for every input $x \in \{0,1\}^n$ and "noise" $\eta \in [-1/3, 1/3]^n$ it holds

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that $\left|p_h(x) - \widetilde{p_h}(x+\eta)\right| < \epsilon$. In high-level, to $\epsilon$-approximate $h(g_1, \ldots, g_s)$ by a low-degree polynomial of communication protocols, we will take a trivial representation of $h$ by a degree-$s$ polynomial $p_h$, convert $p_h$ to the robust polynomial $\widetilde{p_h}$ guaranteed by [She13], and instead of "feeding" $\widetilde{p_h}$ the functions $g_1, \ldots, g_s$, we will feed $\widetilde{p_h}$ the *expected values of the communication protocols for each $g_i$*, while relying on the fact that $\widetilde{p_h}$ is robust to the errors of the protocols.

In more detail, for each $g_i$ denote by $\mathbf{g}_i$ a randomized communication protocol for $g_i$ with error $1/3$. Then, for every $x \in \{0,1\}^n$ we have that

$$\left| h(g_1(x), \ldots, g_s(x)) - \widetilde{p_h}(\mathbb{E}[\mathbf{g}_1(x)], \ldots, \mathbb{E}[\mathbf{g}_s(x)]) \right| < \epsilon/3 ,$$

where we relied on the fact that for each $i$ it holds that $\mathbb{E}[\mathbf{g}_i(x)]$ is $(1/3)$-close to $g_i(x)$ and that $\widetilde{p_h}$ is $(\epsilon/3)$-robust to a noise of up to $1/3$ per coordinate. Our goal is to fool the function $\widetilde{f}(x) = \widetilde{p_h}(\mathbb{E}[\mathbf{g}_1(x)], \ldots, \mathbb{E}[\mathbf{g}_s(x)])$, and we want to show that it suffices to use a PRG that $\delta$-fools communication protocols for functions of the form $\bar{g} = \prod_i g_i$, where $\delta$ is sufficiently small. The final observation that allows us to do so is that any monomial of $\widetilde{f}$, which is of the form $\Pi_i \mathbb{E}[\mathbf{g}_i]$ can be thought of as the expected value of the natural randomized protocol that independently runs protocols for the $g_i$'s and accepts if all of the protocols accepts. Since any PRG for communication protocols also fools the expected value of a randomized protocol, our PRG fools the monomials of $\widetilde{f}$ with low error. Assuming that the error is sufficiently small to allow for a union-bound over monomials (taking into account the weights of their coefficients), our PRG also fools $\widetilde{f}$ itself.

The argument above allows us to replace the $(\epsilon/3s)$-error of the communication protocols by error $\rho = 1/3$. We then instantiate communication protocols (for composition of $d$ LTFs) and PRGs (for the communication protocols) as above, and obtain a PRG for $\text{ANY}_s \circ \text{LTF}$ with seed length $\widetilde{O}(\sqrt{n \cdot d} \cdot \log(1/\rho)) = \widetilde{O}(\sqrt{n \cdot (s + \log(1/\epsilon))})$.

As an aside, observe that our first step was to use a trivial polynomial of degree $s$ to compute the composition $h$. This is unavoidable when $h$ is arbitrary, but when $h$ comes from more a restricted class we can use polynomials with better parameters, yielding a PRG with shorter seed. See Appendix A for details.

**Proposition 2.3 as a corollary of Theorem 1.2.** Let $T$ be a DT with parameters as in Proposition 2.3. We can compute $T$ as $T(x) = \sum_{\ell \in L} I_\ell(x) \cdot \Phi_\ell(x)$, where the summation is over $|L| \leq 2^{D+M}$ leaves, and for each leaf $\ell$ the function $I_\ell$ is the indicator function of $\ell$, and $\Phi_\ell(x)$ is the LTF function that labels $\ell$.[12] It follows that to fool $T$ with error $\delta$, it suffices to fool each term $I_\ell \cdot \Phi_\ell$ with error $\epsilon = \delta \cdot 2^{-(D+M)}$. Now, since the path to each leaf queries $D$ variables and $M$ LTFs, we can express $I_\ell$ as a conjunction of $M+1$ LTFs, one of which will simultaneously test the values of all the $D$ queried variables. Therefore, $I_\ell \cdot \Phi_\ell$ is a conjunction of $M+2$ LTFs, so we can apply Theorem 1.2 with the specific composition function $h = \text{AND}$.

# 3 Previous work on circuit-analysis algorithms for LTF circuits

As mentioned in Section 1.1, a large number of previous works focused on circuit-analysis algorithms for LTF circuits. We now survey the previously-known results, while focusing on *deterministic* circuit-analysis algorithms. (Many randomized circuit-analysis algorithms for LTF circuits are known – see, e.g., [CSS16; ACW16; KL18; KKLMO20] and the references therein – but these are not the focus of this work, and do not imply circuit lower bounds via Williams' [Wil13] approach.)

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[12]Recall that in our actual hybrid model, each leaf is not labeled by a single LTF but rather by a small set of poly($n$) LTFs. We again ignore this issue in the overview for simplicity, and in the actual proof we will simply union-bound over the poly($n$) LTFs at each leaf (see Theorem 6.19 for details).

**Single LTFs and simple compositions of LTFs.** For a single LTF function, a PRG with near-optimal seed length $\widetilde{O}(\log(n/\epsilon))$ was constructed by Gopalan, Kane, and Meka [GKM15], following [DGJSV10; RS10; DKN10; Kan11; KRS12; MZ13; Kan14; KM15]. Concurrently and subsequently, various PRGs were constructed for "simple compositions" of LTFs, and in particular for AND $\circ$ LTF (i.e., for polytopes, see [GOWZ10; DKN10; HKM12; ST17b; CDS19; OST19; KKLMO20]), for monotone functions of LTFs [GOWZ10], and for small De Morgan formulas of LTFs [KKLMO20].

**The class $\text{ANY}_{o(n)} \circ \text{LTF}$.** The problem of fooling $\text{ANY}_s \circ \text{LTF}$ with error $\epsilon$ reduces to fooling $\text{AND}_s \circ \text{LTF}$ with error $\epsilon/2^s$ [CDS19, Footnote 1]. Combining this reduction with the PRG of [KKLMO20, Theorem 30], one can obtain a PRG for $\text{ANY}_s \circ \text{LTF}$ with seed length $\widetilde{O}\big(\sqrt{n} \cdot (s^{5/4} + s^{1/4} \cdot \log(n/\epsilon))\big)$, which is non-trivial for $s \leq n^{2/5}/\text{polylog}(n)$ (note that this result is superseded by Theorem 1.2). Chattopadhyay, De, and Servedio [CDS19] (following [GOWZ10]) constructed a deterministic algorithm that approximately counts the fraction of satisfying assignment for a given $\text{ANY}_s \circ \text{LTF}$ circuit, up to error $\epsilon$, in time $\text{poly}(n) \cdot 2^{\text{poly}(s,1/\epsilon)}$. Note that their running time has an optimal dependency on $n$, but becomes trivial when $s \geq n^{\Omega(1)}$ or $\epsilon \leq n^{-\Omega(1)}$. In comparison, the PRG from Theorem 1.2 always has seed length at least $\sqrt{n}$, which is sub-optimal in the parameter $n$, but its seed length remains $o(n)$ even for $s = n/\text{polylog}(n)$ and $\epsilon = 2^{-n/\text{polylog}(n)}$.

**Constant-depth LTF circuits.** For circuits of depth two (i.e., LTF $\circ$ LTF circuits), Servedio and Tan [ST17a] constructed an $(n^{-O(1)})$-PRG with seed length $n^{1-\Omega(1)}$ that works when the number of wires is subquadratic. In an incomparable result, Alman, Chan, and Williams [ACW16] (following [IPS13; Wil18; Tam16]) constructed a satisfiability algorithm that runs in time $2^{n-n^{\Omega(1)}}$ for the larger class of $\text{AC}^0[m] \circ \text{LTF} \circ \text{LTF}$ circuits of *subexponential size* that have a subquadratic number of LTF gates at their bottom layer.

For LTF circuits of depth $d > 2$, prior to the current work the known PRGs and satisfiability algorithms only handled circuits with at most $n^{.49}$ gates. However, these works extended to the more general model of $\text{AC}^0$ circuits that are augmented by a bounded number LTF gates: Specifically, Servedio and Tan [ST18] (following [Vio07]) constructed a PRG for $\text{AC}^0$ circuits of size $S$ with at most $2^{\alpha \cdot \sqrt{\log S}}$ LTF gates (for a universal constant $\alpha > 0$) whose seed length is $2^{O(\sqrt{\log S})} + \text{polylog}(1/\epsilon)$; and Lovett and Srinivasan [LS11] constructed an incomparable PRG for $\text{AC}^0$ circuits of polynomial size with at most $n^{.49}$ LTF gates whose seed length is $n^{\delta}$ (for an arbitrarily small $\delta > 0$) and whose error is $2^{-n^{.24}}$. See [SSTT16] for another result in this spirit.

The only previously-known algorithm for LTF circuits of depth $d > 2$ and super-linear size was an algorithm for quantified derandomization (i.e., for a relaxed circuit-analysis task) that runs in time $n^{\text{polyloglog}(n)}$ and works when the circuit has $n^{1+2^{-O(d)}}$ wires and evaluates to the same output on all but $2^{n^{1-2^{-O(d)}}}$ of its inputs [Tel18]. In general, quantified derandomization algorithms are not known to imply lower bounds; however, even a very mild improvement in the number of exceptional inputs that the foregoing algorithm can handle (namely, an improvement in the universal constant hiding in the $O$-notation) would yield new lower bounds for $\text{TC}^0$ [CT19].

# 4 Preliminaries

We denote distributions and random variables in boldface. We let $\mathbf{u}_n$ denote the uniform distribution over $\{0,1\}^n$. We will also use the convention of first defining some parameter values (e.g., an input length $n$ and auxiliary parameters denoting size and error bounds) and

then asserting that a uniform algorithm runs within some time bound with respect to these parameter values; in all such statements, we assume that the algorithm explicitly gets all the relevant parameter values as part of its input.

**Definition 4.1** (distance between functions). *We say that two functions $f, g \colon \{0,1\}^n \to \{0,1\}$ are $\epsilon$-close if $|\mathbb{E}[f(\mathbf{u}_n)] - \mathbb{E}[g(\mathbf{u}_n)]| \le \epsilon$.*

**Definition 4.2** (sandwiching). *We say that $f \colon \{0,1\}^n \to \{0,1\}$ is $\epsilon$-upper-sandwiched by $g \colon \{0,1\}^n \to \mathbb{R}$ if for every $x \in \{0,1\}^n$ it holds that $f(x) \le g(x)$, and also $\mathbb{E}[g(\mathbf{u}_n) - f(\mathbf{u}_n)] \le \epsilon$. Similarly, we say that $f$ is $\epsilon$-lower-sandwiched by $g$ if for every $x$ it holds that $g(x) \le f(x)$ and we have that $\mathbb{E}[f(\mathbf{u}_n) - g(\mathbf{u}_n)] \le \epsilon$.*

## 4.1 Standard concentration bounds

We now state several well-known concentration bounds that we will use in the paper. The first is the standard Hoeffding inequality.

**Theorem 4.3** (Hoeffding's inequality [Hoe63, Thm 2]). *Let $w \in \mathbb{R}^n$, and let $\mathbf{z}$ be a uniformly-chosen random vector in $\{-1,1\}^n$. Then, for any $t > 0$ it holds that*

$$\Pr\left[ \left| \langle w, \mathbf{z} \rangle \right| \ge t \cdot \|w\|_2 \right] \le 2\exp(-t^2/2) \,.$$

We also need concentration bounds for two regimes when the random variables are not independent. The first of those, for the case of "read-$k$" random variables, was proved by Gavinsky, Lovett, Saks, and Srinivasan [GLSS15]; and the second one is for random variables that are $k$-wise independent, for which we will use the bound of Bellare and Rompel [BR94].

**Theorem 4.4** (read-$k$ Chernoff bound; [GLSS15, Thm 1.1]). *Let $\{\mathbf{x}_1, ..., \mathbf{x}_n\}$ be independent random variables, and let $\mathbf{y} = \mathbf{y}_1, ..., \mathbf{y}_r$ be a set of functions $\mathbf{x} \to \{0,1\}$ such that each $\mathbf{x}_i$ influences at most $k$ functions from $\mathbf{y}$, where $k \in \mathbb{N}$. Let $\mu = \mathbb{E}[\sum_i \mathbf{y}_i]$. Then, for any $\Delta > 0$,*

$$\Pr\left[ \sum_{i=1}^r \mathbf{y}_i \ge \mu + \Delta \right] \le \exp\left( -\frac{2\Delta^2}{rk} \right).$$

**Theorem 4.5** (tail bound for $k$-wise independence; [BR94, Lemma 2.3]). *Suppose $\mathbf{x}_1, \ldots, \mathbf{x}_n$ are $k$-wise independent random variables taking values in $[0,1]$, where $k \ge 4$.[13] Let $\mu = \mathbb{E}[\sum_i \mathbf{x}_i]$, and let $\Delta$ satisfy $\Delta \ge \mu/2$ and $\Delta \ge 300k$. Then*

$$\Pr\left[ \left| \mu - \sum_i \mathbf{x}_i \right| \ge \Delta \right] \le 2^{-k}.$$

## 4.2 Restrictions

Given a function $f \colon \{0,1\}^n \to \{0,1\}$, a restriction of $f$ is a subset $W \subseteq \{0,1\}^n$. We will be interested in restrictions that are subcubes, and such restrictions can be described by a string $\rho \in \{0,1,\star\}^n$, where the subcube consists of all $x \in \{0,1\}^n$ such that for every $i \in [n]$ for which $\rho_i \ne \star$ it holds that $x_i = \rho_i$. The living variables under $\rho$ are the input bits indexed by

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[13]For convenience, we allow non-integer values of $k$. The meaning is that any set of at most $k$ of the variables $\mathbf{x}_1, \ldots, \mathbf{x}_n$ are independent. Bellare and Rompel's lemma [BR94] assumes $k$ is an even integer, but we chose the constant 300 to be large enough that our formulation follows from Bellare and Rompel's lemma by considering $\lfloor k \rfloor$ and $\lfloor k \rfloor - 1$.

the set $\{i \in [n] : \rho_i = \star\}$. We will sometimes describe a restriction by a pair $\rho = (I, z)$, where $I \subseteq [n]$ and $z \in \{0,1\}^{[n]\setminus I}$ or $z \in \{0,1\}^n$, with the interpretation being

$$\rho_i = \begin{cases} \star & \text{if } i \in I \\ z_i & \text{if } i \in [n] \setminus I. \end{cases}$$

The function $f$ restricted to a subcube $\rho$ is denoted by $f\restriction_\rho\colon \{0,1\}^n \to \{0,1\}$ such that $f\restriction_\rho(x) = f(y)$, where for every $i \in [n]$ it holds that $y_i = x_i$ if $\rho_i = \star$ and $y_i = \rho_i$ otherwise. We will also consider the composition of restrictions to subcubes, where a composition $\rho = \rho_1 \circ \rho_2$ yields the restricted function $f\restriction_\rho = \left(f\restriction_{\rho_2}\right)\restriction_{\rho_1}$. Specifically, if $\rho_1 \in \{0,1,\star\}^{\rho_2^{-1}(\star)}$ or $\rho_1 \in \{0,1,\star\}^n$, then

$$(\rho_1 \circ \rho_2)_i = \begin{cases} (\rho_2)_i & \text{if } (\rho_2)_i \neq \star \\ (\rho_1)_i & \text{if } (\rho_2)_i = \star. \end{cases} \tag{1}$$

As a special case, if $x \in \{0,1\}^{\rho^{-1}(\star)}$, then $x \circ \rho$ is the string in $\{0,1\}^n$ obtained by using $x$ to fill in the $\star$ positions of $\rho$.

**Definition 4.6.** *A $p$-regular restriction is a random variable $\rho \in \{0,1,\star\}^n$ such that for each $i$, $\Pr[\rho_i = \star] = p$ and $\Pr[\rho_i = 0] = \Pr[\rho_i = 1] = (1-p)/2$. If additionally the coordinates $\rho_1,\dots,\rho_n$ are independent, we say that the restriction is* truly random. *If $\rho_1,\dots,\rho_n$ are $k$-wise independent, we say the restriction is* $k$-wise independent.

**Definition 4.7.** *Let $A \subseteq [n]$. A $p$-regular* subset *of $A$ is a random variable $\mathbf{I} \subseteq A$ such that for each $i \in A$,*

$$\Pr[i \in \mathbf{I}] = p.$$

*We say the subset is* $k$-wise independent *if the events $i \in \mathbf{I}$ are $k$-wise independent.*

**Claim 4.8.** *Let $k, n \in \mathbb{N}$ with $k \leq n$, let $p \in (0,1)$ be a power of two, and let $A$ be a subset of $[n]$. Given $n$, $k$, $p$, and $A$, a $p$-regular subset of $A$ and a $p$-regular $k$-wise independent restriction can each be sampled in time $\mathrm{poly}(n, \log(1/p))$ using $O(k \cdot \log(n/p))$ truly random bits.*

**Proof.** Sample a $k$-wise independent sequence $\mathbf{y} \in [q]^n$, where $q = 2/p$; this can be done in $\mathrm{poly}(n, \log q)$ time using $O(k\log(n/p))$ truly random bits [Vad12, Corollary 3.34]. Our $p$-regular $k$-wise independent restriction $\rho$ is given by

$$\rho_i = \begin{cases} 0 & \text{if } \mathbf{y}_i \in \{1, 2, \dots, q/2 - 1\} \\ 1 & \text{if } \mathbf{y}_i \in \{q/2, q/2 + 1, \dots, q - 2\} \\ \star & \text{if } \mathbf{y}_i \in \{q - 1, q\}. \end{cases}$$

Our $p$-regular $k$-wise independent subset $\mathbf{I} \subseteq A$ is given by

$$\mathbf{I} = \rho^{-1}(\star) \cap A. \qquad \blacksquare$$

## 4.3 Threshold functions

For two vectors $w, x \in \mathbb{R}^n$, we denote by $\langle w, x \rangle = \sum_{i \in [n]} w_i \cdot x_i$ the standard inner-product over the reals. For $h < n$, we denote $w_{>h} = (w_{h+1}, \dots, w_n) \in \mathbb{R}^{n-h}$.

A linear threshold function (LTF) $\Phi\colon \{0,1\}^n \to \{0,1\}$ is a function of the form $\Phi(x) = 1 \iff \langle x, w \rangle > \theta$, where $w \in \mathbb{R}^n$ is a vector of real "weights", and (the "threshold") $\theta \in \mathbb{R}$ is a real number; we denote $\Phi = (w, \theta)$. The following are standard definitions (see, e.g., [Ser07; DGJSV10]) that refer to structural properties of LTFs.

**Definition 4.9** (regularity). *For $\mu > 0$, we say that a vector $w \in \mathbb{R}^n$ is $\mu$-regular if for every $i \in [n]$ it holds that $|w_i| \leq \mu \cdot \|w\|_2$. An LTF $\Phi = (w, \theta)$ is $\mu$-regular if $w$ is $\mu$-regular.*

**Definition 4.10** (critical index). *When $w \in \mathbb{R}^n$ satisfies $|w_1| \geq |w_2| \geq \cdots \geq |w_n|$, the $\mu$-critical index of $w$ is defined as the smallest $h \in [n]$ such that $w_{>h}$ is $\mu$-regular (and $h = \infty$ if no such $h \in [n]$ exists). The critical index of an LTF $\Phi = (w, \theta)$ is the critical index of $w'$, where $w' \in \mathbb{R}^n$ is the vector that is obtained from $w$ by permuting the coordinates in order to have $|w_1'| \geq \cdots \geq |w_n'|$.*

### 4.4 PRGs yield hard functions

The following proposition (which is a minor modification of [Vio09, Prop. 5]) spells out the standard transformation of PRGs to hard functions:

**Proposition 4.11** (from PRG to average case hard function). *Suppose that $G: \{0,1\}^{\ell} \to \{0,1\}^n$ is $\epsilon$-pseudorandom for a class $\mathcal{F}$ of functions $f: \{0,1\}^n \to \{0,1\}$ that is closed under permuting the input variables. For $\ell' = \ell + \lceil \log(1/\epsilon) \rceil$, define $h: \{0,1\}^{\ell'} \to \{0,1\}$ by $h(x) = 1$ iff there exists $y$ such that $x$ is a prefix of $G(y)$. Let $\mathbf{d} \in \{0,1\}^{\ell'}$ be a random variable which with probability $1/2$ is equal to $\mathbf{u}_{\ell'}$ and with probability $1/2$ is equal to $G(\mathbf{u}_{\ell})_{[\ell']}$. Then $h$ is $(1/2 + \epsilon)$-average-case hard for $\mathcal{F}$ with respect to $\mathbf{d}$, that is, for every $f \in \mathcal{F}$ that is sensitive to at most $\ell'$ input variables,*[14]

$$\Pr[f(\mathbf{d}) = h(\mathbf{d})] \leq \frac{1}{2} + \epsilon. \tag{2}$$

**Proof.** We will prove that under the distribution $\mathbf{d}$, every $f \in \mathcal{F}$ has correlation at most $2\epsilon$ with $h$. This translates to $(1/2 + \epsilon)$-average-case hardness of $h$. We have[15]

$$\left| \mathbb{E}\left[ (-1)^{f(\mathbf{d}) + h(\mathbf{d})} \right] \right| = \left| \frac{1}{2} \cdot \mathbb{E}\left[ (-1)^{f(\mathbf{u}_n) + h(\mathbf{u}_{\ell'})} \right] + \frac{1}{2} \cdot \mathbb{E}\left[ (-1)^{f(G(\mathbf{u}_{\ell})) + h(G(\mathbf{u}_{\ell})_{[\ell']})} \right] \right|$$

$$= \left| \frac{1}{2} \cdot \mathbb{E}\left[ (-1)^{f(\mathbf{u}_n) + h(\mathbf{u}_{\ell'})} \right] - \frac{1}{2} \cdot \mathbb{E}\left[ (-1)^{f(G(\mathbf{u}_{\ell}))} \right] \right|$$

$$\leq \left| \frac{1}{2} \cdot \mathbb{E}\left[ (-1)^{f(\mathbf{u}_n)} \right] - \frac{1}{2} \cdot \mathbb{E}\left[ (-1)^{f(G(\mathbf{u}_{\ell}))} \right] \right| + 2^{-(\ell' - \ell)}$$

$$\leq 2\epsilon, \qquad\qquad\qquad\qquad\qquad \text{(Since } G \text{ fools } f)$$

where the first inequality follows from

$$\left| \mathbb{E}\left[ (-1)^{f(\mathbf{u}_n) + h(\mathbf{u}_{\ell'})} \right] - \mathbb{E}\left[ (-1)^{f(\mathbf{u}_n)} \right] \right| \leq 2\Pr[h(\mathbf{u}_{\ell'}) = 1] = 2^{1-(\ell'-\ell)}. \quad \blacksquare$$

## 5 An improved low-error PRG for De Morgan formulas

Recall that Impagliazzo, Meka, and Zuckerman [IMZ12] designed a PRG for size-$s$ De Morgan formulas ($s \geq n$) with seed length $s^{1/3+o(1)}$ and error $1/\text{poly}(s)$. In this section, we describe a PRG with much lower error. In particular, we fool size-$s$ De Morgan formulas with seed length $s^{1/3+o(1)} \cdot \text{polylog}(n/\epsilon)$.

**Theorem 5.1** (Low-error PRG for De Morgan formulas; Theorem 1.3, restated). *For any $n, s \in \mathbb{N}$ and any $\epsilon > 0$, there is an $\epsilon$-PRG for size-$s$ De Morgan formulas with output length $n$ that is computable in time $\text{poly}(n)$ with seed length*

$$\left( s^{1/3} \cdot \log^{2/3}(1/\epsilon) + \log^2(1/\epsilon) \right) \cdot 2^{O(\sqrt{\log s})} \cdot \text{polylog}(n).$$

---

[14]Technically, the domain of $f$ is $\{0,1\}^n$, whereas $\mathbf{d} \in \{0,1\}^{\ell'}$; the expression $f(\mathbf{d})$ should be interpreted as the output of $f$ when the bits of $\mathbf{d}$ are placed at input locations to which $f$ is sensitive.

[15]Since $\mathcal{F}$ is closed under permuting the input variables, we may assume without loss of generality that the variables to which $f$ is sensitive come before the variables that $f$ ignores, hence $f(\mathbf{d})$ is $f(G(\mathbf{u}_{\ell}))$ with probability $1/2$ and $f(\mathbf{u}_n)$ otherwise.

## 5.1 Shrinkage in expectation under truly random restrictions

Like the original PRG by Impagliazzo, Meka, and Zuckerman [IMZ12], the proof of Theorem 5.1 relies on the phenomenon that De Morgan formulas *shrink* under a random restriction. Let $L(f)$ denote the size of the smallest De Morgan formula computing $f$ (L for *leaf complexity*). Improving on work by Håstad [Hås98], Tal showed that formulas shrink in expectation under a truly random restriction.

**Theorem 5.2** ([Tal14]). *Let $f$ be a De Morgan formula of size $s$, and let $\rho$ be a truly random $p$-regular restriction. Then $\mathbb{E}[L(f{\restriction}_\rho)] \le O(p^2 s + p\sqrt{s}) \le O(p^2 s + 1)$.*

## 5.2 High-probability shrinkage of bounded-read De Morgan formulas

For our PRG, we would like to show some form of simplification *with high probability* under a *pseudorandom* restriction. Let us begin with the special case of read-$t$ De Morgan formulas for small $t$, i.e., formulas where each variable appears in at most $t$ leaves. Impagliazzo, Meka, and Zuckerman showed [IMZ12, Lemma 4.7] that indeed, under a pseudorandom restriction, such formulas shrink with high probability (see also [KRT17, Lemma 4.4]). Their bound is sufficient for our application (Theorem 5.1), but we take this opportunity to re-prove the result with improved parameters. We begin by recalling a structural lemma for De Morgan formulas that Tal proved [Tal14] building on the work by Impagliazzo, Meka, and Zuckerman [IMZ12].

**Lemma 5.3** ([Tal14]). *Let $f$ be a De Morgan formula of size $s \ge \ell$. There exist a read-once De Morgan formula $F$ and De Morgan formulas $g_1, \dots, g_m$ of size at most $\ell$, with $m = O(s/\ell)$, such that for all $x$,*

$$f(x) = F(g_1(x), \dots, g_m(x)).$$

*Furthermore, if a variable $x_i$ appears $t$ times in $f$, then it appears at most $2t$ times in total among $g_1, \dots, g_m$.*

(The "furthermore" clause was not explicitly stated in Tal's work [Tal14], but it follows from an inspection of the construction.)

**Lemma 5.4** (High-probability shrinkage of bounded-read De Morgan formulas). *Let $p, \epsilon \in (0,1)$. Let $f$ be a read-$t$ De Morgan formula of size $s$, where $p^2 s \ge 1$. Let $\rho \in \{0, 1, \star\}^n$ be a $k$-wise independent $p$-regular restriction, where $k = p^{-2} \log(s/\epsilon)$. Then*

$$\Pr[L(f{\restriction}_\rho) \le O(p^2 s + t \cdot p^{-4} \cdot \log(s/\epsilon))] \ge 1 - \epsilon.$$

**Proof.** Let $f(x) = F(g_1(x), \dots, g_m(x))$ be the decomposition from Lemma 5.3 with $m \le O(p^2 s)$ and $L(g_i) \le \ell = p^{-2}$. Since $k \ge \ell$, Theorem 5.2 implies that $\mathbb{E}[L(g_i{\restriction}_\rho)] \le s_0$ for some $s_0 = O(1)$. Now form a graph with vertices $g_1, \dots, g_m$, where $g_i$ is adjacent to $g_j$ if there is some variable that is read by both $g_i$ and $g_j$. Since $f$ is read-$t$, each variable appears at most $2t$ times in total among $g_1, \dots, g_m$, so the graph has maximum degree less than $2t\ell$. Therefore, there is a proper $(2t\ell)$-coloring of the graph.

Consider a single color class $S \subseteq [m]$ under such a coloring. Since $S$ forms an independent set, the formulas $g_i$ for $i \in S$ read disjoint sets of variables, and each $g_i$ has at most $\ell$ leaves. Therefore, if we let $\mathbf{y}_i = L(g_i{\restriction}_\rho)/\ell \in [0,1]$, then $\mathbf{y}_i$ for $i \in S$ are $k'$-wise independent for $k' = k/\ell = \log(s/\epsilon)$. By Theorem 4.5 with $\Delta = |S|s_0/\ell + 300 \log(s/\epsilon)$, we have

$$\Pr\left[\sum_{i \in S} L(g_i{\restriction}_\rho) > 2|S|s_0 + 300\ell \log(s/\epsilon)\right] \le \frac{\epsilon}{s}.$$

The number of colors is $2t\ell$ (which is at most $s$), so by the union bound,

$$\Pr\left[\sum_{i=1}^m L(g_i{\restriction}_\rho) > 2ms_0 + 600t\ell^2 \log(s/\epsilon)\right] \le \frac{\epsilon}{s} \cdot 2t\ell \le \epsilon.$$

Assuming that event does not occur,

$$\mathsf{L}(f\!\restriction_{\boldsymbol{\rho}}) \le 2ms_0 + 600t\ell^2 \log(s/\epsilon) = O(p^2 s + t\ell^2 \log(s/\epsilon)). \quad \blacksquare$$

## 5.3 High-probability simplification of unbounded-read formulas

Let us turn to the general case of unbounded-read De Morgan formulas. Impagliazzo, Meka, and Zuckerman [IMZ12, Lemma 4.8] showed that with probability $1 - \epsilon$ under a pseudorandom restriction, a size-$s$ De Morgan formula shrinks to size

$$p^2 s \cdot \exp\left(O\left(\frac{\log(1/\epsilon)}{\log^{1/3} s}\right)\right).$$

This is meaningful in the moderate-error regime that they focused on (e.g., $\epsilon = 1/\text{poly}(s)$), but the bound becomes trivial for smaller $\epsilon$ such as $\epsilon = 1/\text{quasipoly}(s)$. Recall that we are aiming to design a PRG for errors as small as $2^{-s^{\Omega(1)}}$.

Unfortunately, as discussed in Section 2.1, the poor dependence on $\epsilon$ in Impagliazzo, Meka, and Zuckerman's result [IMZ12] is not an artifact of their analysis. Even under a *truly* random restriction, De Morgan formulas genuinely *do not shrink* with sufficiently high probability. To evade this obstacle, we are forced to consider a relaxed notion of "simplification." In particular, we study a hybrid decision tree model, defined next.

**Definition 5.5.** *A $(D, s)$-DMF-DT is a partial decision tree $T$ of depth $D$ where each internal node is labeled with a variable $x_i$ and each leaf is labeled with either a size-$s$ De Morgan formula or else $\bot$. The tree computes a function $T\colon \{0,1\}^n \to \{0, 1, \bot\}$ in the natural way: follow the path in the partial decision tree until reaching a leaf defined by the input $x$. If the leaf is marked with $\bot$, output $\bot$, and otherwise output the value of the relevant formula evaluated on $x$. We define*

$$\mathsf{Err}(T) = \Pr[T(\mathbf{u}_n) = \bot].$$

Loosely speaking, we will now show that with probability $1 - \epsilon$ under a pseudorandom restriction with $\star$-probability $p$, a size-$s$ De Morgan formula simplifies to a DMF-DT, where the formulas at the leaves have size only $O(p^2 s)$ and the depth $D$ of the tree (i.e., the maximum number of queries) is $O(p^{-6} \log(s/\epsilon))$. Intuitively, the hybrid decision tree model is helpful because we can query all the "heavy" variables, leaving us with a bounded-read formula.

In fact, since we will need to apply this lemma iteratively to further simplify the simpler function, we will prove more generally that DMF-DTs with size-$s$ formulas at the leaves simplify to DMF-DTs with size-$O(p^2 s)$-formulas at the leaves. Another technicality is that we merely achieve failure probability $\epsilon$ with respect to the pseudorandom choice of restriction *and* a truly random input to the restricted function. The precise statement follows.

**Lemma 5.6** (High-probability simplification of DMF-DTs). *Let $T$ be a $(D, s)$-DMF-DT and let $p, \epsilon \in (0, 1)$ with $p^2 s \ge 1$. For each restriction $\rho \in \{0, 1, \star\}^n$, there is a $(D', s')$-DMF-DT $T_\rho$ such that for all $x$, $T_\rho(x) \in \{(T\!\restriction_\rho)(x), \bot\}$, and*

$$s' \le O(p^2 s) \qquad\qquad D' \le D + O(p^{-6} \log(s/\epsilon)).$$

*Furthermore, suppose $\rho$ is sampled from a $k$-wise independent $p$-regular distribution, where $k \ge D + cp^{-6} \log(s/\epsilon)$ for a suitable constant $c$. Then*

$$\mathbb{E}_{\boldsymbol{\rho}}[\mathsf{Err}(T_{\boldsymbol{\rho}})] \le \mathsf{Err}(T) + \epsilon.$$

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**Proof.** Let $x \in \{0,1\}^n$ be an input to $T_\rho$, and let $y = x \circ \rho$. The tree $T_\rho$ begins by simulating the decision tree portion of $T(y)$, arriving at some leaf $\ell$. If $\ell$ is labeled $\perp$, then the corresponding node of $T_\rho$ is also a leaf labeled $\perp$. Otherwise, $\ell$ is labeled with a size-$s$ De Morgan formula $f$. Let $t = \frac{p^6 \cdot s}{\log(s/\epsilon)}$. The tree $T_\rho$ obtains the values of all variables $y_i$ that appear more than $t$ times in $f$ (by querying $x_i$ if $\rho_i = \star$), arriving at a leaf of $T_\rho$. Let $\tau$ denote the restriction describing these values of $y$, so $\tau_i \in \{y_i, \star\}$ and $f\restriction_\tau$ is a size-$s$ read-$t$ De Morgan formula. For these values of $s$, $t$, and $\epsilon$, the bound in the conclusion of Lemma 5.4 is $Cp^2 s$ for some constant $C$. If $L((f\restriction_\tau)\restriction_\rho) > Cp^2 s$, then the leaf of $T_\rho$ is labeled $\perp$; otherwise, it is labeled with $(f\restriction_\tau)\restriction_\rho$.

By construction, $T_\rho(x) \in \{T(y), \perp\} = \{(T\restriction_\rho)(x), \perp\}$ and we can take $s' = Cp^2 s$. The number of variables that appear in $f$ more than $t$ times is at most $s/t$, so we can take $D' = D + s/t = D + O(p^{-6}\log(s/\epsilon))$. Finally, let us bound $\mathbb{E}[\mathsf{Err}(T_\rho)] = \Pr_{\rho, x}[T_\rho(x) = \perp]$. We can determine which leaf of $T$ is reached by $T_\rho(x)$ by observing at most $D$ coordinates of $\rho$ and $x$. The tree $T_\rho$ will output $\perp$ if the leaf is labeled $\perp$ or if it is labeled $f$ and $f\restriction_\tau$ fails to shrink. Since $k \geq D$, the probability that the leaf is labeled $\perp$ is precisely $\mathsf{Err}(T)$. Otherwise, we can determine the formula $f\restriction_\tau$ by observing at most $s/t$ additional coordinates of $\rho$ and $x$. Conditioned on any values for those $D + s/t$ coordinates, the remaining coordinates of $\rho$ are still $k'$-wise independent where $k' = k - (D + s/t) \geq p^{-2}\log(s/\epsilon)$. By Lemma 5.4, with respect to those remaining coordinates, the probability that $f\restriction_\tau$ fails to shrink is at most $\epsilon$. Therefore, $\mathbb{E}[\mathsf{Err}(T_\rho)] \leq \mathsf{Err}(T) + \epsilon$. ∎

Ultimately we would like to use a restriction with $p \approx s^{-1/3}$, but with such a small $p$, the depth $D'$ in Lemma 5.6 becomes completely trivial, and besides, the seed length of the $k$-wise independent restriction in Lemma 5.6 becomes too large. Following Impagliazzo, Meka, and Zuckerman [IMZ12], we circumvent this issue by composing several pseudorandom restrictions with a much larger value of $p$. Since we will not need to apply this next theorem iteratively, we assume for simplicity that we start with a De Morgan formula rather than a `DMF-DT`.

**Theorem 5.7** (High-probability simplification of De Morgan formulas for small $p$). *Let $n, s \in \mathbb{N}$, and let $p \in (0, 1/2)$ and $\epsilon > 0$. Let $\alpha = 1/\sqrt{\log s} = o(1)$. Then, there is a distribution over $\rho \in \{0, 1, \star\}^n$ that can be sampled in $\mathrm{poly}(n, s, \log(1/p))$ time using $O(s^\alpha \cdot \log^2(1/p) \cdot \log(1/\epsilon) \cdot \log n)$ truly random bits with the following properties.*

1. *$\rho$ is $p'$-regular and $k$-wise independent where $p' \geq p$ and $k = s^\alpha \cdot \log(1/p) \cdot \log(1/\epsilon)$.*

2. *For any size-$s$ De Morgan formula $f$, there is a $(D, s')$-`DMF-DT` $\mathbf{T}$ (jointly distributed with $\rho$) such that*

$$\forall x, \Pr[\mathbf{T}(x) \in \{f\restriction_\rho(x), \perp\}] = 1 \qquad s' \leq p^{2 - O(\alpha)} \cdot s$$
$$\mathbb{E}[\mathsf{Err}(\mathbf{T})] \leq \epsilon \qquad D \leq s^\alpha \cdot \log(1/p) \cdot \log(1/\epsilon).$$

**Proof.** If $p < 2^{-s}$, the statement is trivial because the tree can simply query every variable that $f$ reads, so assume $p \geq 2^{-s}$. Let $q$ be the smallest power of two that is at least $s^{-\alpha/7}$, so $q = 2^{-\Theta(\sqrt{\log s})}$. Let $r = \lfloor \frac{\log(1/p)}{\log(1/q)} \rfloor$, so $q^r \in [p, p/q)$.

Sample $r$ independent and identically distributed restrictions $\rho_1, \ldots, \rho_r \in \{0, 1, \star\}^n$, where $\rho_i$ is $q$-regular and $k$-wise independent for a value of $k$ to be specified later. Set $\rho = \rho_r \circ \cdots \circ \rho_1$, so indeed, $\rho$ is $p'$-regular where $p' = q^r \geq p$. To define $\mathbf{T}$, think of $f$ as a $(0, s)$-`DMF-DT`, and using the notation of Lemma 5.6, define

$$\mathbf{T} = (\cdots ((f_{\rho_1})_{\rho_2})_{\rho_3} \cdots)_{\rho_r}.$$

In each iteration, we use failure probability $\epsilon/r$.

Clearly, $\mathbf{T}(x) \in \{f\lceil_\rho(x), \bot\}$ and $\mathbb{E}[\text{Err}(\mathbf{T})] \leq \epsilon$. Furthermore, $\mathbf{T}$ is a $(D, s')$-DMF-DT, where

$$
\begin{aligned}
D &\leq O(rq^{-6} \log(rs/\epsilon)) \\
&\leq O(s^{6\alpha/7} \log(1/\epsilon) \log(1/p) \sqrt{\log s}) \\
&\leq O(s^\alpha \log(1/\epsilon) \log(1/p))
\end{aligned}
$$

and

$$
s' \leq O(q^2)^r \cdot s \leq 2^{O(r)} q^{2r} \cdot s \leq 2^{O(r)} \cdot p^2 \cdot q^{-2} \cdot s \leq p^{2-O(\frac{1}{\alpha \log s})} \cdot s = p^{2-O(\alpha)} \cdot s.
$$

For each individual restriction, it suffices to take $k = O(D)$. By Claim 4.8, each $\rho_i$ can be sampled using $O(k \log(n/q))$ truly random bits. Therefore, the total seed length is

$$
O(rk \log(n/q)) \leq O(s^\alpha \log(1/\epsilon) \log^2(1/p) \log n) . \quad \blacksquare
$$

## 5.4 The PRG construction

Now we are ready to construct the PRG of Theorem 5.1. We follow the framework of Impagliazzo, Meka, and Zuckerman [IMZ12]. Sample independent copies $\rho_1, \ldots, \rho_t$ of the restriction from Theorem 5.7, with

$$
p = s^{-1/3} \cdot \log^{1/3}(1/\epsilon), \tag{3}
$$

error parameter $\epsilon/t$, and $t = O(p^{-1} \log n + \log(1/\epsilon))$. Let $s'$ and $D$ be the values from Theorem 5.7, and let $G: \{0,1\}^d \to \{0,1\}^n$ be a $(D + s')$-wise independent generator. Sample a $(2400p^{-1})$-wise independent string $\mathbf{w}$. Let $\text{Ext}: \{0,1\}^m \times \{0,1\}^{d_{\text{Ext}}} \to \{0,1\}^d$ be a $(k_{\text{Ext}}, \epsilon_{\text{Ext}})$-extractor, where $k_{\text{Ext}}, \epsilon_{\text{Ext}}$ and $m$ will be specified later. Sample independent uniform random strings $\mathbf{a} \in \{0,1\}^m$ and $\mathbf{y}_1, \ldots, \mathbf{y}_t \in \{0,1\}^{d_{\text{Ext}}}$. Let $\mathbf{z}_i = \text{Ext}(\mathbf{a}, \mathbf{y}_i)$. Our PRG outputs

$$
\mathbf{w} \oplus \bigoplus_{i=1}^{t} (G(\mathbf{z}_i) \circ \rho_i),
$$

i.e., we use $G(\mathbf{z}_i)$ to fill in the $\star$ coordinates of $\rho_i$ and then take the bitwise XOR of the resulting $t$ strings and $\mathbf{w}$.

The proof of correctness is a hybrid argument. Sample independent uniform strings $\mathbf{u}^{(1)}, \ldots, \mathbf{u}^{(t)}$, and define hybrid distributions $\mathbf{h}_0, \ldots, \mathbf{h}_t$ by

$$
\mathbf{h}_j = \mathbf{w} \oplus \left( \bigoplus_{i=1}^{j} (\mathbf{u}^{(i)} \circ \rho_i) \right) \oplus \left( \bigoplus_{i=j+1}^{t} G(\mathbf{z}_i) \circ \rho_i \right).
$$

**Claim 5.8.** *Let $f$ be a size-$s$ De Morgan formula, and let $j \in [t]$. Then*

$$
| \mathbb{E}[f(\mathbf{h}_{j-1})] - \mathbb{E}[f(\mathbf{h}_j)]| \leq \tfrac{\epsilon}{t} + 3 \cdot 2^D \cdot \epsilon_{\text{Ext}}.
$$

**Proof.** Define the random variable $\mathbf{e} = \mathbf{w} \oplus \left( \bigoplus_{i=1}^{j-1} (\mathbf{u}^{(i)} \circ \rho_i) \right) \oplus \left( \bigoplus_{i=j+1}^{t} G(\mathbf{z}_i) \circ \rho_i \right)$ which conveniently gives us

$$
\mathbf{h}_{j-1} = \mathbf{e} \oplus (G(\mathbf{z}_j) \circ \rho_j)
$$
$$
\mathbf{h}_j = \mathbf{e} \oplus (\mathbf{u}^{(j)} \circ \rho_j).
$$

Note that $\mathbf{e}$ and $\mathbf{a}$ are *not* independent, but $\mathbf{e}$ is nevertheless independent of $\rho_j$ and $\mathbf{y}_j$. Let $f^{\oplus \mathbf{e}}(x) = f(\mathbf{e} \oplus x)$, so $f^{\oplus \mathbf{e}}$ can be computed by a size-$s$ De Morgan formula. Let $\mathbf{T}$ be the DMF-DT from Theorem 5.7 associated with $\rho_j$ and $f^{\oplus \mathbf{e}}$, so $\mathbf{T}(x) \in \{(f^{\oplus \mathbf{e}})\lceil_{\rho_j}(x), \bot\}$. Define

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$\mathbf{r} \colon \{0,1\}^n \to [2^D]$ by letting $\mathbf{r}(x)$ be the index of the leaf reached by $\mathbf{T}(x)$. For each $\ell \in [2^D]$, define

$$\mathbf{g}_\ell^-(x) = 1 \iff (\mathbf{r}(x) = \ell) \wedge \mathbf{T}(x) = 1$$
$$\mathbf{g}_\ell^+(x) = 1 \iff (\mathbf{r}(x) = \ell) \wedge \mathbf{T}(x) \in \{1, \bot\}.$$

Now, $\mathbf{g}_\ell^+$ (as a function) is a random variable, since $\mathbf{g}_\ell^+$ depends on $\mathbf{e}$ and $\boldsymbol{\rho}_j$. Let us bound the support size of that random variable. For each fixed $\ell$, to describe the function $\mathbf{g}_\ell^+$, we could specify the sequence of variables and values on the path from the root to leaf $\ell$ of $\mathbf{T}$, and then we could specify the label of that leaf (either $\bot$ or a size-$s'$ De Morgan formula). In total, that requires at most $O(D \log n + s' \log n) = O(s' \log n)$ bits.[16]

Intuitively, this means that $\mathbf{a}$ has a lot of entropy even given $\mathbf{g}_\ell^+$. By the extractor guarantee, this should imply that $\mathbf{z}_j = \mathsf{Ext}(\mathbf{a}, \mathbf{y}_i)$ is near uniform even given $\mathbf{g}_\ell^+$, and hence $\mathbf{g}_\ell^+(G(\mathbf{z}_j)) \approx \mathbf{g}_\ell^+(G(\mathbf{u}_d))$.

The cleanest way to make this sort of argument rigorous is to use the notion of *conditional min-entropy* [DORS08]. Recall that for two random variables such as $\mathbf{a}$ and $\mathbf{g}_\ell^+$, the min-entropy of $\mathbf{a}$ given $\mathbf{g}_\ell^+$ is defined as

$$\widetilde{H}_\infty(\mathbf{a} \mid \mathbf{g}_\ell^+) = \log \left( \frac{1}{\mathbb{E}_{g \sim \mathbf{g}_\ell^+}[\max_a \Pr[\mathbf{a} = a \mid \mathbf{g}_\ell^+ = g]]} \right).$$

Conditional min-entropy satisfies a *chain rule* [DORS08, Lemma 2.2], giving

$$\widetilde{H}_\infty(\mathbf{a} \mid \mathbf{g}_\ell^+) \geq H_\infty(\mathbf{a}) - \log(\mathrm{supp}(\mathbf{g}_\ell^+)) \geq m - O(s' \log n).$$

Furthermore, extractors can extract randomness from sources with high conditional min-entropy. In particular, if we set $k_{\mathsf{Ext}}$ to be that same quantity $m - O(s' \log n)$, then [Vad12, Problem 6.8]

$$(\mathbf{g}_\ell^+, \mathbf{z}_j) \sim_{3\epsilon_{\mathsf{Ext}}} (\mathbf{g}_\ell^+, \mathbf{u}),$$

where $\mathbf{u}$ is a uniform random $d$-bit string independent of $\mathbf{g}_\ell^+$ and $\sim_\gamma$ denotes $\gamma$-closeness in total variation distance. Deterministic processing can only decrease total variation distance, so

$$\left| \mathbb{E}[\mathbf{g}_\ell^+(G(\mathbf{z}_j))] - \mathbb{E}[\mathbf{g}_\ell^+(G(\mathbf{u}))] \right| \leq 3\epsilon_{\mathsf{Ext}}.$$

Furthermore, $\mathbf{g}_\ell^+$ only reads $D + s'$ variables, so $G$ perfectly fools $\mathbf{g}_\ell^+$. Therefore,

$$\left| \mathbb{E}[\mathbf{g}_\ell^+(G(\mathbf{z}_j))] - \mathbb{E}[\mathbf{g}_\ell^+(\mathbf{u}^{(j)})] \right| \leq 3\epsilon_{\mathsf{Ext}}.$$

The same argument applies just as well to $\mathbf{g}_\ell^-$, showing that

$$\left| \mathbb{E}[\mathbf{g}_\ell^-(G(\mathbf{z}_j))] - \mathbb{E}[\mathbf{g}_\ell^-(\mathbf{u}^{(j)})] \right| \leq 3\epsilon_{\mathsf{Ext}}.$$

Altogether, we have

$$\mathbb{E}[f^{\oplus \mathbf{e}}(G(\mathbf{z}_j) \circ \boldsymbol{\rho}_j)] \leq \sum_{\ell=1}^{2^D} \mathbb{E}[\mathbf{g}_\ell^+(G(\mathbf{z}_j))]$$

$$\leq \mathbb{E}\left[ \sum_{\ell=1}^{2^D} \mathbf{g}_\ell^+(\mathbf{u}^{(j)}) \right] + 2^D \cdot 3\epsilon_{\mathsf{Ext}}$$

$$= \mathbb{E}\left[ \sum_{\ell=1}^{2^D} \mathbf{g}_\ell^-(\mathbf{u}^{(j)}) \right] + \mathbb{E}[\mathsf{Err}(\mathbf{T})] + 2^D \cdot 3\epsilon_{\mathsf{Ext}}$$

$$\leq \mathbb{E}[f^{\oplus \mathbf{e}}(\mathbf{u}^{(j)} \circ \boldsymbol{\rho}_j)] + \frac{\epsilon}{t} + 2^D \cdot 3\epsilon_{\mathsf{Ext}}.$$

---

[16]We may assume without loss of generality that $s \leq n^3$, since otherwise the theorem is trivial.

A symmetric argument proves a bound in the other direction. Since $f^{\oplus \mathbf{e}}(G(\mathbf{z}_j) \circ \boldsymbol{\rho}_j) = f(\mathbf{h}_{j-1})$ and $f^{\oplus \mathbf{e}}(\mathbf{u}^{(j)} \circ \boldsymbol{\rho}_j) = f(\mathbf{h}_j)$, this completes the proof. ∎

Claim 5.8 showed that the hybrid distributions are indistinguishable by $f$. Clearly, $\mathbf{h}_0$ is our pseudorandom distribution. Next, we show that $\mathbf{h}_t$ is statistically close to $\mathbf{u}_n$.

**Claim 5.9.** $\mathbf{h}_t \sim_\epsilon \mathbf{u}_n$.

**Proof.** Suppose we have already sampled $\boldsymbol{\rho}_1, \ldots, \boldsymbol{\rho}_{j-1}$. Let $\mathbf{I}$ be the set of coordinates in $[n]$ that are not yet covered by a $\star$, i.e.,

$$\mathbf{I} = [n] \setminus \left( \bigcup_{i=1}^{j-1} \boldsymbol{\rho}_i^{-1}(\star) \right).$$

Let us say that $\boldsymbol{\rho}_j$ is a *success* if either $|\mathbf{I}| \leq 2400p^{-1}$ or $|\boldsymbol{\rho}_j^{-1}(\star) \cap \mathbf{I}| \geq p|\mathbf{I}|/2$. Recall from Theorem 5.7 that $\boldsymbol{\rho}_j$ is 4-wise independent (indeed, $k$-wise independent for $k \gg 4$) and $p'$-regular for some $p' \geq p$. Therefore, by Theorem 4.5 with $\Delta = p'|I|/2$, conditioned on any values of $\boldsymbol{\rho}_1, \ldots, \boldsymbol{\rho}_{j-1}$, the probability that $\boldsymbol{\rho}_j$ is a success is at least $15/16$. This implies that with high probability, there will be at least $\Omega(t)$ successes. Indeed, by Azuma's inequality [DRV10, Lemma B.1], there will be at least $t/2$ successes, except with probability $e^{-\Omega(t)} \leq \epsilon$ (recalling that $t = O(p^{-1} \log n + \log(1/\epsilon))$).

Suppose now that there are at least $t/2$ successes. We start with $n$ coordinates not covered by $\star$, and whenever there is a success, either we are down to $2400p^{-1}$ coordinates not covered, or else the number of coordinates not covered decreases by a factor of $(1 - p/2)$. If the latter case happens every time, then every coordinate is covered, because $(1 - p/2)^{t/2} < 1$ (here we use $t \geq \Omega(p^{-1} \log n)$). Therefore, either way we must eventually cover all but $2400p^{-1}$ coordinates. In that case, with respect to the randomness of $\mathbf{w}$ and $\mathbf{u}^{(1)}, \ldots, \mathbf{u}^{(t)}$, $\mathbf{h}_t$ is clearly uniformly random. ∎

**Proof of Theorem 5.1.** By Claim 5.8 and the triangle inequality,

$$|\mathbb{E}[f(\mathbf{h}_0)] - \mathbb{E}[f(\mathbf{h}_t)]| \leq \epsilon + 2^D \cdot 3t\epsilon_{\mathsf{Ext}}.$$

By Claim 5.9, this implies that

$$|\mathbb{E}[f(\mathbf{h}_0)] - \mathbb{E}[f]| \leq 2\epsilon + 2^D \cdot 3t\epsilon_{\mathsf{Ext}}.$$

Recall that $\mathbf{h}_0$ is the output distribution of our PRG. We shall set $\epsilon_{\mathsf{Ext}} = \epsilon 2^{-D}/t$, so the total error is $O(\epsilon)$.

Finally, let us bound the seed length of our PRG. We have $\log(1/p) < \log n$ and $\log(1/\delta) = O(\log(n/\epsilon))$. Therefore, each $\boldsymbol{\rho}_i$ costs fewer than

$$s^\alpha \cdot \log(1/\epsilon) \cdot \mathrm{polylog}(n)$$

truly random bits, where $\alpha = 1/\sqrt{\log s} = o(1)$. Furthermore, using Eq. (3),

$$s' = p^{2-O(\alpha)}s = s^{1/3+O(\alpha)} \log^{2/3}(1/\epsilon).$$

Therefore, the generator $G$ has seed length

$$d = O((D + s') \log n) \leq s^\alpha \log(1/\epsilon) \cdot \mathrm{polylog}(n) + s^{1/3+O(\alpha)} \cdot \log^{2/3}(1/\epsilon).$$

We shall take Ext to be the Guruswami-Umans-Vadhan extractor [GUV09], so we can take $k_{\mathsf{Ext}} = O(d)$. As mentioned previously, we also need $k_{\mathsf{Ext}} = m - O(s' \log n)$, so we shall take

$m = O(d)$. Of course, to sample **a** we need $m$ truly random bits. The seed length $d_{\mathsf{Ext}}$ of this extractor is

$$O(\log(m/\epsilon_{\mathsf{Ext}})) = O(\log(m) + D + \log(t)) = s^\alpha \log(1/\epsilon) \cdot \mathrm{polylog}(n).$$

Finally, the $O(p^{-1})$-wise independent distribution **w** costs another $O(p^{-1} \log n)$ truly random bits. Summing up, the total seed length is

$$s^{1/3 + O(\alpha)} \cdot \log^{2/3}(1/\epsilon) + (p^{-1} + \log(1/\epsilon)) \cdot s^\alpha \cdot \log(1/\epsilon) \cdot \mathrm{polylog}(n),$$

which is bounded by

$$\left( s^{1/3} \cdot \log^{2/3}(1/\epsilon) + \log^2(1/\epsilon) \right) \cdot s^{O(\alpha)} \cdot \mathrm{polylog}(n) . \quad \blacksquare$$

# 6 A PRG for LTF circuits of super-linear size

In this section we prove Theorem 1.1. We first present, in Section 6.1, a pseudorandom restriction procedure that simplifies any LTF circuit into a suitable hybrid model, and fails with tiny probability. Then, in Section 6.2, we construct a low-error PRG for the latter hybrid model. And we combine these two parts into a PRG using the proof framework of Ajtai and Wigderson [AW85] in Section 6.3.

## 6.1 Low-error pseudorandom restrictions for LTF circuits

In this section we present our pseudorandom restriction procedure for LTF circuits. We begin, in Section 6.1.1, by defining the hybrid model to which any LTF circuit will be simplified with very high probability, which is a generalization of decision trees and that we call an LTF-DT. Then, in Section 6.1.2 we analyze the effect of a carefully-structured restriction on a *single* LTF function (i.e., a single gate in the circuit). In Section 6.1.3 we show how to simplify any LTF circuit to an LTF-DT whose leaves are labeled by LTF circuits of smaller depth, with very high probability. Anticipating iterative applications of this procedure, in Section 6.1.4 we show how to simplify an LTF-DT whose leaves are labeled by LTF circuits into another LTF-DT whose leaves are labeled by LTF circuits of smaller depth. Finally, in Section 6.1.5 we show how to iteratively apply the foregoing procedure in order to simplify an LTF circuit into an LTF-DT whose leaves are labeled by LTF functions (i.e., of LTF circuits of depth one).

Actually, as we will explain below, we show that each LTF circuit can be *approximated* by an LTF-DT, and additionally that the approximation error of the LTF-DT can be decided by a relatively-simple function (i.e., at each leaf of the LTF-DT the approximation error can be decided by the sum of polynomially-many LTFs). The fact that the approximation error can be decided in this way will be crucial to our PRG construction, as explained in Section 6.3.

### 6.1.1 The hybrid computational model

Let us now formally define LTF decision trees. We first present a simplified definition and then expand it to the full definition.

**Definition 6.1** (LTF decision tree, see Figure 1). *For $n \in \mathbb{N}$, we say that a binary tree $T$ is an $(n, M, D, d, w)$ LTF decision tree (or $(n, M, D, d, w)$-LTF-DT, in short) if:*

1. *Each internal node in $T$ is labeled either by a variable $x_i$ (for some $i \in [n]$) or by a linear threshold function $\{0,1\}^n \to \{0,1\}$.*

2. *Each leaf $\ell$ of $T$ is labeled by an LTF circuit $C_\ell$ over n variables of depth d and with at most w wires, and none of the variables queried on the path to $\ell$ appear as input variables in $C_\ell$.*
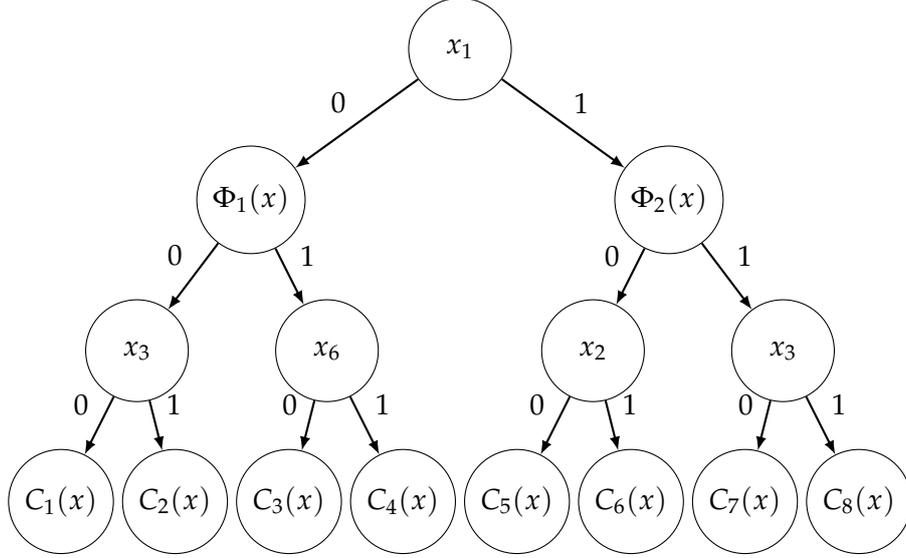
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Figure 1: An $(n, 1, 2, d, w)$-LTF-DT. Each $\Phi_i$ is an LTF, and each $C_i$ is an LTF circuit with depth $d$ and at most $w$ wires on variables $x_1, \ldots, x_n$. In the more refined hybrid model presented in Definition 6.2, each leaf $\ell$ is labeled not only with $C_i$ but also with a set $\mathcal{E}_\ell$ of LTFs (i.e., with error indicators).

3. *In the path to each leaf in the tree there are at most M nodes labeled with an LTF and at most D nodes labeled with a variable. (In particular, the depth of T is at most D + M.)*

An $(n, M, D, d, w)$-LTF-DT computes a function $T\colon \{0,1\}^n \to \{0,1\}$ in the natural way: Given input $x \in \{0,1\}^n$, we traverse from the root of $T$ along the path that corresponds to the evaluation of the function in each node (i.e., either an LTF or a variable) until we reach a leaf $\ell = \ell(x)$ that is labeled by an LTF circuit $C_\ell$, and we output $C_\ell(x)$.

As mentioned above, we will actually argue that each LTF circuit is *approximated* by an LTF-DT, and moreover that the approximation error can be tested (at each leaf of the LTF-DT) by a "simple function". This is formalized in the following definition:

**Definition 6.2** (LTF decision tree with error indicators)**.** *We define a $(n, M, D, d, w, e)$ LTF decision tree with error indicators (or $(n, M, D, d, w, e)$-LTF-DT, in short) to be an $(n, M, D, d, w)$-LTF-DT where each leaf $\ell$ of the tree is labeled with a set $\mathcal{E}_\ell$ of LTF functions with $|\mathcal{E}_\ell| \leq e$ (in addition to the LTF circuit $C_\ell$ that labels $\ell$ as before).*

The interpretation is, if some $\Phi \in \mathcal{E}_\ell$ outputs 1, that means something has gone wrong and the output of the tree is not reliable. An $(n, M, D, d, w, e)$-LTF-DT computes a function $T\colon \{0,1\}^n \to \{0,1\}$ as before: given input $x \in \{0,1\}^n$ we traverse the corresponding path in the tree until reaching a leaf $\ell = \ell(x)$, and then we output $C_\ell(x)$.

**Definition 6.3** (error functions of an LTF-DT)**.** *Given an LTF-DT $T\colon \{0,1\}^n \to \{0,1\}$, we define its error-indicator function by $\mathsf{Err}(T, x) = \sum_{\Phi \in \mathcal{E}_{\ell(x)}} \Phi(x)$. We define the error of T by $\mathsf{Err}(T) = \mathbb{E}_{x \sim \mathbf{u}_n}[\mathsf{Err}(T, x)]$.*

Recall that when $T$ was a DMF-DT, we defined $\mathsf{Err}(T)$ to be the *probability* of error on a random input. Now that $T$ is an LTF-DT, we have defined $\mathsf{Err}(T)$ to be the *expected number* of errors on a random input.

**Definition 6.4** (consistency of an LTF-DT with a function)**.** *Given a function $f\colon \{0,1\}^n \to \{0,1\}$ and an LTF-DT $T\colon \{0,1\}^n \to \{0,1\}$, we say that T is consistent with f if for every $x \in \{0,1\}^n$,*

$$T(x) \neq f(x) \implies \mathsf{Err}(T, x) \geq 1 .$$

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### 6.1.2 Simplification of a single `LTF` under a random restriction

To prove our result we will rely on a result asserting that any *single* `LTF` becomes close a constant, with decent probability, under a restriction that randomly assigns values to a fixed "good" set of variables. A similar result was proved by Chen, Santhanam, and Srinivasan [CSS16, Lem. 4.4], who analyzed the case of a truly random restriction, and a derandomized and refined version was proved in [Tel18, Prop. 3.8].

To get some intuition for the result, consider the illustrative example of the simple majority function on $n$ bits and of a random restriction. With extremely high probability, the $\ell_2$ norm of the living variables is $\approx \sqrt{p \cdot n}$; and by a suitable anti-concentration result (i.e., the Berry-Esséen Theorem), the probability that a random fixing of the rest of the variables has absolute value less than $t \cdot \sqrt{p \cdot n}$ is at most $O(t \cdot \sqrt{p})$. Thus, with probability at least $1 - O(t \cdot \sqrt{p})$ the restricted function has variables with $\ell_2$ norm $\approx \sqrt{p \cdot n}$ and "threshold" more than $t \cdot \sqrt{p}$, in which case it is $\exp(-t)$-close to a constant function (see [Tel18, Fact 5.3] for details).

Indeed, the result of [CSS16] asserts that the same phenomenon happens for *every* `LTF` rather than just for the majority function. We will need a variant of the derandomized version of [Tel18] for this result: For any `LTF`, we will condition on a corresponding "good" choice of variables to keep alive (where the meaning of "good" appears below), and assert that with decent probability under a uniform choice of values for fixed variables, the `LTF` becomes close to a constant.[17] (We will also parametrize the result more carefully than in [Tel18].)

The proof below of this result closely follows [CSS16; Tel18]. In high-level, following an idea of [Ser07], we partition the variables of the `LTF` into the "head" and the "tail," where the head consists of the variables with the largest weights in absolute value. (The precise partition to head and tail relies on the critical index of the `LTF`, as defined in Definition 4.10.) Intuitively, for any fixing of the head variables, the residual function on the tail variables behaves approximately like a majority function, whose behavior under a random restriction was analyzed above. In addition, the weights *inside the head* behave in a structured way (i.e., they essentially decrease exponentially), which makes them amenable to analysis. The proof thus proceeds by a case analysis, depending on the relative total weight of the head.

**Proposition 6.5** (random restriction lemma for a single `LTF` and a fixed set of living variables)**.**
*Let $n \in \mathbb{N}$, let $\mu, \mu', \epsilon > 0$ such that $\mu \leq \frac{1}{4\sqrt{2\log(2/\epsilon)}}$, and let $\lambda = \frac{10\log^2(1/\mu)}{\mu^2}$. Let $\Phi \colon \{0,1\}^n \to \{0,1\}$ be an `LTF` with $\mu$-critical index $h$, and assume that the weights vector $w \in \mathbb{R}^n$ of $\Phi = (w, \theta)$ satisfies $|w_1| \geq |w_2| \geq \ldots \geq |w_n|$. Let $I \subseteq [n]$ such that:*

1. *If $h > \lambda$ we require that $I \cap [\lambda] = \varnothing$.*

2. *If $h \leq \lambda$ we require that $I \cap [h] = \varnothing$ and $\|w_I\|_2 \leq \mu' \cdot \left\|w_{[n]\setminus[h]}\right\|_2$.*

*Then, the probability over a uniform choice of $\mathbf{z} \in \{0,1\}^{[n]\setminus I}$ that the restricted function $\Phi\!\restriction_{I,\mathbf{z}}$ is $\epsilon$-close to a constant is at least $1 - O(\mu + \mu' \cdot \sqrt{\log(1/\epsilon)})$.*

**Proof.** Let $J = [n] \setminus I$ be the set of variables fixed by $\mathbf{z}$, and let $T = [n] \setminus [\min\{h, \lambda\}]$ be the "tail" of variables following the "head" of the first $\min\{h, \lambda\}$ variables. For convenience, for each string $x \in \{0,1\}^*$, let $e[x] \in \{-1,1\}^{|x|}$ be the string $e[x]_i = (-1)^{x_i}$. Letting $w' = -\frac{1}{2}w$, there is some $\theta'$ such that
$$\Phi(x) = 1 \iff \langle w', e[x] \rangle > \theta'.$$

---

[17]The original statement in [Tel18] also referred to a pseudorandom choice of values for the fixed variables, but we only need a statement that refers to a pseudorandom choice of variables to fix and to a uniform choice of values for the fixed variables.

Note that the $\mu$-critical index of $w'$ is $h$ as well. We will prove that with probability at least $1 - O(\mu + \mu' \cdot \log(1/\epsilon))$ over choice of $\mathbf{z} \in \{0,1\}^J$,

$$\langle w'_J, e[\mathbf{z}] \rangle \notin \theta' \pm \sqrt{2\log(2/\epsilon)} \cdot \|w'_I\|_2 .$$

Using Hoeffding's inequality (Theorem 4.3), whenever this happens the restricted function $\Phi\!\restriction_{I,\mathbf{z}}$ is $\epsilon$-close to a constant. Our proof of this claim relies on a case analysis.

**The case of $h > \lambda$.** For this case we use the following claim (the original notation is modified to be consistent with our notation):

**Claim 6.5.1** (see [Tel18, Claim 5.7.1 in full version], following [CSS16] and [DGJSV10, Lemma 5.5]). *For any $r \in \mathbb{N}$, let $\lambda_{r,\mu} = \frac{4r \cdot \ln(3/\mu^2)}{\mu^2}$. Then, for any $J \supseteq [\lambda_{r,\mu}]$, the probability under uniform choice of $\mathbf{z} \in \{0,1\}^J$ that $\langle w'_J, e[\mathbf{z}] \rangle \in \theta' \pm \frac{1}{4\mu} \cdot \left\| w'_{> \lambda_{r,\mu}} \right\|_2$ is at most $2^{-r}$.*

We use the claim above with parameter $r = \log(1/\mu)$, relying on our hypothesis that $\lambda = 10 \cdot \frac{\log^2(1/\mu)}{\mu^2} > \lambda_{r,\mu}$, to deduce that $\Pr_{\mathbf{z}} \left[ \langle w'_J, e[\mathbf{z}] \rangle \notin \theta' \pm (1/4\mu) \cdot \left\| w'_{> \lambda_{r,\mu}} \right\|_2 \right] \geq 1 - \mu$. Now, observe that

$$\frac{1}{4\mu} \cdot \left\| w'_{> \lambda_{r,\mu}} \right\|_2 \geq \sqrt{2\log(2/\epsilon)} \cdot \left\| w'_{> \lambda_{r,\mu}} \right\|_2 \qquad (\mu \leq \tfrac{1}{4\sqrt{2\log(2/\epsilon)}})$$

$$> \sqrt{2\log(2/\epsilon)} \cdot \|w'_T\|_2 \qquad (\lambda > \lambda_{r,\mu})$$

$$\geq \sqrt{2\log(2/\epsilon)} \cdot \|w'_I\|_2 , \qquad (I \subseteq T)$$

and hence the probability over $\mathbf{z}$ that $\langle w'_J, e[\mathbf{z}] \rangle \notin \theta' \pm \sqrt{2\log(2/\epsilon)} \cdot \|w'_I\|_2$ is at least $1 - \mu$.

**The case of $h \leq \lambda$.** For this case, observe that for any fixed value for $\mathbf{z}_{[h]}$, the event $\langle w'_J, e[\mathbf{z}] \rangle \in \theta' \pm \sqrt{2\log(2/\epsilon)} \cdot \|w'_I\|_2$ happens if and only if $\langle w'_{T \setminus I}, e[\mathbf{z}_{T \setminus I}] \rangle \in \theta'' \pm \sqrt{2\log(2/\epsilon)} \cdot \|w'_I\|_2$, where $\theta'' = \theta' - \langle w'_{[h]}, e[\mathbf{z}_{[h]}] \rangle$. Relying on the hypothesis that $\|w_I\|_2 \leq \mu' \cdot \|w_T\|_2$ (hence $\|w'_I\|_2 \leq \mu' \cdot \|w'_T\|_2$), to upper-bound the probability of the latter event it suffices to upper-bound the probability of the event $\langle w'_{T \setminus I}, e[\mathbf{z}_{T \setminus I}] \rangle \in \theta'' \pm \sqrt{2\log(2/\epsilon)} \cdot \mu' \cdot \|w'_T\|_2$. We do so using the following claim, whose proof amounts to an application of the Berry-Esséen theorem:

**Claim 6.5.2** (see [Tel18, Lemma 5.5 in full version]). *Assume that $w'_T$ is $\mu$-regular and that $\mu' \leq 3/4$, and let $I \subseteq T$ such that $\|w'_I\|_2 < \mu' \cdot \|w'_T\|_2$. Then, for any $\theta'' \in \mathbb{R}$ and $r > 0$, the probability over uniform choice of $\mathbf{z}' \in \{0,1\}^{T \setminus I}$ that $\langle w'_{T \setminus I}, e[\mathbf{z}'] \rangle \in \theta'' \pm r \cdot \mu' \cdot \|w'_T\|_2$ is at most $O(r \cdot \mu' + \mu)$.*

We invoke the claim above with $r = \sqrt{2\log(2/\epsilon)}$, relying on the fact that $w'_T$ is $\mu$-regular and that $\mu' \leq 3/4$.[18] We deduce that the probability that $\langle w'_{T \setminus I}, e[\mathbf{z}'] \rangle \in \theta'' \pm \sqrt{2\log(2/\epsilon)} \cdot \mu' \cdot \|w'_T\|_2$ is $O(\mu + \mu' \cdot \sqrt{\log(1/\epsilon)})$. By the hypothesis that $\|w'_I\|_2 \leq \mu' \cdot \|w'_T\|_2$, the probability that $\langle w'_{T \setminus I}, e[\mathbf{z}'] \rangle \in \theta'' \pm \sqrt{2\log(2/\epsilon)} \cdot \|w'_I\|_2$ is $O(\mu + \mu' \cdot \sqrt{\log(1/\epsilon)})$. Since this holds for any fixed value for $\mathbf{z}_{[h]}$, it follows that the probability over $\mathbf{z} \in \{0,1\}^J$ that $\langle w'_J, e[\mathbf{z}] \rangle \in \theta' \pm \sqrt{2\log(2/\epsilon)} \cdot \|w'_I\|_2$ is at most $O(\mu + \mu' \cdot \sqrt{\log(1/\epsilon)})$. ∎

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[18]Note that we can assume $\mu' \leq 3/4$ without loss of generality, otherwise the statement that we are trying to prove is trivial (because our claimed error bound $O(\mu' \cdot \sqrt{\log(1/\epsilon)} + \mu)$ is larger than one).

The next proposition considers a restriction where we assign truly random values to a pseudorandom subset of the variables, as well as to the variables with the largest weights (in absolute value). Under such a restriction, the proposition asserts that the LTF is likely to become extremely biased. Furthermore, the bad event (i.e., the event that the LTF does not become extremely biased) is broken up into two bad events: a bad set of living variables, or a bad assignment. The probability of a bad assignment is moderately low, and crucially, the probability of a bad set of living variables is extremely low.

**Proposition 6.6** (pseudorandom restriction lemma for a single LTF). *For any $\epsilon, \gamma > 0$, there is a value*

$$\lambda = O(\gamma^{-2} \cdot \log^2(1/\epsilon) \cdot \log^2(\log(1/\epsilon)/\gamma)) = \widetilde{O}(\gamma^{-2} \cdot \log^2(1/\epsilon)) \tag{4}$$

*such that the following holds. Let $\Phi: \{0,1\}^n \to \{0,1\}$ be an LTF with weights vector $w \in \mathbb{R}^n$, and assume $|w_1| \geq |w_2| \geq \cdots \geq |w_n|$. Let $A \subseteq [n] \setminus [\lambda]$ and let $\mathbf{I}$ be a $p$-regular $\log(1/\epsilon)$-wise independent subset of $A$. Sample $\mathbf{z} \in \{0,1\}^{[n] \setminus \mathbf{I}}$ uniformly at random. Then with probability $1 - \epsilon$ over $\mathbf{I}$,*

$$\Pr_{\mathbf{z}}[\Phi\restriction_{\mathbf{I},\mathbf{z}} \text{ is not } \epsilon\text{-close to a constant}] \leq \gamma + O\left(\sqrt{p \log(1/\epsilon)}\right).$$

**Proof.** We wish to apply Proposition 6.5 with

$$\mu = \Theta\left(\frac{\gamma}{\log(1/\epsilon)}\right).$$

For this value of $\mu$, the parameter $\lambda$ in Proposition 6.5 is indeed given by Equation 4. We must verify that with high probability $\mathbf{I}$ satisfies the Proposition's hypotheses. Let $h$ be the $\mu$-critical index of $\Phi$. When $h > \lambda$, $\mathbf{I}$ is guaranteed to satisfy the hypotheses, because $\mathbf{I} \cap [\lambda] = \varnothing$ by design. Assume now that $h \leq \lambda$. Let $T = [n] \setminus [h]$, so $\mathbf{I} \subseteq A \subseteq T$. We need to show that with high probability over $\mathbf{I}$, we have $\|w_{\mathbf{I}}\| \leq \mu' \|w_T\|$ for some small parameter $\mu'$. Indeed, we claim that

$$\Pr_{\mathbf{I}}\left[\|w_{\mathbf{I}}\|_2 \leq O\left(\sqrt{p} + \mu\sqrt{\log(1/\epsilon)}\right) \cdot \|w_T\|_2\right] \geq 1 - \epsilon. \tag{5}$$

To prove it, for each $i \in A$, let $\mathbf{a}_i$ be the random variable

$$\mathbf{a}_i = \frac{w_i^2}{\mu^2 \|w_T\|_2^2} \cdot \mathbb{1}_{i \in \mathbf{I}}.$$

Note that, since $I \subseteq A$, we have that $\mu^2 \cdot \sum_{i \in A} \mathbf{a}_i = \frac{\|w_{\mathbf{I}}\|_2^2}{\|w_T\|_2^2}$. Since $w_T$ is $\mu$-regular, $\mathbf{a}_i \in [0,1]$. Furthermore,

$$\mathbb{E}\left[\sum_{i \in A} \mathbf{a}_i\right] = \frac{p\|w_A\|_2^2}{\mu^2 \|w_T\|_2^2} \leq \frac{p}{\mu^2}.$$

By Theorem 4.5 with $\Delta = p/\mu^2 + 300\log(1/\epsilon)$,

$$\Pr\left[\sum_{i \in A} \mathbf{a}_i \geq 2p/\mu^2 + 300\log(1/\epsilon)\right] \leq \epsilon.$$

(Here we use the fact that the events $i \in \mathbf{I}$ are $\log(1/\epsilon)$-wise independent.) If that bad event does not occur, then

$$\|w_{\mathbf{I}}\|_2^2 \leq (2p + 300\mu^2 \log(1/\epsilon)) \cdot \|w_T\|_2^2,$$

and hence $\|w_{\mathbf{I}}\|_2 \leq O(\sqrt{p} + \mu\sqrt{\log(1/\epsilon)}) \cdot \|w_T\|_2$, completing the proof of Equation (5). In this case, the hypotheses of Proposition 6.5 are satisfied with $\mu' = O(\sqrt{p} + \mu\sqrt{\log(1/\epsilon)})$, so

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indeed,

$$\Pr_{\mathbf{z}}[\Phi\!\restriction_{\mathbf{I},\mathbf{z}} \text{ is not } \epsilon\text{-close to a constant}] \leq O\left(\mu \log(1/\epsilon) + \sqrt{p \log(1/\epsilon)}\right)$$

$$= \gamma + O\left(\sqrt{p \log(1/\epsilon)}\right). \quad \blacksquare$$

### 6.1.3 Restrictions for one layer of an LTF circuit

We would now like to prove that an LTF circuit of super-linear size simplifies under a pseudorandom restriction, with very high probability. More specifically, in this result the $\star$ positions (**I**) are pseudorandom, but the non-$\star$ positions are filled in using truly random bits ($\mathbf{u}_{[n]\setminus\mathbf{I}}$). This is in contrast to the restrictions we studied in the context of De Morgan formulas, where both components were pseudorandom.

We begin with the special case that each variable in the LTF circuit has a bounded fan-out. (This is analogous to our analysis of De Morgan formulas, where we began with the special case of bounded-read formulas.)

The result below is stated for general parameters. To facilitate its parsing, consider the parametric setting with which we will apply the result: For a very small constant $\delta > 0$, given a circuit with $w = n^{1+\delta}$ wires in which each variable has fan-out at most $t = n^{O(\delta)}$, we apply a restriction that keeps $p = n^{O(\delta)}$ fraction of the variables alive. Our goal is to deduce that the circuit simplifies to an LTF-DT in which each branch queries at most $D = o(p \cdot n)$ variables and $M = n^{O(\delta)}$ LTFs. Indeed, we prove the following more general technical statement:

**Proposition 6.7** (pseudorandom restrictions simplify LTF circuits when the variables have bounded fan-out). *Let $n, w, d, t \in \mathbb{N}$ and $p, \epsilon > 0$. Let $\mathbf{I}$ be a $k$-wise independent $p$-regular subset of $[n]$ where $k = p^{-5/6} \log(6w/\epsilon)$, sample $\mathbf{u} \in \{0,1\}^n$ uniformly at random, and let $\boldsymbol{\rho} = (\mathbf{I}, \mathbf{u}_{[n]\setminus\mathbf{I}})$. For any depth-$d$ LTF circuit $C \colon \{0,1\}^n \to \{0,1\}$ with at most $w$ wires where every variable has fan-out at most $t$, there is an $(n, M, D, d-1, w, w)$-LTF-DT $\mathbf{T}$ (jointly distributed with $\boldsymbol{\rho}$) that is consistent with $C\!\restriction_{\boldsymbol{\rho}}$ such that $\mathbb{E}[\mathsf{Err}(\mathbf{T})] \leq \epsilon$ and*

$$D = O((p^{7/6} \cdot w + p^{-5/2} \cdot t) \cdot \log^2(w/\epsilon))$$
$$M = O(p^{-2/3} \cdot t).$$

**Proof.** We first analyze the effect of the restriction $\boldsymbol{\rho}$ on $C$ and prove a number of technical claims, while also explaining intuitively and in advance how we intend to construct an LTF decision tree that approximates $C\!\restriction_{\boldsymbol{\rho}}$. Afterwards we will rely on these technical claims to formally show how to construct the LTF-DT with error indicators.

Let $W$ be the set of LTF gates $\Phi$ such that every input to $\Phi$ is a variable (not another gate). We partition $W = W^{\mathtt{H}} \cup W^{\mathtt{L}}$, where $W^{\mathtt{H}}$ is the set of ("heavy") gates with fan-in at least $p^{-5/6}$ and $W^{\mathtt{L}} = W \setminus W^{\mathtt{H}}$. Let $X = \{x_1, \dots, x_n\}$ be the set of variables.

**Light gates.** Consider the wires between $W^{\mathtt{L}}$ and $X$. We say that two distinct variables $x_i, x_j \in X$ are a connected pair if there exists $g \in W^{\mathtt{L}}$ such that both $x_i$ and $x_j$ feed into $g$. The probability that both variables in a connected pair survive is $p^2$. The number of connected pairs is less than $p^{-5/6} \cdot w$, since each wire participates in fewer than $p^{-5/6}$ connected pairs. Therefore, in expectation, the number of connected pairs that survive the restriction is bounded by $p^2 \cdot p^{-5/6} \cdot w = p^{7/6} \cdot w$. The next claim says that a similar bound holds with high probability.

**Claim 6.7.1.** *With probability $1 - \epsilon/6$, the number of connected pairs such that both variables in the pair are in $\mathbf{I}$ is $O(p^{7/6} \cdot w + p^{-5/2} \cdot t \cdot \log(w/\epsilon))$.*

| | notation | our main setting |
|---|---|---|
| number of wires | $w$ | $n^{1+\delta}$ |
| fraction of live variables | $p$ | $n^{-O(\delta)}$ |
| target error probability | $\epsilon$ | $2^{-O(n^\delta)}$ |
| heavy gates fan-in | $\geq p^{-5/6}$ | $\geq n^{O(\delta)}$ |
| variable fan-out | $\leq t$ | $\leq n^{O(\delta)}$ |

Figure 2: The main parameters in the proof

*Proof.* Partition $W^{\mathtt{L}}$ into blocks $B_1, \ldots, B_r$, where $r \leq \log(p^{-5/6})$, such that each block $B_i$ consists of all gates with fan-in more than $2^{i-1}$ and at most $2^i$. Fix a block $i \in [r]$. Form a graph with vertex set $B_i$, where $g$ is adjacent to $g'$ if there is some variable $x_i \in X$ that feeds into both $g$ and $g'$. Since each gate $g$ has fan-in less than $p^{-5/6}$ and each variable has fan-out at most $t$, the maximum degree of this graph is less than $p^{-5/6} \cdot t$. Therefore, there is a proper coloring of the graph using $O(p^{-5/6} \cdot t)$ colors.

For each gate $g \in W^{\mathtt{L}}$, let $\mathbf{a}_g \in [0,1]$ be the fraction of pairs of variables feeding into $g$ such that both variables are in $\mathbf{I}$. Consider one color class $S$. Within this color class, gates read disjoint sets of variables. Furthermore, each gate reads fewer than $p^{-5/6}$ variables. Therefore, the variables $\mathbf{a}_g$ for $g \in S$ are $k'$-wise independent where $k' = \log(6w/\epsilon)$. Furthermore, $\mathbb{E}[\mathbf{a}_g] = p^2$, so

$$\mathbb{E}\left[\sum_{g \in S} \mathbf{a}_g\right] = p^2 |S|.$$

By Theorem 4.5, we have

$$\Pr\left[\sum_{g \in S} \mathbf{a}_g \geq 2p^2 |S| + 300 \log(6w/\epsilon)\right] \leq \frac{\epsilon}{6w}.$$

Now we shall union bound over all color classes and all blocks. Each color class has at least one gate, and there are at most $w$ gates in total. Therefore, except with probability $\epsilon/6$, for every $i$, we have

$$\sum_{g \in B_i} \mathbf{a}_g \leq 2p^2 |B_i| + O(p^{-5/6} \cdot t \cdot \log(w/\epsilon)).$$

In this case, the number of connected pairs feeding into $B_i$ that survive the restriction is

$$\sum_{g \in B_i} \mathbf{a}_g \cdot \binom{\mathtt{fan\text{-}in}(g)}{2} \leq \binom{2^i}{2} \cdot \sum_{g \in B_i} \mathbf{a}_g$$

$$\leq \binom{2^i}{2} \cdot (2p^2 |B_i| + O(p^{-5/6} \cdot t \cdot \log(w/\epsilon)))$$

$$\leq O\left(\binom{2^i}{2} \cdot p^{-5/6} \cdot t \cdot \log(w/\epsilon) + p^2 \sum_{g \in B_i} \binom{\mathtt{fan\text{-}in}(g)}{2}\right),$$

where the last step holds because $\binom{\mathtt{fan\text{-}in}(g)}{2} > \binom{2^{i-1}}{2} > \frac{1}{4}\binom{2^i}{2}$ for each $g \in W^{\mathtt{H}}$. Therefore, the total number of connected pairs that survive the restriction is

$$O\left(\left(\sum_{i=1}^{r} \binom{2^i}{2}\right) \cdot p^{-5/6} \cdot t \cdot \log(w/\epsilon)\right) + p^2 \cdot \sum_{g \in W^{\mathtt{L}}} \binom{\mathtt{fan\text{-}in}(g)}{2}\right).$$

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Since the total number of wires is at most $w$ and the fan-in of each $g \in W^{\mathrm{L}}$ is less than $p^{-5/6}$, we have $\sum_{g \in W^{\mathrm{L}}} \binom{\mathtt{fan\text{-}in}(g)}{2} < p^{-5/6} \cdot w$. Furthermore, $\sum_{i=1}^{r} \binom{2^i}{2} \leq 2^{2r+1} \leq O(p^{-5/3})$. Therefore the total number of connected pairs that survive is at most

$$O(p^{-5/3} \cdot p^{-5/6} \cdot t \cdot \log(w/\epsilon) + p^2 \cdot p^{-5/6} \cdot w) = O(p^{-5/2} \cdot t \cdot \log(w/\epsilon) + p^{7/6} \cdot w). \square$$

We will condition on the event of Claim 6.7.1, and in this case we will query all of the $O(p^{7/6} \cdot w + p^{-5/2} \cdot t \cdot \log(w/\epsilon))$ variables that participate in surviving connected pairs, such that the only remaining light gates are now projection functions.

**Heavy gates.** Consider the bipartite subgraph between $W^{\mathrm{H}}$ and $X$ (see Figure 3 for a pictorial representation of this subgraph). We first condition on three events that happen with high probability, and depend only on the choice of $\mathbf{I}$, the set of variables to keep alive. The first event will be that the fan-in of each gate decreases by roughly a factor of $p$; more accurately:
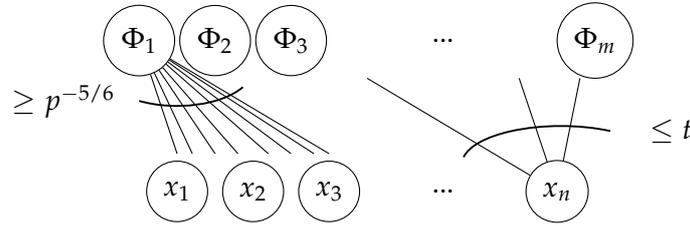


Figure 3: Pictorial representation of the subgraph between $W^{\mathrm{H}}$ and $X$. Recall that each $\Phi_i \in W^{\mathrm{H}}$ has fan-in at least $p^{-5/6}$, whereas each $x_i \in X$ has fan-out at most $t$.

**Claim 6.7.2.** *With probability at least $1 - \epsilon/6$, for each gate $g \in W$, there are at most $2p \cdot \mathtt{fan\text{-}in}(g) + O(\log(w/\epsilon))$ variables feeding into $g$ that are in $\mathbf{I}$.*

*Proof.* This follows from Theorem 4.5 and a union bound over the $\leq w$ gates in $W$. $\square$

We now consider two additional high-probability events that depend only on $\mathbf{I}$. Intuitively, we want to claim that after querying an additional small set of variables (on top of the variables assigned by $\boldsymbol{\rho}$), each gate $g \in W^{\mathrm{H}}$ has a decent chance of becoming extremely biased under the uniform random assignment of bits in $\boldsymbol{\rho}$.

In more detail, let $\gamma = p^{1/3} \log(w/\epsilon)$, and let $\lambda$ be the quantity from Proposition 6.6 with error parameter[19] $\epsilon/(6w)$, so $\lambda = O(p^{-2/3} \cdot \log^2(1/p))$. Let $X^{\mathtt{heads}}$ be the set of variables that includes, for each $g \in W^{\mathrm{H}}$, the $\lambda$ variables with the largest weights (in absolute value). Then, we claim that:

**Claim 6.7.3.** *With probability at least $1 - \epsilon/6$,*

$$|\mathbf{I} \cap X^{\mathtt{heads}}| \leq O(p^{7/6} \cdot w \cdot \log^2(1/p) + \log(1/\epsilon)).$$

*Proof.* We have $|X^{\mathtt{heads}}| \leq \lambda \cdot p^{5/6} \cdot w$ (since $|W^{\mathrm{H}}| \leq p^{5/6} \cdot w$ and each gate in $W^{\mathrm{H}}$ contributes at most $\lambda$ variables to $X^{\mathtt{heads}}$). By Theorem 4.5 with $\Delta = p \cdot \lambda \cdot p^{5/6} \cdot w + 300 \log(6/\epsilon)$, with probability at least $1 - \epsilon/6$, the number of variables in $X^{\mathtt{heads}}$ that land in $\mathbf{I}$ is at most

$$O(p \cdot \lambda \cdot p^{5/6} \cdot w + \log(1/\epsilon)) \leq O(p^{7/6} \cdot w \cdot \log^2(1/p) + \log(1/\epsilon)).$$

Here we use the fact that $\mathbf{I}$ is $\log(6/\epsilon)$-wise independent. $\square$

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[19]I.e., the good event in Proposition 6.6 is that the restricted function is $(\epsilon/(6w))$-close to a constant.

**Claim 6.7.4.** *Let* $\mathbf{I}' = \mathbf{I} \setminus X^{\text{heads}}$. *With probability at least* $1 - \epsilon/6$ *over the choice of* $\mathbf{I}$, *for every* $g \in W^{\text{H}}$,

$$\Pr_{\mathbf{u} \in \{0,1\}^n}[g\restriction_{\mathbf{I}',\mathbf{u}} \text{ is not } (\epsilon/(6w))\text{-close to a constant}] \leq O\left(p^{1/3}\log(w/\epsilon)\right). \tag{6}$$

*Proof.* For each $g \in W^{\text{H}}$, by Proposition 6.6, Equation (6) holds with probability $1 - \epsilon/(6w)$ over the choice of $\mathbf{I}$ (note that $\sqrt{p\log(1/\epsilon)} < \gamma$.) A union bound over the $\leq w$ gates in $W^{\text{H}}$ completes the proof. $\qquad\square$

Our LTF-DT will query all the variables in $X^{\text{heads}}$, and then we will deal with the gates according to the partition in the next claim. We will replace each gate in $\mathbf{W_1^H}$ with the corresponding constant; we will query all the variables feeding into the gates in $\mathbf{W_2^H}$; we will query the gates in $\mathbf{W_3^H}$ themselves.

**Claim 6.7.5.** *Let* $I$ *be such that the conclusions of Claims 6.7.2 and 6.7.4 are both satisfied. Let* $I' = I \setminus X^{\text{heads}}$ *and* $\mathbf{z} = \mathbf{u}_{[n]\setminus I'}$. *With probability* $1 - \epsilon/6$ *over* $\mathbf{z}$, $W^{\text{H}}$ *can be partitioned into three sets,* $W^{\text{H}} = \mathbf{W_1^H} \cup \mathbf{W_2^H} \cup \mathbf{W_3^H}$, *such that under the restriction* $(I', \mathbf{z})$:

1. *Every gate in* $\mathbf{W_1^H}$ *is* $(\epsilon/(6w))$-*close to a constant.*

2. *The number of living wires feeding into* $\mathbf{W_2^H}$ *is at most* $O(p^{7/6} \cdot w \cdot \log^2(w/\epsilon))$.

3. $|\mathbf{W_3^H}| \leq O(p^{-2/3} \cdot t)$.

*Proof.* Initially, partition $W^{\text{H}}$ into blocks $B_1, \ldots, B_r$, where $r \leq \log w$, such that each block $B_i$ consists of all gates with fan-in more than $2^{i-1}$ and at most $2^i$. For each gate $g \in W^{\text{H}}$, by Claim 6.7.4, under the restriction $(I', \mathbf{z})$, the probability that $g$ is not $(\epsilon/(6w))$-close to a constant is at most $\varphi = O(p^{1/3} \cdot \log(w/\epsilon))$. We let $\mathbf{W_3^H}$ be the union of all gates in blocks $B_i$ with $|B_i| \leq \varphi^{-2} \cdot t \cdot \log(6r/\epsilon)$, so indeed,

$$\begin{aligned}
|\mathbf{W_3^H}| &\leq r \cdot \varphi^{-2} \cdot t \cdot \log(6r/\epsilon) \\
&\leq O(\log w \cdot p^{-2/3} \cdot \log^{-2}(w/\epsilon) \cdot t \cdot \log(\log(w)/\epsilon)) \\
&< O(p^{-2/3} \cdot t).
\end{aligned}$$

We let $\mathbf{W_1^H}$ be the set of gates in $W^{\text{H}} \setminus \mathbf{W_3^H}$ that are $(\epsilon/(6w))$-close to a constant after the restriction, and we let $\mathbf{W_2^H} = W^{\text{H}} \setminus (\mathbf{W_1^H} \cup \mathbf{W_3^H})$. All that remains is to bound the number of living wires feeding into $\mathbf{W_2^H}$.

Consider some block $B_i$ with $|B_i| > \varphi^{-2} \cdot t \cdot \log(6r/\epsilon)$. For each $g \in B_i$, we have $\Pr[g \in \mathbf{W_2^H}] \leq \varphi$. Admittedly, these events are not completely independent, but each variable has fan-out at most $t$, so we may apply the read-$t$ Chernoff bound (Theorem 4.4) to our uniform choice of $\mathbf{z}$ (recall that $I$ is fixed). This shows that

$$\Pr[|B_i \cap \mathbf{W_2^H}| \geq 2\varphi|B_i|] \leq \exp(-\varphi^2|B_i|/t) < \frac{\epsilon}{6r}.$$

Therefore, by the union bound, with probability $1 - \epsilon/6$ every block $B_i$ contributes at most $2\varphi|B_i|$ gates to $\mathbf{W_2^H}$.

Furthermore, recall that we are assuming that $I$ satisfies the conclusion of Claim 6.7.2, so each gate in $B_i$ has at most $2p \cdot 2^i + O(\log(w/\epsilon))$ living wires. Therefore, in total, the number of living wires feeding into $\mathbf{W_2^H}$ is at most

$$\begin{aligned}
\sum_{i=1}^{r} 2\varphi \cdot |B_i| \cdot (2p \cdot 2^i + O(\log(w/\epsilon))) &\leq \varphi \cdot \left( \left(4p\sum_{i=1}^{r}|B_i| \cdot 2^i\right) + O\left(\log(w/\epsilon) \cdot \sum_{i=1}^{r}|B_i|\right)\right) \\
&\leq \varphi \cdot O\left(pw + p^{5/6} \cdot w \cdot \log(w/\epsilon)\right) \\
&\leq O(p^{7/6} \cdot w \cdot \log^2(w/\epsilon)),
\end{aligned}$$

where we used the fact that the number of gates in $W^{\text{H}}$ is at most $p^{5/6} \cdot w$. $\qquad\square$

**Constructing the `LTF-DT` with error indicators.** With probability $1 - 4\epsilon/6$ over the choice of restriction $\rho$, the conclusions of Claims 6.7.1, 6.7.2, 6.7.3, and 6.7.4 are all satisfied. If not, we set $\mathbf{T}$ to be a trivial tree with $\mathbf{T}(x) = 0$ and $\mathrm{Err}(\mathbf{T}, x) = 1$ for all $x$. Assume now that the conclusions of Claims 6.7.1, 6.7.2, 6.7.3, and 6.7.4 are all satisfied.

Let $\mathbf{I}' = \mathbf{I} \setminus X^{\texttt{heads}}$. On input $x \in \{0,1\}^{\mathbf{I}}$, our tree $\mathbf{T}$ first queries the variables in $X^{\texttt{heads}}$. These queries, together with $\rho$, define an assignment $\mathbf{z} \in \{0,1\}^{[n] \setminus \mathbf{I}'}$. If this assignment $\mathbf{z}$ does not satisfy the conclusion of Claim 6.7.5, the corresponding node of $\mathbf{T}$ is a leaf labeled by the constant zero function and $\mathcal{E}_\ell = \{1\}$ so that $\mathrm{Err}(\mathbf{T}, x) = 1$.

Assume now that the conclusion of Claim 6.7.5 is satisfied, so we obtain a partition of $W^{\mathtt{H}}$ into $W^{\mathtt{H}} = W_1^{\mathtt{H}} \cup W_2^{\mathtt{H}} \cup W_3^{\mathtt{H}}$. The gates in $W_1^{\mathtt{H}}$ are close to constants, after restricting according to $(\mathbf{I}', \mathbf{z})$. Let $\widetilde{C\restriction_{\mathbf{I}', \mathbf{z}}}$ be the circuit obtained from $C\restriction_{\mathbf{I}', \mathbf{z}}$ by replacing each gate in $W_1^{\mathtt{H}}$ with the corresponding constant. Write $W_1^{\mathtt{H}} = \{\Phi_1, \ldots, \Phi_r\}$ (where $r \le w$), and let $\Sigma = \{\sigma_1, \ldots, \sigma_r\}$ be the corresponding set of constants. For each $\Phi_i \in W_1^{\mathtt{H}}$, let

$$\mathbf{E}_i = \begin{Bmatrix} \Phi_i\restriction_{\mathbf{I}', \mathbf{z}} & \sigma_i = 0 \\ 1 - \Phi_i\restriction_{\mathbf{I}', \mathbf{z}} & \sigma_i = 1 \end{Bmatrix},$$

and note that $\mathbf{E}_i(x) = 1$ if and only if $\Phi_i\restriction_{\mathbf{I}', \mathbf{z}}(x) \ne \sigma_i$. Define $\mathcal{E} = \{\mathbf{E}_1, \ldots, \mathbf{E}_r\}$.

Next, $\mathbf{T}$ queries the live variables feeding into $W_2^{\mathtt{H}}$ and queries each gate in $W_3^{\mathtt{H}}$. We query also the connected pairs of variables feeding into $W^{\mathtt{L}}$, arriving at a leaf $\ell$ of $\mathbf{T}$. After replacing each of these variables and gates with the corresponding query value, our circuit $\widetilde{C\restriction_{\mathbf{I}', \mathbf{z}}}$ simplifies to a new `LTF` circuit $\mathbf{C}'$. This new circuit has depth $d - 1$, because for every gate $\Phi$ in $W$, either we queried $\Phi$ itself (hence it got replaced with a constant) or we queried all but perhaps one of the input variables to $\Phi$ (hence it got replaced with a constant or a literal). We set $C_\ell = \mathbf{C}'$ and $\mathcal{E}_\ell = \mathcal{E}$.

By construction, either $\mathbf{T}(x) = C\restriction_{\rho}(x)$ or else some $\Phi_i(x) \ne \sigma_i$ in which case $\mathrm{Err}(\mathbf{T}, x) \ge 1$, so indeed, $\mathbf{T}$ is consistent with $C\restriction_{\rho}$. Now let us bound $\mathbb{E}[\mathrm{Err}(\mathbf{T})] = \mathbb{E}[\mathrm{Err}(\mathbf{T}, \mathbf{u_I})]$. There is a $4\epsilon/6$ chance that $\rho$ is a bad restriction causing us to immediately halt with $\mathrm{Err}(\mathbf{T}, \mathbf{u_I}) = 1$. The probability that the good event of Claim 6.7.5 does not occur is at most $\epsilon/6$. Each gate $\Phi_i$ that we replaced by a constant was $(\epsilon/(6w))$-close to that constant, so $\mathbb{E}[\mathbf{E}_i(\mathbf{u_I})] \le \epsilon/(6w)$. There are at most $w$ gates in the circuit, so by linearity of expectation, $\mathbb{E}[\mathrm{Err}(\mathbf{T})] \le 4\epsilon/6 + \epsilon/6 + \epsilon/6 = \epsilon$.

Let us verify that we obtained the claimed parameters for the tree. We query the variables in living connected pairs, the variables in $X^{\texttt{heads}}$, and the variables feeding into $W_2^{\mathtt{H}}$, giving

$$\begin{aligned} D &\le O(p^{7/6} \cdot w + p^{-5/2} \cdot t \cdot \log(w/\epsilon)) \\ &\quad + O(p^{7/6} \cdot w \cdot \log^2(1/p) + \log(1/\epsilon)) \\ &\quad + O(p^{7/6} \cdot w \cdot \log^2(w/\epsilon)) \\ &\le O((p^{7/6} \cdot w + p^{-5/2} \cdot t) \cdot \log^2(w/\epsilon)), \end{aligned}$$

where the last step uses the fact that $\log(1/p) \le \log w$ without loss of generality. (After all, if $p < 1/w$, then our claimed bound on $D$ is greater than $w$.) Also, we queried the gates from $W_3^{\mathtt{H}}$, giving

$$M \le O(p^{-2/3} \cdot t).$$

Finally, note that for each leaf of the tree, none of the variables queried along the path to that leaf appear as input variables in the circuit labeling that leaf. (This is required by Definition 6.1.) ∎

We now state a result analogous to Proposition 6.7, but that doesn't assume the variables have bounded fan-out. Intuitively, we will reduce the general case to the case of bounded fan-out by using the decision tree to query "heavy" variables.

**Proposition 6.8** (pseudorandom restrictions simplify LTF circuits, even if the variable fan-out is large). *Let $n, w, d \in \mathbb{N}$ and $p, \epsilon > 0$. Let $\mathbf{I}$ be a $k$-wise independent $p$-regular subset of $[n]$ where $k = p^{-5/6} \log(6w/\epsilon)$, sample $\mathbf{u} \in \{0,1\}^n$ uniformly at random, and let $\boldsymbol{\rho} = (\mathbf{I}, \mathbf{u}_{[n]\setminus \mathbf{I}})$. For any depth-$d$ LTF circuit $C \colon \{0,1\}^n \to \{0,1\}$ with at most $w$ wires, there is an $(n, M, D, d-1, w, w)$-LTF-DT $\mathbf{T}$ (jointly distributed with $\boldsymbol{\rho}$) that is consistent with $C{\restriction}_{\boldsymbol{\rho}}$ such that $\mathbb{E}[\mathrm{Err}(\mathbf{T})] \leq \epsilon$ and*

$$D = O((p^{7/6} \cdot w + p^{-11/3}) \cdot \log^2(w/\epsilon))$$
$$M = O(p^{-11/6}).$$

**Proof.** Let $X^{\mathtt{H}} \subseteq [n]$ be the set of variables with fan-out more than $t$, where $t = \lceil p^{-7/6} \rceil$, and let $X^{\mathtt{L}} = [n] \setminus X^{\mathtt{H}}$. For each $z \in \{0,1\}^{X^{\mathtt{H}}}$, define $C_z = C{\restriction}_{(X^{\mathtt{L}}, z)}$, a depth-$d$ LTF circuit with at most $w$ wires where every variable has fan-out at most $t$. Applying Proposition 6.7 to $C_z$ gives some tree $\mathbf{T}_z$ (jointly distributed with $\boldsymbol{\rho}$) that is consistent with $(C_z){\restriction}_{\boldsymbol{\rho}}$. On input $x \in \{0,1\}^{\mathbf{I}}$, our tree $\mathbf{T}$ first queries every variable in $X^{\mathtt{H}} \cap \mathbf{I}$. Together with $\boldsymbol{\rho}$, the answers to these queries define some assignment $z \in \{0,1\}^{X^{\mathtt{H}}}$. Our tree $\mathbf{T}$ then simulates $\mathbf{T}_z(x)$. As before (and as required in Definition 6.1), none of the variables queried along the path to a leaf of the tree appear as input variables in the circuit labeling that leaf.

Now let us bound $\mathbb{E}[\mathrm{Err}(\mathbf{T})]$. By construction,

$$
\begin{aligned}
\mathbb{E}[\mathrm{Err}(\mathbf{T})] &= \mathbb{E}[\mathrm{Err}(\mathbf{T}, \mathbf{u}_{\mathbf{I}})] \\
&= \mathbb{E}[\mathrm{Err}(\mathbf{T}_{\mathbf{u}_{X^{\mathtt{H}}}}, \mathbf{u}_{\mathbf{I}})] \\
&= \mathbb{E}\left[ \sum_{z \in \{0,1\}^{X^{\mathtt{H}}}} \mathrm{Err}(\mathbf{T}_z, \mathbf{u}_{\mathbf{I}}) \cdot \mathbb{1}_{z = \mathbf{u}_{X^{\mathtt{H}}}} \right] \\
&= \sum_{z \in \{0,1\}^{X^{\mathtt{H}}}} \mathbb{E}[\mathrm{Err}(\mathbf{T}_z, \mathbf{u}_{\mathbf{I}}) \cdot \mathbb{1}_{z = \mathbf{u}_{X^{\mathtt{H}}}}].
\end{aligned}
$$

For a fixed $z$, the circuit $C_z$ only reads variables in $X^{\mathtt{L}}$. Therefore, the random variable $\mathrm{Err}(\mathbf{T}_z, \mathbf{u}_{\mathbf{I}})$ is independent of $\mathbf{u}_{X^{\mathtt{H}}}$. Therefore,

$$\mathbb{E}[\mathrm{Err}(\mathbf{T})] = \sum_{z \in \{0,1\}^{X^{\mathtt{H}}}} \mathbb{E}[\mathrm{Err}(\mathbf{T}_z, \mathbf{u}_{\mathbf{I}})] \cdot \Pr[z = \mathbf{u}_{X^{\mathtt{H}}}] = \sum_{z \in \{0,1\}^{X^{\mathtt{H}}}} \mathbb{E}[\mathrm{Err}(\mathbf{T}_z)] \cdot 2^{-|X^{\mathtt{H}}|} \leq \epsilon.$$

Finally, since $C$ has at most $w$ wires, $|X^{\mathtt{H}}| \leq w/t \leq p^{7/6} \cdot w$, hence the number of variable queries made by $\mathbf{T}$ is at most

$$|X^{\mathtt{H}}| + O((p^{7/6} \cdot w + p^{-5/2} \cdot t) \cdot \log^2(w/\epsilon)) = O((p^{7/6} \cdot w + p^{-11/3}) \cdot \log^2(w/\epsilon)),$$

and the number of LTF queries made by $\mathbf{T}$ is at most

$$O(p^{-2/3} \cdot t) = O(p^{-11/6}). \qquad \blacksquare$$

### 6.1.4 Restrictions for one layer of the leaves of an LTF-DT

Recall that given a LTF circuit of depth $d$ and super-linear size, we want to iteratively apply multiple restrictions that will simplify the circuit. Since Proposition 6.7 asserts that the first restriction will already simplify the circuit to an LTF-DT, we now want to show that further restrictions simplify an LTF-DT to a simpler LTF-DT (in particular, one whose leaves are labeled by shallower LTF circuits). This is proved in the following result.

Similarly to Proposition 6.7, the result below is stated for general parameters, and to facilitate its parsing we suggest the following specific setting with which it will be applied. For a very small constant $\delta > 0$, we are given an LTF-DT whose leaves are labeled by circuits

with $w = n^{1+\delta}$ wires, and in which each branch queries at most $D = o(n)$ variables and $M = n^{O(\delta)}$ LTF gates. We will apply a restriction that keeps $p = n^{O(\delta)}$ fraction of the variables alive, and want to deduce that the LTF-DT simplifies to one whose leaves are labeled by shallower circuit, such that each branch queries at most $D' = p \cdot D + o(p \cdot n)$ variables and $M' = M + n^{O(\delta)}$ LTFs, with tiny error probability $\epsilon \approx 2^{p^{-.01}}$. These parameter settings are formally stated in Corollary 6.10 below.

In the statement below, instead of using the notation $D$ and $D'$ (and so forth) we will denote the parameters with a subscript $d$ (e.g., $D_d$ and $D_{d-1}$). We use this notation because we will later use the result in a recursive depth-reduction process, in which all the parameters will change in each depth-reduction step. Nevertheless, we wish to stress that in the generic statement below these parameters are *not* functions of the depth.

**Proposition 6.9** (pseudorandom restrictions simplify LTF-DTs). *Let $n, w, d, M_d \in \mathbb{N}$ and $p, \epsilon > 0$. Let $\mathbf{I}$ be a $k$-wise independent $p$-regular subset of $[n]$ where $k = p^{-5/6} \cdot (M_d + \log(12w/\epsilon))$, sample $\mathbf{u} \in \{0,1\}^n$ uniformly at random, and let $\boldsymbol{\rho} = (\mathbf{I}, \mathbf{u}_{[n]\setminus \mathbf{I}})$. For any function $C \colon \{0,1\}^n \to \{0,1\}$ and any $(n, M_d, D_d, d, w, e_d)$-LTF-DT $T_d$ consistent with $C$, there is an $(n, M_{d-1}, D_{d-1}, d-1, w, e_{d-1})$-LTF-DT $\mathbf{T}_{d-1}$ (jointly distributed with $\boldsymbol{\rho}$) that is consistent with $C|_{\boldsymbol{\rho}}$ such that*

$$\mathbb{E}[\mathsf{Err}(\mathbf{T}_{d-1})] \le \mathsf{Err}(T_d) + \epsilon$$
$$D_{d-1} = O(p \cdot D_d + (p^{7/6} \cdot w + p^{-11/3}) \cdot (M_d^2 + \log^2(w/\epsilon)))$$
$$M_{d-1} = M_d + O(p^{-11/6})$$
$$e_{d-1} = e_d + w.$$

Before turning to the proof, let us state the special case of Proposition 6.9 that was mentioned above and that we will use for our main result.

**Corollary 6.10** (the special case of Proposition 6.9 used in our main result). *Let $\delta > 0$ be sufficiently small and let $n, d \in \mathbb{N}$. For suitable values $p = n^{-O(\delta)}$ and $k = n^{O(\delta)}$, let $\mathbf{I}$ be a $k$-wise independent $p$-regular subset of $[n]$. Sample $\mathbf{u} \in \{0,1\}^n$ uniformly at random and let $\boldsymbol{\rho} = (\mathbf{I}, \mathbf{u}_{[n]\setminus \mathbf{I}})$. For any function $C \colon \{0,1\}^n \to \{0,1\}$ and any $(n, M_d, D_d, d, n^{1+\delta}, e_d)$-LTF-DT $T_d$ consistent with $C$, there is an $(n, M_{d-1}, D_{d-1}, d-1, n^{1+\delta}, e_{d-1})$-LTF-DT $\mathbf{T}_{d-1}$ (jointly distributed with $\boldsymbol{\rho}$) that is consistent with $C|_{\boldsymbol{\rho}}$ such that*

$$\mathbb{E}[\mathsf{Err}(\mathbf{T}_{d-1})] \le \mathsf{Err}(T_d) + 2^{-\Omega(n^\delta)}$$
$$D_{d-1} = O(p \cdot D_d) + n^{-\Omega(\delta)} \cdot p \cdot n$$
$$M_{d-1} = M_d + n^{O(\delta)}$$
$$e_{d-1} = e_d + n^{1+\delta}.$$

**Proof of Proposition 6.9.** Let $L$ be the leaves of $T_d$. Let $\ell(x) \in L$ be the leaf reached by $T_d(x)$, and for each $\ell \in L$, let $V_\ell$ be the set of variables queried by $T_d$ along the path to $\ell$. Loosely speaking, we will first show that with high probability, the restriction decreases the length of every path in $T_d$ by a factor of approximately $p$. Then, we use Proposition 6.7 to simplify the functions that label the leaves of $T_d$.

**Shortening the paths in the tree.** On input $x \in \{0,1\}^{\mathbf{I}}$, our new tree $\mathbf{T}_{d-1}$ begins by simulating the tree portion of $T_d(x \circ \boldsymbol{\rho})$, querying $x$ whenever $T_d$ makes a query to a variable in $\mathbf{I}$. However, if $\mathbf{T}_{d-1}$ finds that this process would require making more than $q$ queries to $x$ where $q = 2p \cdot D_d + 300 \log(2/\epsilon)$, then instead of making query number $\lfloor q \rfloor + 1$, our tree $\mathbf{T}_{d-1}$ halts, outputs 0, and sets $\mathcal{E}_\ell = \{1\}$ for that leaf.

Let us bound the contribution from these events to $\mathbb{E}[\mathrm{Err}(\mathbf{T}_{d-1})]$, i.e., the probability that we are forced to halt early in that way with respect to $\rho$ and the uniform random input $\mathbf{u}_{\mathbf{I}}$. Since $\mathbf{u}_{\mathbf{I}} \circ \rho = \mathbf{u}$, we are simulating $T_d(\mathbf{u})$, so the contribution to $\mathbb{E}[\mathrm{Err}(\mathbf{T}_{d-1})]$ is

$$\Pr_{\mathbf{I},\mathbf{u}}[|V_{\ell(\mathbf{u})} \cap \mathbf{I}| > q] = \sum_{\ell \in L} \Pr_{\mathbf{u}}[\ell(\mathbf{u}) = \ell] \cdot \Pr_{\mathbf{I}}[|V_\ell \cap \mathbf{I}| > q].$$

For a fixed $\ell$, by Theorem 4.5, we have $\Pr[|V_\ell \cap \mathbf{I}| > q] \leq \epsilon/2$. Hence, overall we get the bound

$$\sum_{\ell \in L} \frac{\epsilon}{2} \cdot \Pr_{\mathbf{u}}[\ell(\mathbf{u}) = \ell] = \frac{\epsilon}{2}.$$

**Approximating leaves by LTF-DTs.** Consider now the case that the simulation of $T_d(x \circ \rho)$ successfully reaches a leaf $\ell$ of $T_d$ (without needing to make more than $q$ queries to $x$). For each fixed leaf $\ell \in L$, let $C_\ell$ be the depth-$d$ LTF circuit labeling $\ell$, and let $\mathcal{E}_\ell$ be the set of error indicators labeling $\ell$. Let $\mathbf{T}^{(\ell)}$ be the tree (jointly distributed with $\rho$) obtained from applying Proposition 6.7 to $C_\ell$ with error $\epsilon' := \epsilon \cdot 2^{-M_d-1}$, so $\mathbf{T}^{(\ell)}$ is consistent with $C_\ell\!\restriction_\rho$. (Note that $\mathbf{I}$ has enough independence to apply Proposition 6.7 with this small error value.) Our tree $\mathbf{T}_{d-1}(x)$ simulates $\mathbf{T}^{(\ell)}(x)$. When $\mathbf{T}^{(\ell)}$ finally reaches a leaf labeled by a circuit $C'$ and a set $\mathcal{E}$ of error indicators, then the corresponding leaf of $\mathbf{T}_{d-1}$ is labeled by the same circuit $C'$ and the set $\mathcal{E} \cup \mathcal{E}_\ell$ of error indicators.

In this way, for every $x$, we have $\mathbf{T}_{d-1}(x) = C\!\restriction_\rho(x)$ or $\mathrm{Err}(\mathbf{T}_{d-1}, x) \geq 1$. Let us bound $\mathbb{E}[\mathrm{Err}(\mathbf{T}_{d-1})] = \mathbb{E}[\mathrm{Err}(\mathbf{T}_{d-1}, \mathbf{u}_{\mathbf{I}})]$. The contribution from the error indicators of $T_d$ is at most $\mathrm{Err}(T_d)$; now we must bound the contribution from the error indicators of $\mathbf{T}^{(\ell)}$. The leaf $\ell \in L$ that we reach is given by $\ell(\mathbf{u}_{\mathbf{I}} \circ \rho) = \ell(\mathbf{u})$.

It is tempting to say that the contribution from $\mathbf{T}^{(\ell(\mathbf{u}))}$ must be at most $\epsilon'$, because for each fixed leaf $\ell$, $\mathbb{E}[\mathrm{Err}(\mathbf{T}^{(\ell)})] \leq \epsilon'$. Unfortunately, we cannot argue the same way we did in the proof of Proposition 6.8. The reason is that when accounting for the error, the expected contribution of each $\mathbf{T}^{(\ell)}$ (i.e., for a fixed leaf $\ell$ of $T_d$) is the number of errors made by $\mathbf{T}^{(\ell)}$ on a random input *conditioned on the input leading the tree to $\ell$ in $T_d$* (i.e., conditioned on the event $\ell(\mathbf{u}) = \ell$). If $T_d$ would only query variables, this conditioning would not matter, since $\mathbf{T}^{(\ell)}$ does not depend on the values of variables queried in the path to $\ell$. However, $T_d$ also queries $M_d$ LTFs, and hence the conditioning might focus the contribution of $\mathbf{T}^{(\ell)}$ on a subset of inputs on which $\mathbf{T}^{(\ell)}$ is likely to err. Fortunately, as we show below, this conditioning can only increase the contribution of each leaf by $2^{M_d}$, and thus overall contribution of $\mathbf{T}^{(\ell(\mathbf{u}))}$ to the error is at most $\epsilon' \cdot 2^{M_d}$.

For each fixed leaf $\ell \in L$, recall that $V_\ell$ is the set of variables queried in $T_d$ along the path to $\ell$, and let $\vec{v}_\ell \in \{0,1\}^{|V_\ell|}$ be the sequence of values of the edges outgoing from the nodes that correspond to $V_\ell$ along this path. Similarly, let $G_\ell$ be the set of at most $M_d$ gates queried in $T$ along the path to $\ell$, and let $\vec{g}_\ell \in \{0,1\}^{|G_\ell|}$ be the sequence of values of the edges outgoing from the nodes that correspond to $G_\ell$ along this path. We define $\mathtt{gts}_\ell\colon \{0,1\}^n \to \{0,1\}^{|G_\ell|}$ to be the function $x \mapsto (g(x))_{g \in G_\ell}$, and similarly define $\mathtt{vrs}_\ell(x) = (x_i)_{x_i \in V_\ell}$. Then

$$\begin{aligned}
\mathbb{E}_{\mathbf{I},\mathbf{u}}\left[\mathrm{Err}(\mathbf{T}^{(\ell(\mathbf{u}))}, \mathbf{u}_{\mathbf{I}})\right] &= \mathbb{E}_{\mathbf{I},\mathbf{u}}\left[\sum_{\ell \in L} \mathrm{Err}(\mathbf{T}^{(\ell)}, \mathbf{u}_{\mathbf{I}}) \cdot \mathbb{1}_{\ell(\mathbf{u})=\ell}\right] \\
&= \sum_{\ell \in L} \mathbb{E}_{\mathbf{I},\mathbf{u}}\left[\mathrm{Err}(\mathbf{T}^{(\ell)}, \mathbf{u}_{\mathbf{I}}) \cdot \mathbb{1}_{\mathtt{vrs}_\ell(\mathbf{u})=\vec{v}_\ell} \cdot \mathbb{1}_{\mathtt{gts}_\ell(\mathbf{u})=\vec{g}_\ell}\right] \\
&\leq \sum_{\ell \in L} \mathbb{E}_{\mathbf{I},\mathbf{u}}\left[\mathrm{Err}(\mathbf{T}^{(\ell)}, \mathbf{u}_{\mathbf{I}}) \cdot \mathbb{1}_{\mathtt{vrs}_\ell(\mathbf{u})=\vec{v}_\ell}\right].
\end{aligned}$$

Now, $C_\ell$ does not read any of the variables in $V_\ell$, and hence neither does $\mathbf{T}^{(\ell)}$. Therefore, the random variables $\mathsf{Err}(\mathbf{T}^{(\ell)}, \mathbf{u})$ and $\mathbb{1}_{\mathrm{vrs}_\ell(\mathbf{u})=\vec{v}_\ell}$ are independent, giving us the bound

$$\mathop{\mathbb{E}}_{\mathbf{I},\mathbf{x}}[\mathsf{Err}(\mathbf{T}^{(\ell(\mathbf{u}))}, \mathbf{u_I})] \leq \sum_{\ell \in L} \mathop{\mathbb{E}}_{\mathbf{I},\mathbf{u}}[\mathsf{Err}(\mathbf{T}^{(\ell)}, \mathbf{u_I})] \cdot \mathop{\Pr}_{\mathbf{u}}[\mathrm{vrs}_\ell(\mathbf{u}) = \vec{v}_\ell]$$

$$= \sum_{\ell \in L} \mathop{\mathbb{E}}_{\rho}[\mathsf{Err}(\mathbf{T}^{(\ell)})] \cdot \mathop{\Pr}_{\mathbf{u}}[\mathrm{vrs}_\ell(\mathbf{u}) = \vec{v}_\ell]$$

$$\leq \epsilon' \cdot \sum_{\ell \in L} \mathop{\Pr}_{\mathbf{u}}[\mathrm{vrs}_\ell(\mathbf{u}) = \vec{v}_\ell]$$

$$= \epsilon' \cdot \mathop{\mathbb{E}}_{\mathbf{u}}[|\{\ell \in L : \mathrm{vrs}_\ell(\mathbf{u}) = \vec{v}_\ell\}|].$$

Now consider some fixed string $u \in \{0,1\}^n$. To find all the leaves $\ell$ satisfying $\mathrm{vrs}_\ell(u) = \vec{v}_\ell$, we can start at the root; when we reach a node that queries a variable, we take the outgoing edge specified by $u$, and when we reach a node that queries a gate, we choose an outgoing edge arbitrarily. We always make at most $M_d$ such binary choices, so $|\{\ell \in L : \mathrm{vrs}_\ell(u) = \vec{v}_\ell\}| \leq 2^{M_d}$. Therefore,

$$\mathop{\mathbb{E}}_{\mathbf{I},\mathbf{u}}[\mathsf{Err}(\mathbf{T}^{(\ell(\mathbf{u}))}, \mathbf{u})] \leq 2^{M_d} \cdot \epsilon'.$$

Summing up, overall we get

$$\mathbb{E}[\mathsf{Err}(\mathbf{T}_{d-1})] \leq \mathsf{Err}(T_d) + \frac{\epsilon}{2} + 2^{M_d} \cdot \epsilon' = \mathsf{Err}(T_d) + \epsilon.$$

By Proposition 6.8, we have

$$D_{d-1} \leq q + O((p^{7/6} \cdot w + p^{-11/3}) \cdot \log^2(w/\epsilon'))$$

$$= O(p \cdot D_d + (p^{7/6} \cdot w + p^{-11/3}) \cdot (M_d + \log(w/\epsilon))^2)$$

and $M_{d-1} = M_d + O(p^{-11/6})$. $\blacksquare$

### 6.1.5   Iterated restriction: Simplifying the entire circuit

Our goal now is to iteratively apply Proposition 6.9 to a given LTF circuit, in order to simplify it to an LTF-DT whose leaves are labeled by real sums of LTF functions. This is presented in the following result, which is the formal statement of Proposition 2.2, and whose proof mainly involves inductive calculations of the parameters of such iterative applications. As in the previous section, we first state a general result for a broad range of parameters, and afterwards state a corollary that refers to the specific parameters used in our main result.

**Proposition 6.11** (iterated restrictions simplify an LTF circuit to a decision tree with LTFs at the leaves). *Let $n, d, w \in \mathbb{N}$ and $p, \epsilon \in (0, 1/2)$. There is a distribution over subsets $\mathbf{I} \subseteq [n]$ of size $\lceil pn \rceil$ with the following properties.*

1. *Let $\rho = (\mathbf{I}, \mathbf{u}_n)$. If $C: \{0,1\}^n \to \{0,1\}$ is a depth-$d$ LTF circuit with at most $w$ wires, then with probability $1 - \epsilon$, there is an $(\lceil pn \rceil, M, D, 1, w, wd)$-LTF-DT $\mathbf{T}$ consistent with $C\restriction_\rho$ such that $\mathsf{Err}(\mathbf{T}) \leq \epsilon$ and*

$$D = (p^{1+40^{-(d-1)}} \cdot w + p^{-4}) \cdot 2^{O(d)} \cdot \log^2(w/\epsilon)$$

$$M = O(p^{-2} \cdot d).$$

2. *The set $\mathbf{I}$ can be sampled using $O(p^{-1} \cdot d \cdot \log(w/\epsilon) \cdot \log n)$ truly random bits in time $\mathrm{poly}(n)$.*

**Proof.** Without loss of generality, assume that $p > 1/n$ (otherwise we can take $\mathbf{I} = \varnothing$) and that $d < \log(n)$ and $w < n^2$ and $\epsilon \geq 2^{-n}$ (otherwise $D > p \cdot n$, in which case for any set $I$ of size $\lceil p \cdot n \rceil$ we can construct a depth-$D$ tree that queries all living variables).[20]

We view the initial circuit $C$ as an $(n, M_d, D_d, d, w, 0)$-LTF-DT $\mathbf{T}_d$ with the trivial parameters $D_d = M_d = 0$. Then, we will repeatedly apply Proposition 6.9 with error parameter $\epsilon^2/(2d)$, giving a sequence of restrictions $\boldsymbol{\rho}_d, \dots, \boldsymbol{\rho}_2 \in \{0, 1, \star\}^n$ and a sequence of trees $\mathbf{T}_{d-1}, \dots, \mathbf{T}_1$, where $\mathbf{T}_i$ is an $(n, M_i, D_i, i, w, w \cdot (d-i))$-LTF-DT, where $M_i$ and $D_i$ will be computed shortly. We emphasize that we have numbered the restrictions so that we start with $\boldsymbol{\rho}_d$ and finish with $\boldsymbol{\rho}_2$. That way, $\boldsymbol{\rho}_i$ is applied to a tree whose leaves are labeled with circuits of depth $i$. Note also that for convenience, we are thinking of each $\mathbf{T}_i$ as a function of $n$ variables (though possibly fewer than $n$ variables are influential).[21]

Let $A = \sum_{i=2}^{d} 40^{d-i} = (40^{d-1} - 1)/39$. We choose $\boldsymbol{\rho}_i$ to be a $p_i$-regular restriction, where

$$p_i \approx (2p)^{40^{d-i}/A}.$$

Specifically, $p_i$ is the smallest power of two such that $p_i \geq (2p)^{40^{d-i}/A}$. For convenience, we extend this definition also to the case $i = d + 1$. Define $p_{i \cdots d} = \prod_{j=i}^{d} p_j$. Observe that $p_i \leq p_{i+1}$, and indeed $p_i \leq 2p_{i+1}^{40}$. Furthermore, $i < d \implies p_i < 2p_{i+1 \cdots d}^{39}$.[22] Let $\overline{\boldsymbol{\rho}} = \boldsymbol{\rho}_2 \circ \cdots \circ \boldsymbol{\rho}_d$, so that for each $j \in [n]$,

$$\Pr[j \in (\overline{\boldsymbol{\rho}})^{-1}(\star)] = p_{2 \cdots d} \geq 2p.$$

Since each set $\boldsymbol{\rho}_i^{-1}(\star)$ is $k$-wise independent for $k \gg \log(2/\epsilon)$ (this is required by Proposition 6.9 regardless of $M_i$ and $D_i$), $(\overline{\boldsymbol{\rho}})^{-1}(\star)$ is also $\log(2/\epsilon)$-wise independent. Therefore, by Theorem 4.5 with $\Delta = pn$, with probability $1 - \epsilon/2$, we have $|(\overline{\boldsymbol{\rho}})^{-1}(\star)| \geq pn$.[23]

If $|(\overline{\boldsymbol{\rho}})^{-1}(\star)| < pn$, we just let $\mathbf{I} = \{1, \dots, \lceil pn \rceil\}$. Assume from now on that $|(\overline{\boldsymbol{\rho}})^{-1}(\star)| \geq pn$. In this case, we let $\mathbf{I}$ be an arbitrary subset of $|(\overline{\boldsymbol{\rho}})^{-1}(\star)|$ of size exactly $\lceil pn \rceil$, and we set $\mathbf{T} = \mathbf{T}_1 {\upharpoonright}_{\boldsymbol{\rho}}$, where recall $\boldsymbol{\rho} = (\mathbf{I}, \mathbf{u}_n)$. In other words, we assign uniform random values to a few of the variables of $\mathbf{T}_1$ (simplifying the tree and the circuits labeling its leaves in the straightforward way) so that $\mathbf{T}$ is a function of exactly $\lceil pn \rceil$ variables.

Clearly, $\mathbf{T}$ is an $(\lceil pn \rceil, M_1, D_1, 1, w, wd)$-LTF-DT that is consistent with $C{\upharpoonright}_{\boldsymbol{\rho}}$. Furthermore, for any $i \in \{2, \dots, d\}$ and any fixing of $\boldsymbol{\rho}_d, \dots, \boldsymbol{\rho}_{i+1}$, Proposition 6.9 guarantees that

$$\mathop{\mathbb{E}}_{\boldsymbol{\rho}_i}[\mathsf{Err}(\mathbf{T}_{i-1})] \leq \mathsf{Err}(\mathbf{T}_i) + \frac{\epsilon^2}{2d}.$$

Note that $\mathbf{T}_i$ does not depend on $\boldsymbol{\rho}_i, \dots, \boldsymbol{\rho}_2$ and similarly $\mathbf{T}_{i-1}$ does not depend on $\boldsymbol{\rho}_{i-1}, \dots, \boldsymbol{\rho}_2$. Therefore, by averaging, we get

$$\mathop{\mathbb{E}}_{\overline{\boldsymbol{\rho}}}[\mathsf{Err}(\mathbf{T}_{i-1})] \leq \mathop{\mathbb{E}}_{\overline{\boldsymbol{\rho}}}[\mathsf{Err}(\mathbf{T}_i)] + \frac{\epsilon^2}{2d}.$$

We start with $\mathsf{Err}(\mathbf{T}_d) = 0$, so inductively we get $\mathbb{E}_{\overline{\boldsymbol{\rho}}}[\mathsf{Err}(\mathbf{T}_1)] < \epsilon^2/2$. Furthermore, $\mathbb{E}_{\boldsymbol{\rho}}[\mathsf{Err}(\mathbf{T})] = \mathbb{E}_{\overline{\boldsymbol{\rho}}}[\mathsf{Err}(\mathbf{T}_1)]$, because on both sides of the equation, we are plugging a uniform random input into $\mathbf{T}_1$. Thus $\mathbb{E}[\mathbf{T}] \leq \epsilon^2/2$. By Markov's inequality, therefore, except with probability $\epsilon/2$, we have $\mathsf{Err}(\mathbf{T}) < \epsilon$. Now let us compute the parameters $M_i$ and $D_i$.

---

[20]Formally, we assume that the algorithm is a RAM machine that scans its input $(n, d, p, \epsilon)$, and if it detects that a parameter value is outside the assumed range it outputs a trivial solution and aborts.

[21]Note that the bounds in the conclusion of Proposition 6.9 do not refer to $n$ (only to $p$, $\epsilon$, and the structural parameters of $\mathbf{T}_i$). Therefore there is no penalty for thinking of each $\mathbf{T}_i$ as a function of all $n$ variables (other than a tiny increase in the seed length).

[22]Indeed, $p_i < 2 \cdot (2p)^{40^{d-i}/A}$, and $p_{i+1 \cdots d} \geq \prod_{j=i+1}^{d} (2p)^{40^{d-j}/A} = (2p)^{(40^{d-i}-1)/(39A)} \geq (2p)^{40^{d-i}/(39A)}$, so $p_i < 2p_{i+1 \cdots d}^{39}$.

[23]We may assume without loss of generality that $\Delta \geq 300 \log(2/\epsilon)$, because otherwise, we can just let $\mathbf{I} = \{1, \dots, \lceil pn \rceil\}$ and let $\mathbf{T}$ be a trivial tree that queries every variable in $\mathbf{I}$.

**Number of LTF queries:** By Proposition 6.9, $M_{i-1} \leq M_i + O(p_i^{-11/6})$. Inductively, this shows that

$$M_i = O\left(\sum_{j=i+1}^{d} p_j^{-11/6}\right) < O(d \cdot p_{i+1}^{-2}). \tag{7}$$

In particular, $M_1 < O(dp_2^{-2}) < O(dp^{-2})$ as claimed.

**Number of variable queries:** By Proposition 6.9,

$$
\begin{aligned}
D_{i-1} &= O\left(p_i \cdot D_i + (p_i^{7/6} \cdot w + p_i^{-11/3}) \cdot (M_i^2 + \log^2(w/\epsilon))\right) \\
&< O\left(p_i \cdot D_i + (p_i^{7/6} \cdot w + p_i^{-11/3}) \cdot p_{i+1}^{-4} \cdot (d\log(w/\epsilon))^2\right) && \text{(Equation (7))} \\
&= O\left(p_i \cdot D_i + (p_i^{16/15} \cdot w + p_i^{-113/30}) \cdot (d\log(w/\epsilon))^2\right) && (p_i \leq 2p_{i+1}^{40}) \\
&\leq C \cdot \left(p_i \cdot D_i + (p_d^{1/15} \cdot p_{i\cdots d} \cdot w + p_i^{-4}) \cdot (d\log(w/\epsilon))^2\right) && (6.1)
\end{aligned}
$$

for some constant $C$, where the last inequality uses the fact that $p_i < 2p_{i+1\cdots d}^{39}$ when $i < d$, which implies that $p_i^{1/15} < 2p_{i+1\cdots d} \cdot p_{i+1\cdots d}^{24/15} \leq 2p_{i+1\cdots d} \cdot p_d^{1/15}$. Let us show by backward induction that

$$D_i \leq (2C)^{d-i} \cdot (p_d^{1/15} \cdot p_{i+1\cdots d} \cdot w + p_{i+1}^{-4}) \cdot (d\log(w/\epsilon))^2.$$

This is true in the base case $i = d$. For the inductive step, we have

$$
\begin{aligned}
D_{i-1} &< C \cdot \left(p_i \cdot D_i + (p_d^{1/15} \cdot p_{i\cdots d} \cdot w + p_i^{-4}) \cdot (d\log(w/\epsilon))^2\right) && \text{(Eq. (6.1))} \\
&< C \cdot \left(p_i \cdot D_i + (p_d^{1/15} \cdot p_{i\cdots d} \cdot w + p_i^{-4})\right) \cdot (d\log(w/\epsilon))^2 \\
&< C \cdot \left(p_i \cdot (2C)^{d-i} \cdot (p_d^{1/15} \cdot p_{i+1\cdots d} \cdot w + p_{i+1}^{-4}) + (p_d^{1/15} \cdot p_{i\cdots d} \cdot w + p_i^{-4})\right) \cdot (d\log(w/\epsilon))^2 \\
& && \text{(induction hypothesis)} \\
&< (2C)^{d-(i-1)} \cdot (p_d^{1/15} \cdot p_{i\cdots d} \cdot w + p_i^{-4}) \cdot (d\log(w/\epsilon))^2.
\end{aligned}
$$

Now, $p_d^{1/15} \leq 2 \cdot (2p)^{1/(15A)}$, and $\frac{1}{15A} = \frac{39}{15(40^{d-1}-1)} > 40^{-(d-1)}$, so $p_d^{1/15} \leq 4p^{40^{-(d-1)}}$. Therefore, indeed,

$$
\begin{aligned}
D_1 &\leq 2^{O(d)} \cdot (p_d^{1/15} \cdot p \cdot w + p_2^{-4}) \cdot \log^2(w/\epsilon) \\
&\leq 2^{O(d)} \cdot (p^{1+40^{-(d-1)}} \cdot w + p^{-4}) \cdot \log^2(w/\epsilon).
\end{aligned}
$$

**Sampling cost:** The set $\rho_i^{-1}(\star)$ can be sampled in time $\text{poly}(n, \log(1/p_i)) = \text{poly}(n)$ using a seed length of

$$
\begin{aligned}
O\left(p_i^{-5/6} \cdot (M_i + \log(w/\epsilon)) \cdot \log(n/p_i)\right) &< O\left(p_i^{-5/6} \cdot \log(n) \cdot \log(w/\epsilon)\right) \cdot M_i \\
&< O\left(p_i^{-5/6} \cdot \log(n) \cdot \log(w/\epsilon)\right) \cdot (d \cdot p_{i+1}^{-2}) \quad \text{(Eq. (7))} \\
&< O\left(p_i^{-1} \cdot d \cdot \log(w/\epsilon) \cdot \log n\right). \quad\quad (p_i < p_{i+1}^{12})
\end{aligned}
$$

Therefore, summing up, the total seed length for sampling **I** is

$$
\begin{aligned}
O\left(\left(\sum_i p_i^{-1}\right) \cdot d \cdot \log(w/\epsilon) \cdot \log n\right) &< O(p_{2\cdots d}^{-1} \cdot d \cdot \log(w/\epsilon) \cdot \log n) \\
&= O(p^{-1} \cdot d \cdot \log(w/\epsilon) \cdot \log n)
\end{aligned}
$$

as claimed, and the running time is at most $d \cdot \text{poly}(n) = \text{poly}(n)$. ∎

Let us now state the instantiation of Proposition 6.11 to the parameter values used in our main result:

**Corollary 6.12** (iterated restrictions simplify an LTF circuit to a decision tree with LTFs at the leaves). *Let $n, d \in \mathbb{N}$, let $\epsilon > 0$, and let $\delta = \frac{1}{2} \cdot 50^{-d}$. There is a distribution over subsets $\mathbf{I} \subseteq [n]$ of size $\lceil pn \rceil$, where $p = n^{-(1+\delta)/10}$, that can be sampled in time $\mathrm{poly}(n)$ with $n^{1/10+O(\delta)}$ random bits, such that for $\boldsymbol{\rho} = (\mathbf{I}, \mathbf{u}_n)$ the following holds. For any depth-$d$ LTF circuit $C: \{0,1\}^n \to \{0,1\}$ with at most $n^{1+\delta}$ wires, with probability $1 - 2^{-n^\delta}$ there is an $(\lceil pn \rceil, M, D, 1, n^{1+\delta}, d \cdot n^{1+\delta})$-LTF-DT $\mathbf{T}$ consistent with $C\!\upharpoonright_{\boldsymbol{\rho}}$ such that $\mathsf{Err}(\mathbf{T}) \le 2^{-n^\delta}$ and*

$$D = 2^{O(d)} \cdot (p^{1+\Omega(1)} \cdot n)$$
$$M = d \cdot n^{1/4}.$$

## 6.2 Fooling LTF decision trees with error indicators

So far, we have shown that an LTF circuit simplifies under pseudorandom restrictions. The simplified model is a decision tree that queries both variables and LTFs, with LTFs and LTF error indicators at the leaves. In this section, we will show how to fool that simplified model, which mainly amounts to obtaining an improved PRG for *polytopes* (i.e., functions of the form AND ∘ LTF) in the extremely-low-error regime.

We will in fact construct a PRG for the more general model of ANY ∘ LTF; that is, we prove Theorem 1.2. The proof outline was described in Section 2.3.3. As mentioned there, our starting point will be the recent result of Kabanets, Koroth, Lu, Myrisiotis, and Oliveira [KKLMO20]. Using their ideas with appropriate communication protocols for LTFs and PRGs for combinatorial rectangles, one can obtain a PRG with seed length $\widetilde{O}(\sqrt{n \cdot s} \cdot \log(1/\epsilon))$. [24] We will get a better seed length of $\widetilde{O}(\sqrt{n \cdot (s + \log(1/\epsilon))})$.

### 6.2.1 A low-error PRG for arbitrary functions of a bounded number of LTFs

We begin with a general result on fooling functions of the form $p(g_1, \ldots, g_s)$, where $p$ is a polynomial and each $g_i$ has low *communication complexity*. If $p$ is a multivariate real polynomial $p(x) = \sum_a c_a \prod_i x_i^{a_i}$, we define $L_1(p)$ to be the sum of the absolute values of the coefficients of $p$, i.e., $L_1(p) = \sum_a |c_a|$. Furthermore, we let $\deg(p)$ denote the total degree of $p$, i.e., $\deg(p) = \max\{\sum_i a_i : c_a \ne 0\}$.

Recall that a *k-dimensional combinatorial rectangle* is a function $f: (\{0,1\}^{n/k})^k \to \{0,1\}$ of the form

$$f(x^{(1)}, \ldots, x^{(k)}) = \prod_{i=1}^k f_i(x^{(i)}),$$

where $f_i: \{0,1\}^{n/k} \to \{0,1\}$.

**Theorem 6.13** (low-error PRG for polynomials of low-communication functions). *Let $\mathbf{x}$ be a distribution over $(\{0,1\}^{n/k})^k$ that $\epsilon$-fools $k$-dimensional combinatorial rectangles. Let $f(x) = p(g_1(x), \ldots, g_s(x))$, where $p: \mathbb{R}^s \to [0,1]$ is a polynomial and $g_1, \ldots, g_s: (\{0,1\}^{n/k})^k \to \{0,1\}$ can be computed by randomized $k$-party number-in-hand communication protocols with communication cost $R$ and failure probability $1/3$. Then $\mathbf{x}$ fools $f$ with error*

$$(\epsilon \cdot L_1(p))^{\Omega(1/R)} \cdot 2^{O(\deg(p))}.$$

---

[24]To see this, let $k = \sqrt{n/s}$. Expand $g$ as a degree-$s$ real polynomial. We compute each monomial $\bar{g}$ by $s$ repetitions of the communication protocol of Viola [Vio15] (following Nisan [Nis93]) for LTFs, which uses $R = O(\sqrt{n \cdot s} \cdot \log(ns/\epsilon))$ communication bits. We then "fool" this protocol with error $\epsilon/2^{O(s)}$ using the PRG for combinatorial rectangles of Gopalan and Yehudayoff [GY20], whose seed length in this parameter setting is dominated by $\widetilde{O}(R) = \widetilde{O}(\sqrt{n \cdot s} \cdot \log(1/\epsilon))$

Theorem 6.13 is similar to the analysis in [KKLMO20]. The improvement is that our theorem tolerates communication protocols with constant error, whereas the analysis by [KKLMO20] requires communication protocols with low error due to a union bound. The effect is that we will achieve a smaller value of $R$, hence a smaller error. Our improvement is based on a beautiful result by Sherstov.

**Theorem 6.14** (Making Polynomials Robust to Noise [She13]). *Let $p : \{0,1\}^n \to [0,1]$ be a given polynomial. Then for every $\delta > 0$, there is a polynomial $p_{\text{robust}} : \mathbb{R}^n \to \mathbb{R}$ such that*

$$|p(x) - p_{\text{robust}}(x + \eta)| < \delta$$

*for all $x \in \{0,1\}^n$ and all $\eta \in [-1/3, 1/3]^n$. Furthermore,*

$$\deg(p_{\text{robust}}) \le O(\deg(p) + \log(1/\delta))$$

*and*

$$L_1(p_{\text{robust}}) \le L_1(p) \cdot 2^{O(\deg(p) + \log(1/\delta))}.$$

(The bound on $L_1(p_{\text{robust}})$ is not explicitly stated in Sherstov's work [She13]. We now briefly explain how the $L_1$ bound can be verified, assuming familiarity with Sherstov's proof [She13]. In the proof of Sherstov's Theorem 5.2, the polynomial he calls $p$ and the quantities he calls $d$ and $D$ satisfy $L_1(p) \le 2^{O(d+D)}$. It follows that in the proof of his Theorem 6.2, we have $L_1(P) \le L_1(\phi) \cdot 2^{O(\deg(\phi)+D)}$. He sets $D = O(\deg(\phi) + \log(1/\delta))$, and the polynomial $r$ at the end of his Theorem 6.2 only increases $L_1(p_{\text{robust}})$ by a constant factor. Note that Sherstov's input polynomial $\phi$ is defined over the domain $\{\pm 1\}^n$ whereas Theorem 6.14 is stated over the domain $\{0,1\}^n$. The justification is that under the input transformation $\{0,1\} \leftrightarrow \{\pm 1\}$ given by $x \leftrightarrow (-1)^x = 1 - 2x$, the degree of a polynomial does not increase, whereas $L_1(p)$ can go up by at most a factor of $2^{O(\deg(p))}$.)

**Proof of Theorem 6.13.** Let $p_{\text{robust}}$ be the robust version of $p$ with $\delta = (\epsilon \cdot L_1(p))^{\Omega(1/R)} \cdot 2^{O(\deg p)}$. On any given input $x$, any of the functions $g_1(x), \ldots, g_s(x)$ can be computed by a randomized $k$-party number-in-hand protocol with error $1/3$ and $R$ bits of communication. For $i = 1, \ldots, s$, denote by $q_i(x)$ the acceptance probability of the randomized protocol for $g_i(x)$. We know that if $g_i(x) = 1$, then $q_i(x) \ge 2/3$ and if $g_i(x) = 0$ then $q_i(x) \le 1/3$. Now, we wish to show that $\mathbf{x}$ fools $p(g_1(x), \ldots, g_s(x))$. By the robustness of $p_{\text{robust}}$, for every $x$ we have

$$|p(g_1(x), \ldots, g_s(x)) - p_{\text{robust}}(q_1(x), \ldots, q_s(x))| \le \delta, \tag{6.2}$$

and thus it suffices to show that $\mathbf{x}$ fools $p_{\text{robust}}(q_1(x), \ldots, q_s(x))$. For this we analyze each monomial of $p_{\text{robust}}$ separately. Write

$$p_{\text{robust}}(z) = \sum_{a: \sum_i a_i \le \deg(p_{\text{robust}})} c_a \cdot z_1^{a_1} z_2^{a_2} \cdots z_s^{a_s}.$$

Take any formal monomial $z_1^{a_1} z_2^{a_2} \cdots z_s^{a_s}$ with $\sum_i a_i \le \deg(p_{\text{robust}})$. We wish to show that $\mathbf{x}$ fools the product $q_1(x)^{a_1} \cdots q_s(x)^{a_s}$. Observe that for any $x$, $q_1(x)^{a_1} \cdots q_s(x)^{a_s}$ can be thought of as the acceptance probability of a protocol that on input $x$ runs the protocol for $g_1(x)$ $a_1$ times, each with fresh randomness, then the protocol for $g_2(x)$ $a_2$ times, each with fresh randomness and so on and so forth – eventually taking the AND of the answers of the $\sum_i a_i$ many protocols. This combined protocol is a randomized protocol in the $k$-party number-in-hand model that uses $R \cdot \deg(p_{\text{robust}})$ communication bits. Denote the value of this protocol on input $x$ and randomness $r$ by $\pi(x, r)$. By design, $\mathbb{E}_{\mathbf{r}}[\pi(x, \mathbf{r})] = q_1(x)^{a_1} \cdots q_s(x)^{a_s}$ for any $x$.

Now, for every fixed randomness $r$, the randomized protocol becomes a deterministic protocol with value $\pi_r(x) = \pi(x, r)$ and communication cost at most $R \cdot \deg(p_{\text{robust}})$. We can

write $\pi_r(x) = \sum_{z \in A} \pi_{r,z}(x)$, where $A$ is the set of accepting transcripts and $\pi_{r,z}(x)$ indicates whether $\pi$ has transcript $z$ on input $x$ and randomness $r$. For fixed $r$ and $z$, the predicate $\pi_{r,z}$ can be computed by a $k$-dimensional combinatorial rectangle. Since $\mathbf{x}$ fools $k$-dimensional combinatorial rectangles with error $\epsilon$, it fools $\pi_r$ with error $\epsilon |A| \leq \epsilon \cdot 2^{R \cdot \deg(p_{\text{robust}})}$. Therefore,

$$\left| \mathop{\mathbb{E}}_{x \sim \mathbf{x}} [\pi_r(x)] - \mathop{\mathbb{E}}_{x \sim \mathbf{u}_n} [\pi_r(x)] \right| \leq \epsilon \cdot 2^{R \cdot \deg(p_{\text{robust}})}.$$

By averaging, we get

$$\left| \mathop{\mathbb{E}}_{x \sim \mathbf{x}, \mathbf{r}} [\pi_{\mathbf{r}}(x)] - \mathop{\mathbb{E}}_{x \sim \mathbf{u}_n, \mathbf{r}} [\pi_{\mathbf{r}}(x)] \right| \leq \epsilon \cdot 2^{R \cdot \deg(p_{\text{robust}})}.$$

And now since $\mathbb{E}_{\mathbf{r}}[\pi_{\mathbf{r}}(x)] = q_1(x)^{a_1} \cdots q_s(x)^{a_s}$ for every $x$ we have

$$\left| \mathop{\mathbb{E}}_{x \sim \mathbf{x}} [q_1(x)^{a_1} \cdots q_s(x)^{a_s}] - \mathop{\mathbb{E}}_{x \sim \mathbf{u}_n} [q_1(x)^{a_1} \cdots q_s(x)^{a_s}] \right| \leq \epsilon \cdot 2^{R \cdot \deg(p_{\text{robust}})}.$$

Summing over all monomials, we get

$$\left| \mathop{\mathbb{E}}_{x \sim \mathbf{x}} [p_{\text{robust}}(q_1(x), \ldots, q_s(x))] - \mathop{\mathbb{E}}_{x \sim \mathbf{u}_n} [p_{\text{robust}}(q_1(x), \ldots, q_s(x))] \right|$$
$$\leq \sum_a |c_a| \cdot \epsilon \cdot 2^{R \cdot \deg(p_{\text{robust}})}$$
$$= L_1(p) \cdot \epsilon \cdot 2^{R \cdot O(\deg(p) + \log(1/\delta))}$$
$$= \sqrt{L_1(p) \cdot \epsilon} \tag{6.3}$$

by a suitable choice of $\delta = (\epsilon \cdot L_1(p))^{\Omega(1/R)} \cdot 2^{O(\deg p)}$.

Overall, from Eq. (6.2) it follows that

$$\left| \mathop{\mathbb{E}}_{x \sim \mathbf{x}} [p(g_1(x), ..., p(g_s(x)))] - \mathop{\mathbb{E}}_{x \sim \mathbf{x}} [p_{\text{robust}}(q_1(x), ..., q_s(x))] \right| \leq \delta$$

and

$$\left| \mathop{\mathbb{E}}_{x \sim \mathbf{u}_n} [p(g_1(x), ..., p(g_s(x)))] - \mathop{\mathbb{E}}_{x \sim \mathbf{u}_n} [p_{\text{robust}}(q_1(x), ..., q_s(x))] \right| \leq \delta .$$

In Eq. (6.3) we showed that

$$\left| \mathop{\mathbb{E}}_{x \sim \mathbf{u}_n} [p_{\text{robust}}(q_1(x), \ldots, q_s(x))] - \mathop{\mathbb{E}}_{x \sim \mathbf{x}} [p_{\text{robust}}(q_1(x), \ldots, q_s(x))] \right| \leq \sqrt{L_1(p) \cdot \epsilon} < \delta ,$$

and thus by combining all three inequalities, applying the triangle inequality, we get that $\mathbf{x}$ fools $p(g_1(\cdot), g_2(\cdot), \ldots, g_s(\cdot))$ with error at most $3\delta$. ∎

In our case, Nisan [Nis93] showed that LTFs have efficient randomized communication protocols, and more recently Viola [Vio15] improved his result:

**Theorem 6.15** (Communication complexity of LTFs [Nis93; Vio15]). *Let $\Phi \colon \{0,1\}^n \to \{0,1\}$ be an LTF. Under any partition of $[n]$ into $k$ parts, there is a $\delta$-error randomized $k$-party number-in-hand protocol for $\Phi$ with communication cost $O(k \cdot \log(k) \cdot \log(n/\delta))$.*

As an immediate corollary, we get an improved low-error PRG for arbitrary Boolean functions of a bounded number of LTFs. Let $\text{ANY}_s$ denote the class of all functions $f \colon \{0,1\}^s \to \{0,1\}$.

**Corollary 6.16** (PRGs for combinatorial rectangles fool $\texttt{ANY} \circ \texttt{LTF}$). *For any $n, k \in \mathbb{N}$ such that $k < n$ and any $\delta > 0$, let $\mathbf{x}$ be a distribution over $(\{0,1\}^{n/k})^k$ that $\delta$-fools $k$-dimensional combinatorial rectangles. Then for any $s \in \mathbb{N}$, $\mathbf{x}$ $\epsilon$-fools $\texttt{ANY}_s \circ \texttt{LTF}$, where $\epsilon = \delta^{\Omega(1/(k \cdot \log(k) \cdot \log(n)))} \cdot 2^{O(s)}$.*

*Proof.* For any function $f \colon \{0,1\}^s \to \{0,1\}$, we can write

$$f(x) = \sum_{y \in \{0,1\}^s} f(y) \cdot \left( \prod_{i \in y^{-1}(1)} x_i \right) \left( \prod_{i \in y^{-1}(0)} (1 - x_i) \right).$$

This "brute force" expansion shows that $L_1(f) \leq 4^s$. The claim then follows using Theorem 6.13 and Theorem 6.15, while reying on the fact that

$$\epsilon = (\delta \cdot 4^s)^{1/O(k \cdot \log(k) \cdot \log(n))} \cdot 2^{O(s)} = \delta^{\Omega(1/(k \cdot \log(k) \cdot \log(n)))} \cdot 2^{O(s)}. \qquad \blacksquare$$

There is a long line of work developing PRGs for combinatorial rectangles [ASWZ96; EGLNV98; LLSZ97; Lu02; GMRTV12; Vio14; GY20; HLV18; Lee19]. The best seed length is by Gopalan and Yehudayoff [GY20]:

**Theorem 6.17** (PRGs for Combinatorial Rectangles [GY20]). *For any $k \leq n$ and any $\epsilon > 0$, there is a $\mathrm{poly}(n)$-time computable $\epsilon$-PRG for $k$-dimensional combinatorial rectangles on $(\{0,1\}^{n/k})^k$ with seed length*

$$\widetilde{O}(n/k + \log(1/\epsilon) + \log \log k).$$

**Corollary 6.18** (low-error PRG for $\texttt{ANY} \circ \texttt{LTF}$). *For any $n, s \in \mathbb{N}$ and any $\epsilon > 0$, there is an $\epsilon$-PRG for $\texttt{ANY}_s \circ \texttt{LTF}$, computable in time $\mathrm{poly}(n)$, with output length $n$ and seed length*

$$\widetilde{O}\left( \sqrt{n \cdot (s + \log(1/\epsilon))} \right). \tag{8}$$

*Proof.* To get error $\epsilon$ we will use Corollary 6.16 with $\delta = (\epsilon \cdot 2^{-O(s)})^{O(k \cdot \log(k) \cdot \log(n))}$. Plugging into Theorem 6.17, the seed length is

$$\widetilde{O}(n/k + k \log n \cdot (s + \log(1/\epsilon))).$$

To balance the two terms, we choose $k = \sqrt{n/(s + \log(1/\epsilon))}$, giving the desired seed length.
$\blacksquare$

### 6.2.2 Fooling $\texttt{LTF}$ decision trees with error indicators

We now show our low-error PRG for $\texttt{LTF-DT}$'s with a bounded number of $\texttt{LTF}$ queries in each path. The proof amounts to observing that our PRG for $\texttt{ANY}_s \circ \texttt{LTF}$ functions with sufficiently low error fools $\texttt{LTF}$ decision trees with error indicators when the "circuits" at the leaves have depth 1 (i.e., are simply $\texttt{LTF}$s).

**Theorem 6.19** (low-error PRG for $\texttt{LTF-DT}$'s). *For all $n, M, D, w, e, \epsilon$, there is a $\mathrm{poly}(n)$-time computable $\epsilon$-PRG for all functions of the form $f(x) = T(x) + \xi \cdot \mathsf{Err}(T, x)$, where $\xi \in \{\pm 1\}$ and $T$ is an $(n, M, D, 1, w, e)$-$\texttt{LTF-DT}$. The PRG has seed length*

$$\widetilde{O}\left( \sqrt{n \cdot (D + M + \log(e + 1) + \log(1/\epsilon))} \right).$$

**Proof.** Let $L$ be the set of leaves. For each leaf $\ell \in L$, let $g_\ell(x) = 1$ if and only if the tree reaches $\ell$ when it reads $x$. Let $\Phi_{\ell,0}$ be the `LTF` labeling $\ell$, and let $\mathcal{E} = \{\Phi_{\ell,1}, \ldots, \Phi_{\ell,e}\}$ be the set of error indicators labeling $\ell$. That way,

$$f(x) = \sum_{\ell \in L} g_\ell(x) \cdot \left(\Phi_{\ell,0}(x) + \xi \cdot \sum_{i=1}^{e} \Phi_{\ell,i}(x)\right).$$

The function $g_\ell$ is a conjunction of at most $M$ `LTF`s and at most $D$ literals. Any conjunction of literals can be computed by a single `LTF`, so the function $g_\ell(x) \cdot \Phi_{i,\ell}(x)$ can be computed by a conjunction of at most $M+2$ `LTF`s. Therefore, it is $\delta$-fooled by the $\delta$-PRG from Corollary 6.18 with $s = M+2$. Therefore, the same PRG fools $f$ with error $\delta \cdot |L| \cdot (e+1) \le \delta \cdot 2^{D+M} \cdot (e+1)$. Therefore, we should choose $\delta = \epsilon \cdot 2^{-D-M}/(e+1)$, giving the claimed seed length. ∎

### 6.2.3 Improved low-error PRGs for De Morgan formulas with `LTF`s at the leaves

As another application of Theorem 6.13, we obtain an improved low-error PRG for size-$s$ *De Morgan formulas* with `LTF`s at the leaves. Kabanets, Koroth, Lu, Myrisiotis, and Oliveira [KKLMO20] achieved seed length

$$\widetilde{O}(n^{1/2} s^{1/4} \log(1/\epsilon)) \tag{9}$$

for this class, which is trivial if $\log(1/\epsilon) > \sqrt{n}$. Our seed length is

$$\widetilde{O}(n^{1/2} s^{1/4} \log^{1/4}(1/\epsilon) + n^{1/2} \log^{1/2}(1/\epsilon)), \tag{10}$$

which remains nontrivial provided $s \log(1/\epsilon) \ll n^2$ and $\log(1/\epsilon) \ll n$. The second requirement is unavoidable, since fooling conjunctions of literals already requires seed length $\Omega(\log(1/\epsilon))$. When, e.g., $s = n$ and $\epsilon = 2^{-\sqrt{n}}$, both the seed length by [KKLMO20] (Eq. 9) and our seed length for fooling arbitrary functions of `LTF`s (Eq. 8) are larger than $n$, whereas our seed length for De Morgan formulas of `LTF`s is $\widetilde{O}(n^{7/8})$.

To achieve our seed length, we use both Theorem 6.13 and an improved, optimal bound on the low-error approximate degree of a size-$s$ De Morgan formula. Since this result is not necessary for our main constructions, we defer the proof to Appendix A.

### 6.2.4 Fooling `LTF` circuits of unbounded depth

As another corollary of Corollary 6.18, we show a PRG for `LTF` circuits of unbounded depth with at most $O(n/\text{polylog}(n))$ gates.

**Corollary 6.20** (PRG for `LTF` circuits with few gates). *For any $n, s \in \mathbb{N}$ and any $\epsilon > 0$, there is a* $\text{poly}(n)$*-time computable $\epsilon$-PRG for `LTF` circuits with $s$ gates with output length $n$ and seed length*

$$\widetilde{O}\left(\sqrt{n \cdot (s + \log(1/\epsilon))}\right).$$

**Proof.** Let $C$ be an `LTF` circuit with $s$ gates. The input variables to $C$ are $x_1, \ldots, x_n$. Let $y_1, \ldots, y_s$ denote the values output by the gates of $C$ in topological order, so $y_s$ is the output value of the circuit, and for each $i \in [s]$, there is some `LTF` $\Phi_i$ such that $y_i = \Phi_i(x_1, \ldots, x_n, y_1, \ldots, y_{i-1})$.

The proof uses the "guess and verify" technique. For each string $z \in \{0,1\}^s$ (the "guess"), define $g_z(x) = 1$ if and only if during the computation of $C(x)$, for every $i$, we have $y_i = z_i$ (i.e., verifying the guess). That way,

$$C(x) = \sum_{\substack{z \in \{0,1\}^s \\ z_s = 1}} g_z(x). \tag{11}$$

The key claim is that for a fixed $z$,

$$g_z(x) = 1 \iff \forall i, \; \Phi_i(x_1, \ldots, x_n, z_1, \ldots, z_{i-1}) = z_i. \tag{12}$$

Indeed, if $g_z(x) = 1$, then $\Phi_i(x_1, \ldots, x_n, z_1, \ldots, z_{i-1}) = \Phi_i(x_1, \ldots, x_n, y_1, \ldots, y_{i-1}) = y_i = z_i$. Conversely, if the right-hand side of Equation (12) holds, then induction on $i$ shows that $z_i = y_i$ for every $i \in [s]$.

Equation (12) implies that $g_z \in \text{AND}_s \circ \text{LTF}$. Therefore, by Equation (11), any $\delta$-PRG for $\text{AND}_s \circ \text{LTF}$ fools $C$ with error $\delta \cdot 2^{s-1}$. Therefore, we may use the PRG of Corollary 6.18 with error $\delta = \epsilon \cdot 2^{-s+1}$. ∎

## 6.3 The final PRG construction

In this section we combine the restriction procedure from Section 6.1 and the PRG from Section 6.2 to get a PRG for $\text{LTF}$ circuits of super-linear size. As explained in Section 2, we will use the PRG framework of Ajtai and Wigderson [AW85]. Let us now formally state the abstract version of their framework (see [ST19] for a discussion and proof).

**Definition 6.21** (C-to-$C_{\texttt{simple}}$ simplifying restriction). *Let $n \in \mathbb{N}$ and $p > 0$. Let $C$ be a class of functions $C \colon \{0,1\}^n \to \{0,1\}$, and let $C_{\texttt{simple}}$ be a class of functions $C \colon \{0,1\}^{\lceil pn \rceil} \to \{0,1\}$. Let $A \subseteq [n]$, and let $\mathbf{I}$ be a distribution over subsets of $A$ of size $\lceil p|A| \rceil$, and let $\eta > 0$. We say that $\mathbf{I}$ is a* C-to-$C_{\texttt{simple}}$ simplifying $(p, A)$-restriction with error $\eta$ *if for every $C \in C$ that ignores all of its input bits outside $A$, we have*

$$\Pr_{\mathbf{I}, \mathbf{z} \in \{0,1\}^{[n] \setminus \mathbf{I}}} \left[ C\!\restriction_{\mathbf{I}, \mathbf{z}} \notin C_{\texttt{simple}} \right] \le \eta.$$

*Here we think of $C\!\restriction_{\mathbf{I}, \mathbf{z}}$ as having domain $\{0,1\}^{\lceil pn \rceil}$ and ignoring all but the first $\lceil p|A| \rceil$ of its input bits.*

**Theorem 6.22** (the PRG framework of [AW85]; see [ST19, Theorem 5.1]). *Let $n \in \mathbb{N}$, let $p, \epsilon > 0$, and let $\eta = \frac{\epsilon \cdot p}{2 \ln n}$. Let $C$ be a class of functions $C \colon \{0,1\}^n \to \{0,1\}$ that is closed under restriction, and let $C_{\texttt{simple}}$ be a class of functions $C \colon \{0,1\}^{\lceil pn \rceil} \to \{0,1\}$. Assume that:*

1. *For all $A \subseteq [n]$,[25] a C-to-$C_{\texttt{simple}}$ simplifying $(p, A)$-restriction with error $\eta$ can be sampled in $\mathrm{poly}(n)$ time using seed length $s$.*

2. *There is a $\mathrm{poly}(n)$-time $\eta$-PRG for $C_{\texttt{simple}}$ with seed length $s$.*

*Then there is a $\mathrm{poly}(n)$-time $\epsilon$-PRG for $C$ with seed length $O(s \cdot p^{-1} \cdot \log n)$.[26]*

We now state our main result.

**Theorem 6.23** (PRG for super-linear sized LTF circuits). *Let $d \colon \mathbb{N} \to \mathbb{N}$ be time-constructible, and let $\delta(n) = \frac{1}{2} \cdot 50^{-d(n)}$. There exists a $\mathrm{poly}(n)$-time computable $\epsilon$-PRG for $\text{LTF}$ circuits of depth $d(n)$ with at most $n^{1+\delta(n)}$ wires, whose seed length is $O(n^{1-\delta(n)})$ and whose error is $\epsilon = 2^{-n^{\delta(n)}}$.*

---

[25]The statement of [ST19, Theorem 5.1] does not explicitly refer to the set $A$ (it just considers the case $A = [n]$), but multiple values of $A$ are indeed used in their proof. See [ST19, Section 5, "fooling $\mathscr{C}$ recursively"] for further details.

[26]As explained in Section 4, our usual convention is that algorithms receive "all relevant parameter values" as inputs. In this case, the convention might seem to suggest that the algorithms somehow receive descriptions of $C$ and $C_{\texttt{simple}}$ as inputs, but that is not what we have in mind. Instead the restriction sampling algorithm merely gets $n, p, A, \eta$, and its seed as inputs; the PRG for $C_{\texttt{simple}}$ gets $\lceil pn \rceil, \eta$ and its seed; the PRG for $C$ gets $n, p, \epsilon$, and its seed. Implicitly, we are assuming that there is an infinite family of pairs $(C, C_{\texttt{simple}})$ – one for each value of $n$.

**Proof.** For convenience, when $n$ is clear from context we will denote $d = d(n)$, $\delta = \delta(n)$, $\epsilon = \epsilon(n)$, etc. Let $w = n^{1+\delta}$, $p = w^{-1/10}$, and $\eta = \frac{\epsilon \cdot p}{2 \ln n}$. Let C be the set of functions $C \colon \{0,1\}^n \to \{0,1\}$ that can be computed by depth-$d$ LTF circuits with at most $w$ wires, and note that C is closed under restriction. Let $C_{\texttt{simple}}$ be the set of functions $f \colon \{0,1\}^{\lceil pn \rceil} \to \{0,1\}$ such that there is some $(\lceil pn \rceil, M, D, 1, w, wd)$-LTF-DT consistent with $f$, where $\text{Err}(T) \leq \eta/2$ and $M$ and $D$ are the parameters in Proposition 6.11, namely

$$D = (p^{1+40^{-(d-1)}} \cdot w + p^{-4}) \cdot 2^{O(d)} \cdot \log^2(w/\eta) = p^{1+40^{-(d-1)}} \cdot w \cdot 2^{O(d)} \cdot \log^2(w/\eta)$$
$$M = O(p^{-2} \cdot d) \ll D.$$

Observe that every such $f$ is $(\eta/2)$-upper-sandwiched by $T(x) + \text{Err}(T,x)$ and $(\eta/2)$-lower-sandwiched by $T(x) - \text{Err}(T,x)$.

With these definitions, Proposition 6.11 guarantees that for every $A \subseteq [n]$, there is a C-to-$C_{\texttt{simple}}$ simplifying $(p, A)$-restriction with error $\eta$ that can be sampled in $\text{poly}(n)$ time using a seed of length

$$O(p^{-1} \cdot d \cdot \log(w/\eta) \cdot \log n).$$

Recall that Theorem 6.19 guarantees a $\text{poly}(n)$-time computable $(\eta/2)$-PRG for all functions of the form $f(x) = T(x) + \zeta \cdot \text{Err}(T,x)$, where $\zeta \in \{\pm 1\}$ and $T$ is an $(\lceil pn \rceil, M, D, 1, w, wd)$-LTF-DT, with seed length

$$\widetilde{O}\left( \sqrt{pn \cdot (D + M + \log(wd) + \log(1/\eta))} \right)$$
$$= \widetilde{O}\left( \sqrt{pn \cdot p^{1+40^{-(d-1)}} \cdot w \cdot 2^{O(d)} \cdot \log(w/\eta)} \right)$$
$$\leq \widetilde{O}\left( p^{1+\frac{1}{2}40^{-(d-1)}} \cdot w \cdot 2^{O(d)} \cdot \log(1/\epsilon) \right).$$

The following standard fact implies that the same PRG $\eta$-fools $C_{\texttt{simple}}$.

**Fact 6.23.1.** *If a function $f \colon \{0,1\}^m \to \{0,1\}$ is $(\eta/2)$-upper-sandwiched and $(\eta/2)$-lower-sandwiched by functions from a class $\mathcal{F} \subseteq \{\{0,1\}^m \to \mathbb{R}\}$, then any distribution $\mathbf{w}$ over $\{0,1\}^m$ that is $(\eta/2)$-pseudorandom for $\mathcal{F}$ is $\eta$-pseudorandom for $f$.*

*Proof.* Denoting the lower-sandwiching function by $f^{(low)}$, we have that $\mathbb{E}[f(\mathbf{u}_m)] \leq \mathbb{E}[f^{(low)}(\mathbf{u}_m)] + \eta/2 \leq \mathbb{E}[f^{(low)}(\mathbf{w})] + \eta \leq \mathbb{E}[f(\mathbf{w})] + \eta$, and similarly, using the upper-sandwiching function $f^{(up)}$, we have that $\mathbb{E}[f(\mathbf{u}_m)] \geq \mathbb{E}[f^{(up)}(\mathbf{u}_m)] - \eta/2 \geq \mathbb{E}[f^{(up)}(\mathbf{w})] - \eta \geq \mathbb{E}[f(\mathbf{w})] - \eta$. $\qquad\square$

Applying Theorem 6.22 gives us our $\epsilon$-PRG for C with seed length

$$\widetilde{O}\left( p^{1+\frac{1}{2}40^{-(d-1)}} \cdot w \cdot 2^{O(d)} \cdot \log(1/\epsilon) \cdot p^{-1} \cdot \log n \right)$$
$$= \widetilde{O}\left( p^{\frac{1}{2}40^{-(d-1)}} \cdot w \cdot 2^{O(d)} \cdot \log(1/\epsilon) \right)$$
$$= \widetilde{O}\left( w^{1-2\cdot40^{-d}} \cdot 2^{O(d)} \cdot \log(1/\epsilon) \right).$$

We can assume without loss of generality that $\delta \geq 1/\log n$, as otherwise the seed length in the theorem statement is greater than $n$. Since $\delta = \frac{1}{2}50^{-d}$, we get

$$50^d \leq \frac{1}{2} \log n. \tag{13}$$

Therefore, the $2^{O(d)}$ term in the seed length is at most $\text{polylog}(n)$, so we can absorb it into the $\widetilde{O}$, making the seed length $\widetilde{O}(w^{1-2\cdot 40^{-d}} \cdot \log(1/\epsilon))$. Recalling $w = n^{1+\delta}$ and $\epsilon = 2^{-n^{\delta}}$, the seed length becomes

$$
\begin{aligned}
n^{1+2\delta-2\cdot 40^{-d}} \cdot \text{polylog}(n) &\leq n^{1-\delta} \cdot n^{-0.5\cdot 40^{-d}} \cdot \text{polylog}(n) && (40^{-d} > 50^{-d} = 2\delta) \\
&\leq n^{1-\delta} \cdot n^{-0.5\cdot(50^{-d})^{0.95}} \cdot \text{polylog}(n) && (\frac{\log(40)}{\log(50)} < 0.95) \\
&\leq n^{1-\delta} \cdot n^{-\Omega(1/\log^{0.95} n)} \cdot \text{polylog}(n) && (\text{Eq. (13)}) \\
&= n^{1-\delta} \cdot 2^{-\Omega(\log^{0.05} n)} \cdot 2^{O(\log\log n)} \\
&\leq n^{1-\delta}
\end{aligned}
$$

for sufficiently large $n$. $\blacksquare$

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# A    An improved low-error PRG for formulas of LTFs

## A.1    Low-error approximating polynomials for De Morgan formulas

Recall that for a Boolean function $f: \{0,1\}^n \to \{0,1\}$, the *$\delta$-error approximate degree* $\widetilde{\deg}_\delta(f)$ is the smallest degree of a polynomial $p$ such that for all $x$, $|f(x) - p(x)| \leq \delta$. We rely on a beautiful result from quantum computing by Reichardt [Rei11].

**Theorem A.1** ([Rei11]). *If F is a size-s De Morgan formula, then $\widetilde{\deg}_{1/3}(F) \leq O(\sqrt{s})$.*

While Reichardt's result gives a polynomial of degree $\approx \sqrt{s}$ that pointwise approximates $f$ to error $1/3$, it is desirable in many cases to reduce the error much further to some small parameter $\delta$ (that may depend on $s$). It is well-known (see [BNRW07]) that error reduction can be done in a black-box fashion, yielding a polynomial of degree $O(\sqrt{s}\log(1/\delta))$ that point-wise approximates the formula up to error $\delta$. However, this result is not tight, and in the next theorem we show that one can get a better dependency on the error parameter, namely $\sqrt{s\log(1/\delta)}$. Such a result was known for the special case of the OR function on $s$ variables, and is tight for this special case for any $\delta > 2^{-s}$ [BCWZ99].

**Theorem A.2.** *If F is a size-s De Morgan formula, then $\widetilde{\deg}_\delta(F) \leq O(\sqrt{s\log(1/\delta)})$.*

**Proof.** Take a formula for $F$ of size $s$. Let $k = \log(1/\delta)$. By Lemma 5.3, we can write $F$ as a composition of a read-once top formula $T$ of size $m = O(k)$ and bottom-formulas $B_1, \ldots, B_m$ each of size at most $s/k$.

By Theorem A.1, we know that each $B_i$ can be point-wise approximated by a polynomial $q_i$ of degree at most $O(\sqrt{s/k})$.

Take the unique multilinear polynomial $p$ that computes the formula $T$ exactly. $\deg(T) \leq m$ since $T$ is a formula with $m$ leaves. Take the robust version $p_{\text{robust}}$ of $p$ with parameter $\delta$, as guaranteed from Theorem 6.14. By construction $\deg(p_{\text{robust}}) = O(k + \log(1/\delta)) = O(k)$.

Consider the composition $f(x) = p_{\text{robust}}(q_1(x), q_2(x) \ldots, q_m(x))$. The polynomial $f$ is of degree at most

$$O(k) \cdot O(\sqrt{s/k}) = O(\sqrt{sk}) = O\left(\sqrt{s \log(1/\delta)}\right).$$

Moreover, on any input $x \in \{0,1\}^n$ we have

$$(q_1(x), q_2(x) \ldots, q_m(x)) = (B_1(x), \ldots, B_m(x)) + \eta$$

where $\eta \in [-1/3, 1/3]^m$, and thus Theorem 6.14 gives us

$$|f(x) - F(x)| = |p_{\text{robust}}(q_1(x), \ldots, q_m(x)) - p(B_1(x), \ldots, B_m(x))| \leq \delta. \quad \blacksquare$$

## A.2 PRGs from approximating polynomials

Bounds on approximate degree can be combined with Theorem 6.13:

**Theorem A.3.** *Let* $\mathbf{x}$ *be a distribution over* $(\{0,1\}^{n/k})^k$ *that* $\epsilon$-*fools* $k$-*dimensional combinatorial rectangles. Let* $f(x) = F(g_1(x), \ldots, g_s(x))$, *where* $\widetilde{\deg}_\delta(F) \leq d$ *and* $g_1, \ldots, g_s \colon (\{0,1\}^{n/k})^k \to \{0,1\}$ *can be computed by randomized* $k$-*party number-in-hand communication protocols with communication cost* $R$ *and failure probability* $1/6$. *Then* $\mathbf{x}$ *fools* $f$ *with error*

$$2\delta + (\epsilon \cdot (4s+4)^d)^{\Omega(1/R)} \cdot 2^{O(d)}.$$

**Proof.** Let $p$ be a degree-$d$ polynomial such that for all $x \in \{0,1\}^s$, $|p(x) - F(x)| \leq \delta$. Define $q(x) = \frac{p(x)}{1+\delta}$, so that $q$ takes values in $[0,1]$ and we still have $|q(x) - F(x)| \leq 2\delta$. By Theorem 6.13, $\mathbf{x}$ fools $q(g_1(x), \ldots, g_s(x))$ with error $(\epsilon \cdot L_1(q))^{\Omega(1/R)} \cdot 2^{O(d)}$. To bound $L_1(q)$, it is helpful to move to $\{\pm 1\}$ inputs, i.e., define

$$r(x_1, \ldots, x_s) = q\left(\frac{1}{2} - \frac{1}{2}x_1, \ldots, \frac{1}{2} - \frac{1}{2}x_s\right),$$

so that

$$q(x_1, \ldots, x_s) = r(1 - 2x_1, \ldots, 1 - 2x_s).$$

By considering each monomial individually, we see that $\deg(r) \leq \deg(q) = d$ and $L_1(q) \leq L_1(r) \cdot 4^d$. We may think of $r$ as the Fourier expansion of a function $r \colon \{\pm 1\}^s \to [0,1]$. This shows that each individual coefficient of $r$ has absolute value at most 1. The number of coefficients is at most $(s+1)^d$, so $L_1(r) \leq (s+1)^d$. $\quad \blacksquare$

Now we are ready to give our improved low-error PRG for size-$s$ De Morgan formulas with LTFs at the leaves. Let FORMULA$[s]$ denote the class of De Morgan formulas of size $s$.

**Corollary A.4.** *For all* $n, s \in \mathbb{N}$ *and all* $\epsilon > 0$, *there is a* $\text{poly}(n)$-*time computable PRG for* FORMULA$[s] \circ$ LTF *with output length* $n$ *and seed length*

$$\widetilde{O}(n^{1/2}s^{1/4}\log^{1/4}(1/\epsilon) + n^{1/2}\log^{1/2}(1/\epsilon)).$$

*Proof.* By Theorem A.2, Theorem A.3, and Theorem 6.15, for any $k$, it suffices to fool $k$-dimensional combinatorial rectangles with error

$$2^{-\widetilde{O}(\sqrt{s\log(1/\epsilon)} \cdot k \log n)}.$$

By Theorem 6.17, this can be done with seed length

$$\widetilde{O}\left(n/k + \sqrt{s\log(1/\epsilon)} \cdot k \log n\right).$$

To balance the two terms, we choose $k = n^{1/2}s^{-1/4}\log^{-1/4}(1/\epsilon)$. $\quad \blacksquare$

# B  An improved low-error PRG for branching programs and general formulas

In this appendix we construct PRGs with good dependency on the error of size-$s$ branching programs and for size-$s$ formulas over an arbitrary basis. Impagliazzo, Meka, and Zuckerman showed how to fool these classes with seed length of $s^{1/2+o(1)}$ and error $1/\text{poly}(s)$ (for $s \geq n$) [IMZ12]. We will achieve an improved seed length of $\sqrt{s} \cdot \text{polylog}(n/\epsilon)$.

**Theorem B.1** (Low-error PRG for branching programs and formulas over a general basis). *For any $n, s \in \mathbb{N}$ and any $\epsilon > 0$, there is an $\epsilon$-PRG for size-$s$ branching programs and size-$s$ formulas over an arbitrary basis with output length $n$ and seed length $\sqrt{s} \cdot \text{polylog}(n/\epsilon)$, computable in time* $\text{poly}(n)$.

The main improvement is the better dependence on $\epsilon$; our PRG remains nontrivial even when the error parameter is $2^{-s^{\Omega(1)}}$. Even for constant error, our seed length is superior in terms of the lower order terms. The $s^{o(1)}$ term in the IMZ seed length is, more specifically, $2^{O(\sqrt{\log n})}$. Our seed length replaces $2^{O(\sqrt{\log n})}$ with $\text{polylog}(n)$.

## B.1  Shrinkage of all shifts simultaneously

We will present the proof for branching programs; the proof for formulas over a general basis is essentially identical. Like the PRG for De Morgan formulas, the PRG is based on the phenomenon that branching programs *shrink* under random restrictions. In Impagliazzo, Meka, and Zuckerman's work [IMZ12], the bottleneck preventing them from achieving low error is that the chance of a branching program failing to shrink is too high.

To evade this obstacle, one approach would be to use a hybrid decision tree model like we did with De Morgan formulas. We will take a different approach that gives better parameters and is simpler in some respects. The key observation is that when shrinkage does occur, *all shifts* of the branching program shift as well. (This is not necessarily true of De Morgan formulas.)

To state this precisely, for a function $f: \{0,1\}^n \to \{0,1\}$ and a string $y \in \{0,1\}^n$, define $f^{\oplus y}(x) = f(x \oplus y)$. Let $\text{BP}(f)$ be the size of the smallest branching program computing $f$.

**Lemma B.2** (Shrinkage of all shifts of branching programs). *Let $p \in (0,1)$ and let $\boldsymbol{\rho}$ be $p$-regular restriction. Then for any size-$s$ branching program $f$,*

$$\Pr[\forall y, \text{BP}((f^{\oplus y})\!\restriction_{\boldsymbol{\rho}}) \leq 4ps] \geq 3/4.$$

**Proof.** For $i \in [n]$, let $s_i$ be the number of nodes in $f$ that query $x_i$. Define a random variable $\mathbf{a}_i$ by

$$\mathbf{a}_i = \begin{cases} s_i & \text{if } \boldsymbol{\rho}_i = \star \\ 0 & \text{if } \boldsymbol{\rho}_i \neq \star. \end{cases}$$

Then $\mathbb{E}[\sum_i \mathbf{a}_i] \leq ps$, so by Markov's inequality, $\Pr[\sum_i \mathbf{a}_i \leq 4ps] \geq 3/4$. Now, fix any shift $y \in \{0,1\}^n$. The function $(f^{\oplus y})\!\restriction_{\boldsymbol{\rho}}$ can be computed by a branching program of size $\sum_i \mathbf{a}_i$ obtained from $f$ by deleting all vertices $v$ that query some $x_i$ with $\boldsymbol{\rho}_i \neq \star$. The incoming edges to such a vertex are redirected to the vertex reached from $v$ by following the edge labeled $\boldsymbol{\rho}_i \oplus y_i$. ∎

## B.2  A good set of restrictions with high probability

The first step of our PRG is to independently sample pseudorandom restrictions $\boldsymbol{\rho}_1, \ldots, \boldsymbol{\rho}_t \in \{0,1,\star\}^n$. Ideally, we would like these restrictions to shrink all shifts of $f$ like in Lemma B.2,

and we additionally would like the $\star$ coordinates of these restrictions to collectively cover almost all of $[n]$. That won't necessarily happen, but we now will argue that with high probability, some *subset* of the restrictions satisfies both conditions. This is how we are able to tolerate the high failure probability in Lemma B.2.

**Lemma B.3.** *Let $f$ be a size-$s$ branching program on $n$ input bits, and let $p, \epsilon > 0$. For $t = O(p^{-1} \log n + \log(1/\epsilon))$, sample independent restrictions $\rho_1, \ldots, \rho_t \in \{0, \star\}^n$, where each $\rho_i$ is $p$-regular and 4-wise independent. Then except with probability $\epsilon$, there is some set $\mathbf{J} \subseteq [t]$ such that*

1. *For every $j \in \mathbf{J}$, for every $y \in \{0,1\}^n$, $\mathrm{BP}((f^{\oplus y})|_{\rho^{(j)}}) \leq 4ps$.*

2. $\left| \bigcup_{j \in \mathbf{J}} \rho_j^{-1}(\star) \right| \geq n - O(p^{-1})$.

**Proof.** The proof is very similar to the proof of Claim 5.9. Suppose we have already sampled $\rho_1, \ldots, \rho_{j-1}$, and we have already defined $\mathbf{J} \cap [j-1]$. Let $\mathbf{I}$ be the set of coordinates in $[n]$ that are not yet covered by a $\star$, i.e.,

$$\mathbf{I} = [n] \setminus \left( \bigcup_{i \in \mathbf{J} \cap [j-1]} \rho_i^{-1}(\star) \right).$$

Let us include $j \in \mathbf{J}$ if $|\rho_j^{-1}(\star) \cap \mathbf{I}| \geq p|\mathbf{I}|/2$ and for all $y$, $\mathrm{BP}((f^{\oplus y})|_{\rho_j}) \leq 4ps$. We shall also include $j \in \mathbf{J}$ if $|\mathbf{I}| < 2400p^{-1}$. If $|\mathbf{I}| \geq 2400p^{-1}$, then by Theorem 4.5 with $\Delta = p|\mathbf{I}|/2$,

$$\Pr_{\rho_j}[|\rho_j^{-1}(\star) \cap \mathbf{I}| \leq p|\mathbf{I}|/2] \leq \frac{1}{16}.$$

Combining with Lemma B.2, we see that conditioned on any values of $\rho_1, \ldots, \rho_j$, we have

$$\Pr_{\rho_j}[j \in \mathbf{J}] \geq 1 - \frac{1}{4} - \frac{1}{16} > \frac{2}{3}.$$

This implies that after picking $\rho_1, \ldots, \rho_t$, with high probability, $|\mathbf{J}| \geq \Omega(t)$. Indeed, by Azuma's inequality [DRV10, Lemma B.1], $|\mathbf{J}| \geq t/2$ except with probability $e^{-\Omega(t)} \leq \epsilon$.

Suppose now that $|\mathbf{J}| \geq t/2$. We start with $n$ coordinates not covered by $\star$, and whenever we include $j \in \mathbf{J}$, either we are down to $2400p^{-1}$ coordinates not covered, or else the number of coordinates not covered decreases by a factor of $(1 - p/2)$. If the latter case happens every time, then every coordinate is covered, because $(1 - p/2)^{t/2} < 1$ (here we use $t \geq \Omega(p^{-1} \log n)$). Therefore, either way we must eventually cover all but $2400p^{-1}$ coordinates. ∎

## B.3 The improved analysis of the IMZ generator

Now we shall describe the full PRG construction. The construction is similar to our PRG for De Morgan formulas (Section 5) (and the original PRG by Impagliazzo, Meka, and Zuckerman [IMZ12]).

Sample $\rho_1, \ldots, \rho_t$ as in Lemma B.3, with $p = 1/\sqrt{s}$.[27] Let $G: \{0,1\}^d \to \{0,1\}^n$ be a $(4\sqrt{s})$-wise independent generator. Let $\mathsf{Ext}: \{0,1\}^m \times \{0,1\}^{d_{\mathsf{Ext}}} \to \{0,1\}^d$ be a $(k_{\mathsf{Ext}}, \epsilon_{\mathsf{Ext}})$-extractor (the values of these parameters will be specified later.) Sample independent uniform random

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[27] Actually, to optimize the low order terms in the seed length, we should use a value of $p$ that is larger by a factor of $\sqrt{\log(n/\epsilon)}$. We use $p = 1/\sqrt{s}$ just for simplicity.

strings $\mathbf{a} \in \{0,1\}^m$ and $\mathbf{y}_1, \ldots, \mathbf{y}_t \in \{0,1\}^{d_{\mathsf{Ext}}}$. Let $\mathbf{z}_i = \mathsf{Ext}(\mathbf{a}, \mathbf{y}_i)$. Furthermore, sample an $O(\sqrt{s})$-wise independent string $\mathbf{w} \in \{0,1\}^n$. Our PRG outputs

$$\mathbf{w} \oplus \bigoplus_{i=1}^{t} G(\mathbf{z}_i) \circ \rho_i.$$

The proof of correctness is once again a hybrid argument. However, a key difference is that in the hybrid argument, we will consider *fixed* restrictions. In particular, let $f$ be a size-$s$ branching program, and consider some fixed $\rho_1, \ldots, \rho_t$ and some set $J \subseteq [t]$ satisfying the conclusion of Lemma B.3. Let $t' = |J|$, and let $\sigma$ be a permutation on $[t]$ such that $J = \{\sigma(1), \ldots, \sigma(t')\}$.

Define

$$\mathbf{e} = \mathbf{w} \oplus \bigoplus_{i \notin J} G(\mathbf{z}_i) \circ \rho_i.$$

Sample independent uniform strings $\mathbf{u}^{(1)}, \ldots, \mathbf{u}^{(t')}$, and define hybrid distributions $\mathbf{h}_0, \ldots, \mathbf{h}_{t'}$ by

$$\mathbf{h}_j = \mathbf{e} \oplus \left( \bigoplus_{i=1}^{j} (\mathbf{u}^{(j)} \circ \rho_{\sigma(i)}) \right) \oplus \left( \bigoplus_{i=j+1}^{t'} (G(\mathbf{z}_{\sigma(i)}) \circ \rho_{\sigma(i)}) \right).$$

We stress that $\rho_1, \ldots, \rho_t$ and $J$ are fixed at this point, so the randomness of $\mathbf{h}_j$ is due to the random choices of $\mathbf{w}, \mathbf{a}, \mathbf{y}_1, \ldots, \mathbf{y}_t$.

**Claim B.4.** *For each $j \in [t']$,*

$$\mathbb{E}[f(\mathbf{h}_{j-1})] - \mathbb{E}[f(\mathbf{h}_j)] \le 3\epsilon_{\mathsf{Ext}}.$$

**Proof.** Define $\mathbf{e}'$ to be the random variable such that

$$\mathbf{h}_{j-1} = \mathbf{e}' \oplus (G(\mathbf{z}_{\sigma(j)}) \circ \rho_{\sigma(j)})$$
$$\mathbf{h}_j = \mathbf{e}' \oplus (\mathbf{u}^{(j)} \circ \rho_{\sigma(j)}).$$

Note that $\mathbf{e}'$ is *not* independent of $\mathbf{a}$ or $\mathbf{w}$, but $\mathbf{e}'$ is nevertheless independent of $\mathbf{y}_j$. Let $\mathbf{F} = (f^{\oplus \mathbf{e}'})|_{\rho_{\sigma(j)}}$, so $\mathbf{F}$ (as a function) is a random variable (since it depends on $\mathbf{e}'$). Let us bound the support size of that random variable.

Since $\sigma(j) \in J$, we have $\Pr_{\mathbf{e}'}[\mathrm{BP}(\mathbf{F}) \le 4\sqrt{s}] = 1$. Therefore, $\mathbf{F}$ can be described using $O(\sqrt{s} \log n)$ bits. As in the proof of Claim 5.8, this implies that $\widetilde{H}_\infty(\mathbf{a} \mid \mathbf{F}) \ge m - O(\sqrt{s} \log n)$. Setting $k_{\mathsf{Ext}}$ to be the same value $m = O(\sqrt{s} \log n)$, this implies that $(\mathbf{F}, \mathbf{z}_{\sigma(j)}) \sim_{3\epsilon_{\mathsf{Ext}}} (\mathbf{F}, \mathbf{u})$, where $\mathbf{u}$ is a uniform random $d$-bit string independent of $\mathbf{F}$. It follows that

$$|\mathbb{E}[\mathbf{F}(G(\mathbf{z}_{\sigma(j)}))] - \mathbb{E}[\mathbf{F}(G(\mathbf{u}))]| \le 3\epsilon_{\mathsf{Ext}}.$$

Since $\mathrm{BP}(\mathbf{F}) \le 4\sqrt{s}$, $G$ perfectly fools $\mathbf{F}$, so

$$|\mathbb{E}[\mathbf{F}(G(\mathbf{z}_{\sigma(j)})) - \mathbb{E}[\mathbf{F}(\mathbf{u}^{(j)})]| \le 3\epsilon_{\mathsf{Ext}}.$$

Since $\mathbf{F}(G(\mathbf{z}_{\sigma(j)})) = f(\mathbf{h}_{j-1})$ and $\mathbf{F}(\mathbf{u}^{(j)}) = f(\mathbf{h}_j)$, this completes the proof. $\blacksquare$

**Proof of Theorem B.1.** By the triangle inequality,

$$|\mathbb{E}[f(\mathbf{h}_0)] - \mathbb{E}[f(\mathbf{h}_{t'})]| \le 3t'\epsilon_{\mathsf{Ext}} \le 3t\epsilon_{\mathsf{Ext}}.$$

Now, $\mathbf{h}_0$ is our pseudorandom distribution. Meanwhile, we claim that $\mathbf{h}_{t'}$ is a perfectly uniform random string. Indeed, observe that

$$(\mathbf{h}_{t'})_i = \begin{cases} \mathbf{e}_i & \text{if } i \notin \bigcup_{j \in J} \rho^{-1}(\star) \\ \text{a fresh uniform random bit} & \text{otherwise.} \end{cases}$$

Since we are assuming the conclusion of Lemma B.3, the number of coordinates $i$ with $i \notin \bigcup_{j \in J} \rho^{-1}(\star)$ is at most $O(\sqrt{s})$. The random variable $\mathbf{w}$ ensures that $\mathbf{e}$ is uniform random on those coordinates. Thus, taking into account the failure probability in Lemma B.3, the total error of our pseudorandom generator is at most $\epsilon + 3t\epsilon_{\mathsf{Ext}} = O(\epsilon)$, choosing $\epsilon_{\mathsf{Ext}} = \epsilon/t$.

Finally, let us bound the seed length of our PRG. Each $\rho_i$ costs $O(\log n)$ truly random bits. The generator $G$ has seed length $d = O(\sqrt{s} \log n)$. Take Ext to be the GUV extractor [GUV09]. Then it suffices to take $m = O(\sqrt{s} \log n)$ and $d_{\mathsf{Ext}} = O(\log(n/\epsilon))$. Summing up gives the claimed seed length. ∎